

EN35QXR128A (2XC)**128 Megabit 3V Serial Flash Memory with 4Kbyte Uniform Sector****FEATURES**

- Single power supply operation
 - Full voltage range: 2.7-3.6 volt
- Serial Interface Architecture
 - SPI Compatible: Mode 0 and Mode 3
- 128 M-bit Serial Flash
 - 128 M-bit / 16,384 KByte / 65,536 pages
 - 256 bytes per programmable page
- Standard, Dual or Quad SPI
 - Standard SPI: CLK, CS#, DI, DO
 - Dual SPI: CLK, CS#, DQ₀, DQ₁
 - Quad SPI: CLK, CS#, DQ₀, DQ₁, DQ₂, DQ₃
 - Default QE=1(Quad Enable), WP#, HOLD# disable
- High performance
 - Full voltage range
 - 104 MHz clock rate for Single/Dual/Quad I/O
 - Fast Read
- Support Serial Flash Discoverable
- Parameters (SDFP) signature
- Low power consumption
 - 12 mA typical active current
 - 1 μ A typical standby current
- Uniform Sector Architecture:
 - 4096 sectors of 4-Kbyte
 - 512 blocks of 32-Kbyte
 - 256 blocks of 64-Kbyte
 - Any sector or block can be erased individually
- Software and Hardware Write Protection
 - Write Protect all or portion of memory via software
- Software and Hardware Reset
- High performance program/erase speed
 - Page program time: 0.5 ms typical
 - Sector erase time: 40 ms typical
 - Half Block erase time: 200 ms typical
 - Block erase time: 300 ms typical
 - Chip erase time: 60 Seconds typical
- Volatile Status Register Bits.
- Lockable 3x512 byte OTP security sectors
- Write suspend and resume
- Burst read with wrap(8/16/32/64 byte)
- Blank check bit
- Replay-Protected Monotonic Counter (RPCMC)
- Read Unique ID Number
- Minimum 100K endurance cycle
- Data retention time 20years
- Package Options
 - 8-pin SOP 200 mil body width
 - 16-pin SOP 300 mil body width
 - 8-contact VDFN/ WSON (6x5 mm)
 - 8-contact VDFN/ WSON (8x6 mm)
 - All Pb-free packages are compliant RoHS, Halogen-Free and REACH.
- Industrial temperature Range

GENERAL DESCRIPTION

The device is a 128 Megabit (16,384K-byte) Serial Flash memory, with advanced write protection mechanisms. The device supports the single bit and four bits serial input and output commands via standard Serial Peripheral Interface (SPI) pins: Serial Clock, Chip Select, Serial DQ₀ (DI) and DQ₁ (DO), DQ₂ (WP#) and DQ₃ (HOLD#/RESET#). The memory can be programmed 1 to 256 bytes at a time, using the Page Program instruction.

The device also offers a sophisticated method for protecting individual blocks against erroneous or malicious program and erase operations. By providing the ability to individually protect and unprotect blocks, a system can unprotect a specific block to modify its contents while keeping the remaining blocks of the memory array securely protected. This is useful in applications where program code is patched or updated on a subroutine or module basis or in applications where data storage segments need to be modified without running the risk of errant modifications to the program code segments.

The device is designed to allow either single Sector/Block at a time or full chip erase operation. The device can be configured to protect part of the memory as the software protected mode. The device can sustain a minimum of 100K program/erase cycles on each sector or block.

Contents

FEATURES	1
GENERAL DESCRIPTION	1
CONNECTION DIAGRAMS (TOP VIEW)	6
SIGNAL DESCRIPTION	9
Serial Data Input, Output and IOs (DI, DO and DQ ₀ , DQ ₁ , DQ ₂ , DQ ₃)	9
Serial Clock (CLK)	9
Chip Select (CS#)	9
Write Protect (WP#)	9
HOLD (HOLD#)	9
RESET (RESET#)	9
MEMORY ORGANIZATION	10
OPERATING FEATURES	15
Standard SPI Modes	15
Dual SPI Instruction	15
Quad I/O SPI Modes	16
Page Programming	17
Sector Erase, Half Block Erase, Block Erase and Chip Erase	17
Polling During a Write, Program or Erase Cycle	17
Active Power, Stand-by Power and Deep Power-Down Modes	17
Write Protection	17
INSTRUCTIONS	20
Reset-Enable (RSTEN) (66h) and Reset (RST) (99h)	24
Write Enable (WREN) (06h)	26
Volatile Status Register Write Enable (50h)	27
Write Disable (WRDI) (04h)	28
Read Status Register (RDSR) (05h)	29
Read Status Register 2 (RDSR 2) (09h/35h)	31
Read Status Register 3 (RDSR 3) (95h/15h)	33
Write Status Register (WRSR) (01h)	35
Read Data Bytes (READ) (03h)	36
Read Data Bytes at Higher Speed (FAST_READ) (0Bh)	37
Dual Output Fast Read (3Bh)	38
Dual Input / Output FAST_READ (BBh)	39
Quad Output Fast Read (6Bh)	40
Quad Input / Output FAST_READ (EBh)	41
Read Burst (0Ch)	42
Write Status Register 2 (31h/01h)	43
Write Status Register 3 (C0h/11h/01h)	44
Page Program (PP) (02h)	45
Quad Input Page Program (QPP) (32h)	46
Write Suspend (B0h/75h)	47
Write Suspend During Sector Erase or Block Erase	48
Write Suspend During Page Programming	48
Write Resume (30h/7Ah)	49
Sector Erase (SE) (20h)	51
32KB Half Block Erase (HBE) (52h)	52
64K Block Erase (BE) (D8h)	53
Chip Erase (CE) (C7h/60h)	54
Deep Power-down (DP) (B9h)	55
Release from Deep Power-down and Read Device ID (RDI)	56
Read Manufacturer / Device ID (90h)	58
Read Identification (RDID) (9Fh)	59
Program OTP array (42h)	60
Read OTP array (48h)	61
Erase OTP array (44h)	62

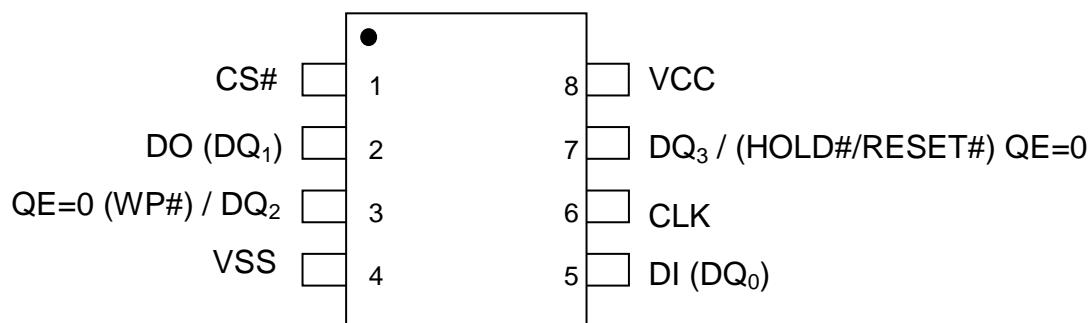
Read SFDP Mode and Unique ID Number (5Ah) (the SFDP table length support 512 byte length include unique ID)	63
Read SFDP Mode	63
Read Unique ID Number	77
Write Root Key Register (9Bh + 00h)	77
Update HMAC Key (9Bh + 01h)	78
Increment Monotonic Counter (9Bh + 02h)	78
Request Monotonic Counter (9Bh + 03h)	79
Reserved RPNC Commands (9Bh + 04h~FFh)	80
Read RPNC Status / Data (96h)	80
Power-up Timing	81
INITIAL DELIVERY STATE	82
DC Characteristics and Operating Conditions	82
AC Timing Input / Output Conditions	83
AC Timing Input / Output Conditions	84
ABSOLUTE MAXIMUM RATINGS	88
RECOMMENDED OPERATING RANGES ^{*1}	88
Input / Output Capacitance	89
Parameter Description	89
PACKAGE MECHANICAL	90
ORDERING INFORMATION	94
Revisions List	95
Important Notice	96

List of Figures

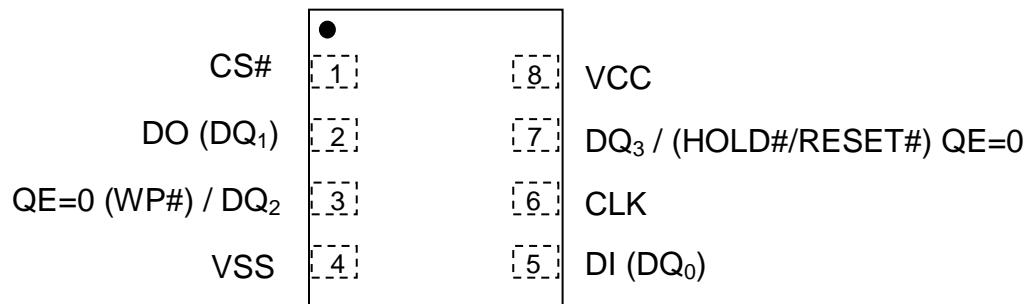
Figure 1. BLOCK DIAGRAM	8
Figure 2. SPI Modes.....	15
Figure 3. Quad SPI Modes	16
Figure 4. Reset-Enable and Reset Sequence Diagram.....	24
Figure 5. Software Reset Flow	25
Figure 6. Write Enable Instruction Sequence Diagram.....	26
Figure 7. Volatile Status Register Write Enable Instruction Sequence Diagram	27
Figure 8. Write Disable Instruction Sequence Diagram.....	28
Figure 9. Read Status Register Instruction Sequence Diagram	29
Figure 10. Read Status Register 2 Instruction Sequence Diagram	31
Figure 11. Read Status Register 3 Instruction Sequence Diagram	33
Figure 12. Write Status Register Instruction Sequence Diagram	35
Figure 13. Write Status Register Instruction Sequence Diagram (multi byte).....	35
Figure 14. Read Data Instruction Sequence Diagram.....	36
Figure 15. Fast Read Instruction Sequence Diagram.....	37
Figure 16. Dual Output Fast Read Instruction Sequence Diagram	38
Figure 17. Dual Input / Output Fast Read Instruction Sequence Diagram.....	39
Figure 18. Quad Output Fast Read Instruction Sequence Diagram	40
Figure 19. Quad Input / Output Fast Read Instruction Sequence Diagram	41
Figure 20. Read Burst Instruction Sequence Diagram	42
Figure 21. Write Status Register 2 Instruction Sequence Diagram	43
Figure 22. Write Status Register 3 Instruction Sequence Diagram	44
Figure 23. Page Program Instruction Sequence Diagram	45
Figure 24. Quad Input Page Program Instruction Sequence Diagram (SPI Mode only).....	46
Figure 25. Write Suspend Instruction Sequence Diagram.....	47
Figure 26. Suspend to Read Latency	48
Figure 27. Resume to Read Latency	48
Figure 28. Resume to Suspend Latency	48
Figure 29. Write Resume Instruction Sequence Diagram	49
Figure 30. Write Suspend / Resume Flow	50
Figure 31. Sector Erase Instruction Sequence Diagram	51
Figure 32. 32KB Half Block Erase Instruction Sequence Diagram	52
Figure 33. 64K Block Erase Instruction Sequence Diagram.....	53
Figure 34. Chip Erase Instruction Sequence Diagram	54
Figure 35. Deep Power-down Instruction Sequence Diagram.....	55
Figure 36. Release Power-down Instruction Sequence Diagram	56
Figure 37. Release Power-down / Device ID Instruction Sequence Diagram.....	57
Figure 38. Read Manufacturer / Device ID Diagram.....	58
Figure 39. Read Identification (RDID)	59
Figure 40. Program OTP array	60
Figure 41. Read OTP array	61
Figure 42. Erase OTP array	62
Figure 43. Read SDFP Mode Instruction Sequence Diagram	63
Figure 44. Write Root Key Instruction Sequence Diagram	77
Figure 45. Update HMAC Key Instruction Sequence Diagram	78
Figure 46. Increment Monotonic Counter Instruction Sequence Diagram	78
Figure 47. Request Monotonic Counter Instruction Sequence Diagram.....	79
Figure 48. Read RPNC Status / Data Instruction Sequence Diagram (BUSY=0)	80
Figure 49. Read RPNC Status Instruction Sequence Diagram (BUSY=1).....	80
Figure 50. Power-up Timing	81
Figure 51. Measurement I/O Waveform	83
Figure 52. Serial Output Timing.....	86
Figure 53. Input Timing	86
Figure 54. Hold Timing	86
Figure 55. Reset Timing	87
Figure 56. Overshoot Waveform	88
Figure 57. SOP 200 mil (official name = 208 mil)	90
Figure 58. 16-LEAD SOP 300 mil.....	91
Figure 59. 8-LEAD VDFN / WSON (6x5 mm).....	92
Figure 60. 8-LEAD VDFN / WSON (8x6 mm).....	93

List of Tables

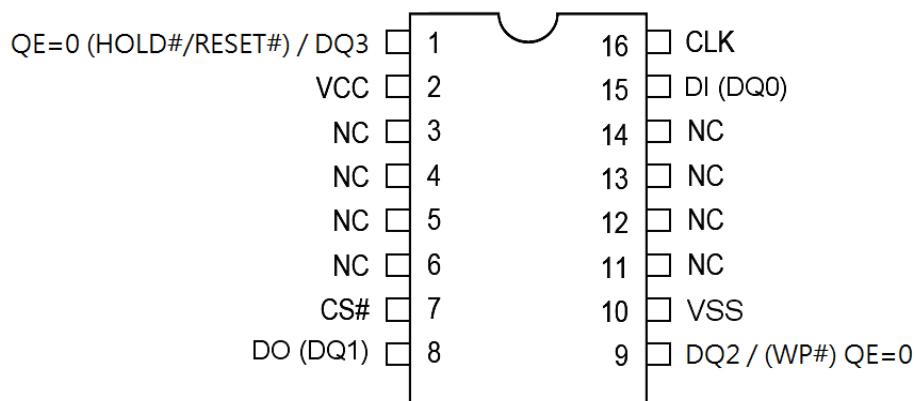
Table 1. Pin Names.....	7
Table 2. Uniform Block Sector Architecture.....	11
Table 3. Protected Area Sizes Sector Organization	18
Table 4. Instruction Set	21
Table 5. Instruction Set (Read Instruction)	22
Table 6. Instruction Set (Program Instruction)	22
Table 7. Instruction Set (Erase Instruction)	22
Table 8. RPNC command	23
Table 9. Manufacturer and Device Identification	23
Table 10. Status Register Bit Locations	30
Table 11. Status Register 2 Bit Locations	32
Table 12. Status Register 3 Bit Locations	34
Table 13. Burst Address Range	42
Table 14. OTP Sector Address.....	60
Table 15. Serial Flash Discoverable Parameters (SFDP) Signature and Parameter Identification Data Value (Advanced Information)	64
Table 16. Parameter ID (0) (Advanced Information).....	65
Table 17. Parameter ID (1) (Advanced Information-4byte address instruction).....	74
Table 18. RPNC Parameter ID.....	75
Table 19. Parameter ID (2) (Advanced Information-ESMT flash parameter).....	76
Table 20. Unique ID Number.....	77
Table 21. Power-Up Timing.....	81
Table 22. DC Characteristics	82
Table 23. AC Measurement Conditions.....	83
Table 24. AC Characteristics.....	84
Table 25. Absolute Ratings	88
Table 26. Operating Conditions.....	88
Table 27. CAPACITANCE	89

CONNECTION DIAGRAMS (TOP VIEW)


8 - LEAD SOP



8 - LEAD VDFN / WSON



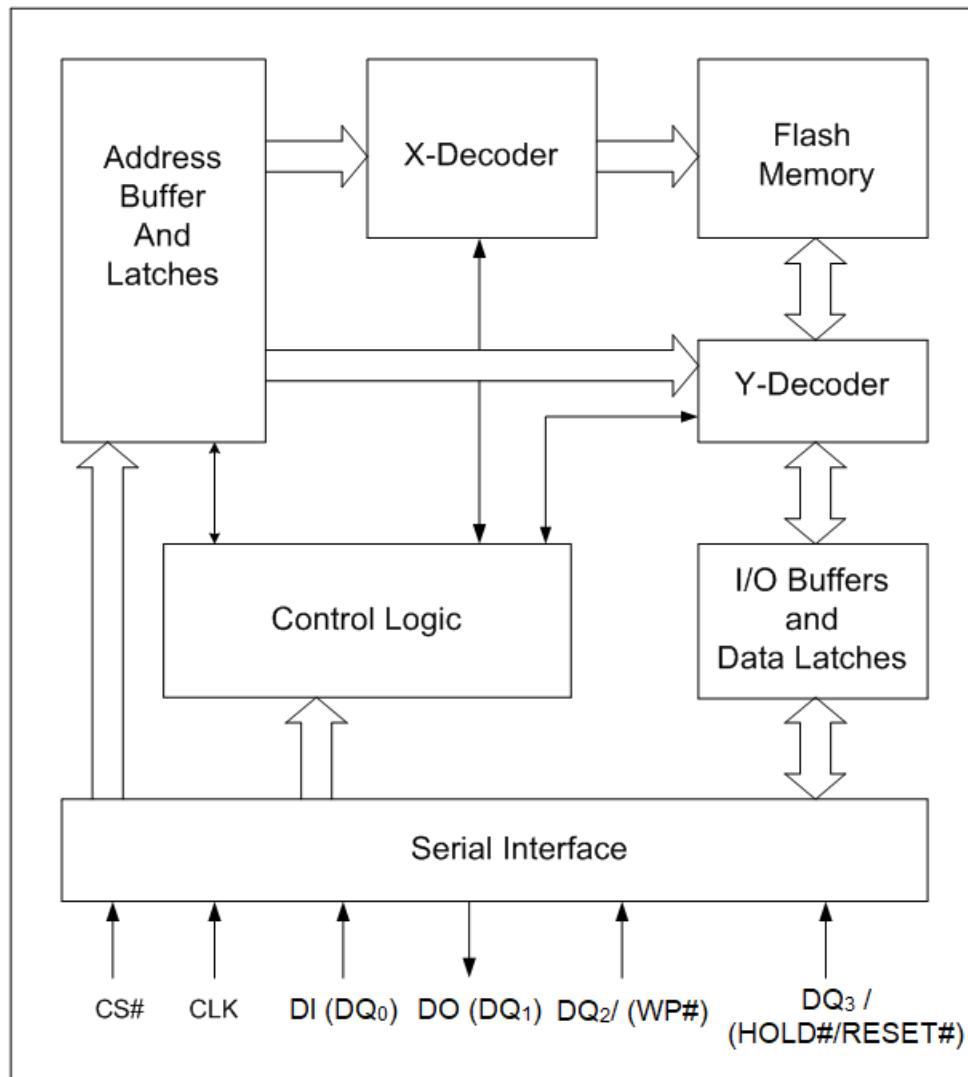
16 - LEAD SOP

Table 1. Pin Names

Symbol	Pin Name
CLK	Serial Clock Input
DI (DQ ₀)	Serial Data Input (Data Input Output 0) ^{*1}
DO (DQ ₁)	Serial Data Output (Data Input Output 1) ^{*1}
CS#	Chip Enable
DQ ₂ / (WP#)	Data Input Output 2/ (Write Protect pin) ^{*2}
DQ ₃ / (HOLD#/RESET#)	Data Input Output 3/ (HOLD#/RESET# pin) ^{*2,3}
V _{cc}	Supply Voltage (2.7-3.6V)
V _{ss}	Ground
NC	No Connect

Note:

1. DQ₀ and DQ₁ are used for Dual and Quad instructions.
2. DQ₀ ~ DQ₃ are used for Quad instructions.
Default Quad Output, WP# & HOLD#/RESET# functions can be available by setting QE=0 for Standard/Dual SPI mode.
3. All RPMD instructions are not support HOLD# function.

Figure 1. BLOCK DIAGRAM

Note:

1. DQ₀ and DQ₁ are used for Dual instructions.
2. DQ₀ ~ DQ₃ are used for Quad instructions.

SIGNAL DESCRIPTION

Serial Data Input, Output and IOs (DI, DO and DQ₀, DQ₁, DQ₂, DQ₃)

The device support standard SPI, Dual SPI and Quad SPI operation. Standard SPI instructions use the unidirectional DI (input) pin to serially write instructions, addresses or data to the device on the rising edge of the Serial Clock (CLK) input pin. Standard SPI also uses the unidirectional DO (output) to read data or status from the device on the falling edge CLK.

Dual and Quad SPI instruction use the bidirectional IO pins to serially write instruction, addresses or data to the device on the rising edge of CLK and read data or status from the device on the falling edge of CLK.

Serial Clock (CLK)

The SPI Serial Clock Input (CLK) pin provides the timing for serial input and output operations. ("See SPI Mode")

Chip Select (CS#)

The SPI Chip Select (CS#) pin enables and disables device operation. When CS# is high the device is deselected and the Serial Data Output (DO, or DQ₀, DQ₁, DQ₂ and DQ₃) pins are at high impedance. When deselected, the devices power consumption will be at standby levels unless an internal erase, program or status register cycle is in progress. When CS# is brought low the device will be selected, power consumption will increase to active levels and instructions can be written to and data read from the device. After power-up, CS# must transition from high to low before a new instruction will be accepted.

Write Protect (WP#)

The device default setting is WP# disable by QE=1. The Write Protect (WP#) pin can be used to prevent the Status Register from being written. Used in conjunction with the Status Register's Block Protect (CMP, 4KBL, TB, BP2, BP1 and BP0) bits and Status Register Protect (SRP) bits, a portion or the entire memory array can be hardware protected. The WP# function is only available after setting QE=0 for standard SPI and Dual SPI operation, when during Quad SPI, this pin is the Serial Data IO (DQ2) for Quad I/O operation.

HOLD (HOLD#)

The device default setting is HOLD# disable by QE=1. The HOLD# pin allows the device to be paused while it is actively selected. When QE bit is "0" and HRSW bit is "0" (factory default), the HOLD# pin is enabled. When HOLD# is brought low, while CS# is low, the DO pin will be at high impedance and signals on the DI and CLK pins will be ignored (don't care). The hold function can be useful when multiple devices are sharing the same SPI signals. The HOLD# function is only available after setting QE=0 for standard SPI and Dual SPI operation, when during Quad SPI, this pin is the Serial Data IO (DQ3) for Quad I/O operation.

All RPNC instructions are not support HOLD# function.

RESET (RESET#)

The device default setting is RESET# disable by QE=1. The RESET# pin allows the device to be reset by the controller. When QE bit is "0" and HRSW bit is '1' (factory default is '0'), the RESET# pin is enabled. The Hardware Reset function is only available after setting QE=0 for standard SPI and Dual SPI operation, when during Quad SPI, this pin is the Serial Data IO (DQ3) for Quad I/O operation. Set RESET# to low for a minimum period 1us (t_{HRST}) will interrupt any on-going instructions to have the device to initial state. The device can accept new instructions again in 28 us (t_{HRSR}) after RESET# back to high.

MEMORY ORGANIZATION

The memory is organized as:

- 16,777,216 bytes
- Uniform Sector Architecture
- 256 blocks of 64-Kbyte
- 512 blocks of 32-Kbyte
- 4,096 sectors of 4-Kbyte
- 65,536 pages (256 bytes each)

Each page can be individually programmed (bits are programmed from 1 to 0). The device is Sector, Block or Chip Erasable but not Page Erasable.

Table 2. Uniform Block Sector Architecture (1/4)

64K Block	32K Block	Sector	Address range	
255	511	4095	FFF000h	FFFFFFFFFFh
		⋮	⋮	⋮
	510	4080	FF0000h	FF0FFFFh
254	509	4079	FEF000h	FEFFFFFFh
		⋮	⋮	⋮
	508	4064	FE0000h	FE0FFFFh
253	507	4063	FDF000h	FDFFFFFFh
		⋮	⋮	⋮
	506	4048	FD0000h	FD0FFFFh
⋮	⋮	⋮	⋮	⋮
242	485	3887	F2F000h	F2FFFFFFh
		⋮	⋮	⋮
	484	3872	F20000h	F20FFFFh
241	483	3871	F1F000h	F1FFFFFFh
		⋮	⋮	⋮
	482	3856	F10000h	F10FFFFh
240	481	3855	F0F000h	F0FFFFFFh
		⋮	⋮	⋮
	480	3840	F00000h	F00FFFFh

64K Block	32K Block	Sector	Address range	
239	479	3839	EFF000h	EFFFFFFh
		⋮	⋮	⋮
	478	3824	EF0000h	EF0FFFFh
238	477	3823	EEF000h	EEFFFFFFh
		⋮	⋮	⋮
	476	3808	EE0000h	EE0FFFFh
237	475	3807	EDF000h	EDFFFFFFh
		⋮	⋮	⋮
	474	3792	ED0000h	ED0FFFFh
⋮	⋮	⋮	⋮	⋮
226	453	3631	E2F000h	E2FFFFFFh
		⋮	⋮	⋮
	452	3616	E20000h	E20FFFFh
225	451	3615	E1F000h	E1FFFFFFh
		⋮	⋮	⋮
	450	3600	E10000h	E10FFFFh
224	449	3599	E0F000h	E0FFFFFFh
		⋮	⋮	⋮
	448	3584	E00000h	E00FFFFh

64K Block	32K Block	Sector	Address range	
223	447	3583	DFF000h	DFFFFFFh
		⋮	⋮	⋮
	446	3568	DF0000h	DF0FFFFh
222	445	3567	DEF000h	DEFFFFFFh
		⋮	⋮	⋮
	444	3552	DE0000h	DE0FFFFh
221	443	3551	DDF000h	DDFFFFFFh
		⋮	⋮	⋮
	442	3536	DD0000h	DD0FFFFh
⋮	⋮	⋮	⋮	⋮
210	421	3375	D2F000h	D2FFFFFFh
		⋮	⋮	⋮
	420	3360	D20000h	D20FFFFh
209	419	3359	D1F000h	D1FFFFFFh
		⋮	⋮	⋮
	418	3344	D10000h	D10FFFFh
208	417	3343	D0F000h	D0FFFFFFh
		⋮	⋮	⋮
	416	3328	D00000h	D00FFFFh

64K Block	32K Block	Sector	Address range	
207	415	3327	CFF000h	CFFFFFFFh
		⋮	⋮	⋮
	414	3312	CF0000h	CF0FFFFh
206	413	3311	CEF000h	CEFFFFFFh
		⋮	⋮	⋮
	412	3296	CE0000h	CE0FFFFh
205	411	3295	CDF000h	CDFFFFFFh
		⋮	⋮	⋮
	410	3280	CD0000h	CD0FFFFh
⋮	⋮	⋮	⋮	⋮
194	389	3119	C2F000h	C2FFFFFFh
		⋮	⋮	⋮
	388	3014	C20000h	C20FFFFh
193	387	3103	C1F000h	C1FFFFFFh
		⋮	⋮	⋮
	386	3088	C10000h	C10FFFFh
192	385	3087	C0F000h	C0FFFFFFh
		⋮	⋮	⋮
	384	3072	C00000h	C00FFFFh

Table 2. Uniform Block Sector Architecture (2/4)

64K Block	32K Block	Sector	Address range	
191	383	3071	BFF000h	BFFFFFh
	
	382	3056	BF0000h	BF0FFFh
190	382	3055	BEF000h	BEFFFFh
	
	380	3040	BE0000h	BE0FFFh
189	379	3039	BDF000h	BDFFFFh
	
	378	3024	BD0000h	BD0FFFh
...
178	357	2863	B2F000h	B2FFFFh
	
	356	2848	B20000h	B20FFFh
177	355	2847	B1F000h	B1FFFFh
	
	354	2832	B10000h	B10FFFh
176	353	2831	B0F000h	B0FFFFh
	
	352	2816	B00000h	B00FFFh

64K Block	32K Block	Sector	Address range	
175	351	2815	AFF000h	AFFFFFh
	
	350	2800	AF0000h	AF0FFFh
174	349	2799	AEF000h	AEFFFFh
	
	348	2784	AE0000h	AE0FFFh
173	347	2783	ADF000h	ADFFFFh
	
	346	2768	AD0000h	AD0FFFh
...
162	325	2607	A2F000h	A2FFFFh
	
	324	2592	A20000h	A20FFFh
161	323	2591	A1F000h	A1FFFFh
	
	322	2576	A10000h	A10FFFh
160	321	2575	A0F000h	A0FFFFh
	
	320	2560	A00000h	A00FFFh

64K Block	32K Block	Sector	Address range	
159	319	2559	9FF000h	9FFFFFh
	
	318	2544	9F0000h	9F0FFFh
158	317	2543	9EF000h	9EFFFFh
	
	316	2528	9E0000h	9E0FFFh
157	315	2527	9DF000h	9DFFFFh
	
	314	2512	9D0000h	9D0FFFh
...
146	293	2351	92F000h	92FFFFh
	
	292	2336	920000h	920FFFh
145	291	2335	91F000h	91FFFFh
	
	290	2320	910000h	910FFFh
144	289	2319	90F000h	90FFFFh
	
	288	2304	900000h	900FFFh

64K Block	32K Block	Sector	Address range	
143	287	2303	8FF000h	8FFFFFh
	
	286	2288	8F0000h	8F0FFFh
142	285	2287	8EF000h	8EFFFFh
	
	284	2272	8E0000h	8E0FFFh
141	283	2271	8DF000h	8DFFFFh
	
	282	2256	8D0000h	8D0FFFh
...
130	261	2095	82F000h	82FFFFh
	
	260	2080	820000h	820FFFh
129	259	2079	81F000h	81FFFFh
	
	258	2064	810000h	810FFFh
128	257	2063	80F000h	80FFFFh
	
	256	2048	800000h	800FFFh

Table 2. Uniform Block Sector Architecture (3/4)

64K Block	32K Block	Sector	Address range	
127	255	2047	7FF000h	7FFFFFh
		⋮	⋮	⋮
	254	2032	7F0000h	7F0FFFh
126	253	2031	7EF000h	7EFFFFh
		⋮	⋮	⋮
	252	2016	7E0000h	7E0FFFh
125	251	2015	7DF000h	7DFFFFh
		⋮	⋮	⋮
	250	2000	7D0000h	7D0FFFh
⋮	⋮	⋮	⋮	⋮
114	229	1839	72F000h	72FFFFh
		⋮	⋮	⋮
	228	1824	720000h	720FFFh
113	227	1823	71F000h	71FFFFh
		⋮	⋮	⋮
	226	1808	710000h	710FFFh
112	225	1807	70F000h	70FFFFh
		⋮	⋮	⋮
	224	1792	700000h	700FFFh

64K Block	32K Block	Sector	Address range	
111	223	1791	6FF000h	6FFFFFFh
		⋮	⋮	⋮
	222	1776	6F0000h	6F0FFFh
110	221	1775	6EF000h	6EFFFFh
		⋮	⋮	⋮
	220	1760	6E0000h	6E0FFFh
109	219	1759	6DF000h	6DFFFFh
		⋮	⋮	⋮
	218	1744	6D0000h	6D0FFFh
⋮	⋮	⋮	⋮	⋮
98	197	1583	62F000h	62FFFFh
		⋮	⋮	⋮
	196	1568	620000h	620FFFh
97	195	1567	61F000h	61FFFFh
		⋮	⋮	⋮
	194	1552	610000h	610FFFh
96	193	1551	60F000h	60FFFFh
		⋮	⋮	⋮
	192	1536	600000h	600FFFh

64K Block	32K Block	Sector	Address range	
95	191	1535	5FF000h	5FFFFFFh
		⋮	⋮	⋮
	190	1520	5F0000h	5F0FFFh
94	189	1519	5EF000h	5EFFFFh
		⋮	⋮	⋮
	188	1504	5E0000h	5E0FFFh
93	187	1503	5DF000h	5DFFFFh
		⋮	⋮	⋮
	186	1488	5D0000h	5D0FFFh
⋮	⋮	⋮	⋮	⋮
82	165	1327	52F000h	52FFFFh
		⋮	⋮	⋮
	164	1312	520000h	520FFFh
81	163	1311	51F000h	51FFFFh
		⋮	⋮	⋮
	162	1296	510000h	510FFFh
80	161	1295	50F000h	50FFFFh
		⋮	⋮	⋮
	160	1280	500000h	500FFFh

64K Block	32K Block	Sector	Address range	
79	159	1279	4FF000h	4FFFFFFh
		⋮	⋮	⋮
	158	1264	4F0000h	4F0FFFh
78	157	1263	4EF000h	4EFFFFh
		⋮	⋮	⋮
	156	1248	4E0000h	4E0FFFh
77	155	1247	4DF000h	4DFFFFh
		⋮	⋮	⋮
	154	1232	4D0000h	4D0FFFh
⋮	⋮	⋮	⋮	⋮
66	133	1071	42F000h	42FFFFh
		⋮	⋮	⋮
	132	1056	420000h	420FFFh
65	131	1055	41F000h	41FFFFh
		⋮	⋮	⋮
	130	1040	410000h	410FFFh
64	129	1039	40F000h	40FFFFh
		⋮	⋮	⋮
	128	1024	400000h	400FFFh

Table 2. Uniform Block Sector Architecture (4/4)

64K Block	32K Block	Sector	Address range	
63	127	1023	3FF000h	3FFFFh
		⋮	⋮	⋮
62	126	1008	3F0000h	3F0FFFh
	125	1007	3EF000h	3EFFFFh
61	124	⋮	⋮	⋮
	123	992	3E0000h	3E0FFFh
60	122	991	3DF000h	3DFFFFh
		⋮	⋮	⋮
50	101	976	3D0000h	3D0FFFh
		⋮	⋮	⋮
49	100	815	32F000h	32FFFFh
		⋮	⋮	⋮
48	99	800	320000h	320FFFh
	98	799	31F000h	31FFFFh
47		⋮	⋮	⋮
	97	784	310000h	310FFFh
46	96	783	30F000h	30FFFFh
		⋮	⋮	⋮
45	95	768	300000h	300FFFh
		⋮	⋮	⋮

64K Block	32K Block	Sector	Address range	
47	95	767	2FF000h	2FFFFh
		⋮	⋮	⋮
46	94	752	2F0000h	2F0FFFh
	93	751	2EF000h	2EFFFFh
45	92	736	2E0000h	2E0FFFh
	91	735	2DF000h	2DFFFFh
44	90	720	2D0000h	2D0FFFh
		⋮	⋮	⋮
43	69	559	22F000h	22FFFFh
		⋮	⋮	⋮
42	68	544	220000h	220FFFh
	67	543	21F000h	21FFFFh
41	66	528	210000h	210FFFh
	65	527	20F000h	20FFFFh
40	64	512	200000h	200FFFh
		⋮	⋮	⋮

64K Block	32K Block	Sector	Address range	
31	63	511	1FF000h	1FFFFh
		⋮	⋮	⋮
30	62	496	1F0000h	1F0FFFh
	61	495	1EF000h	1EFFFFh
29	60	480	1E0000h	1E0FFFh
	59	479	1DF000h	1DFFFFh
28	58	464	1D0000h	1D0FFFh
		⋮	⋮	⋮
27	37	303	12F000h	12FFFFh
		⋮	⋮	⋮
26	36	288	120000h	120FFFh
		⋮	⋮	⋮
25	35	287	11F000h	11FFFFh
		⋮	⋮	⋮
24	34	272	110000h	110FFFh
		⋮	⋮	⋮
23	33	271	10F000h	10FFFFh
		⋮	⋮	⋮
22	32	256	100000h	100FFFh
		⋮	⋮	⋮

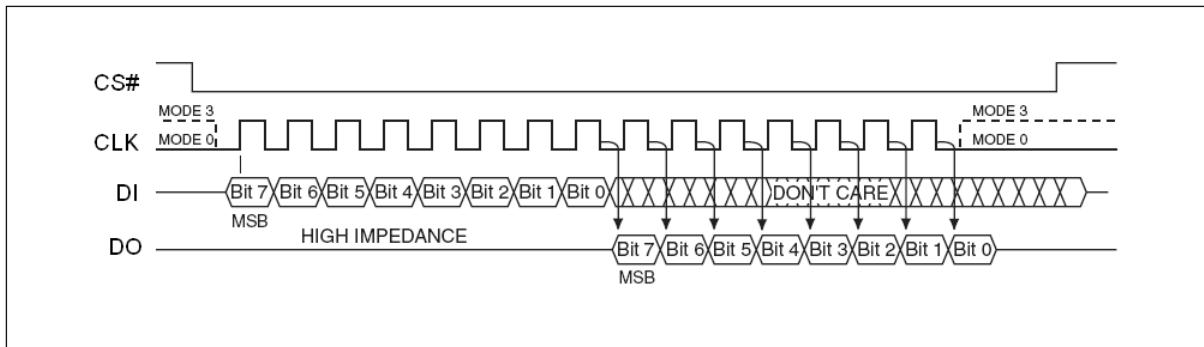
64K Block	32K Block	Sector	Address range	
15	31	255	0FF000h	0FFFFh
		⋮	⋮	⋮
14	30	240	0F0000h	0F0FFFh
	29	239	0EF000h	0EFFFFh
13	28	224	0E0000h	0E0FFFh
	27	223	0DF000h	0DFFFFh
12	26	208	0D0000h	0D0FFFh
		⋮	⋮	⋮
11	5	47	02F000h	02FFFFh
		⋮	⋮	⋮
10	4	32	020000h	020FFFh
		⋮	⋮	⋮
9	3	31	01F000h	01FFFFh
		⋮	⋮	⋮
8	2	16	010000h	010FFFh
		⋮	⋮	⋮
7	1	15	00F000h	00FFFFh
		⋮	⋮	⋮
6	0	0	000000h	000FFFh
		⋮	⋮	⋮

OPERATING FEATURES

Standard SPI Modes

The device is accessed through an SPI compatible bus consisting of four signals: Serial Clock (CLK), Chip Select (CS#), Serial Data Input (DI) and Serial Data Output (DO). Both SPI bus operation Modes 0 (0,0) and 3 (1,1) are supported. The primary difference between Mode 0 and Mode 3, as shown in SPI Modes figure, concerns the normal state of the CLK signal when the SPI bus master is in standby and data is not being transferred to the Serial Flash. For Mode 0 the CLK signal is normally low. For Mode 3 the CLK signal is normally high. In either case data input on the DI pin is sampled on the rising edge of the CLK. Data output on the DO pin is clocked out on the falling edge of CLK.

Figure 2. SPI Modes



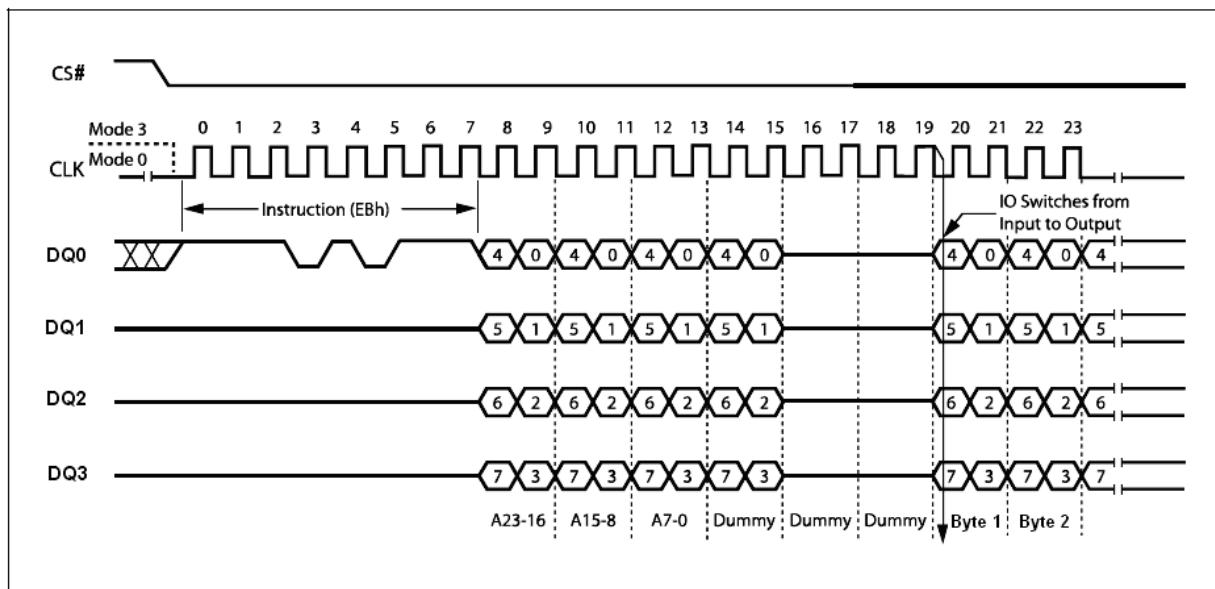
Dual SPI Instruction

The device supports Dual SPI operation when using the “Dual Output Fast Read and Dual I/ O FAST_READ “ (3Bh and BBh) instructions. These instructions allow data to be transferred to or from the Serial Flash memory at two to three times the rate possible with the standard SPI. The Dual Read instructions are ideal for quickly downloading code from Flash to RAM upon power-up (code-shadowing) or for application that cache code-segments to RAM for execution. The Dual output feature simply allows the SPI input pin to also serve as an output during this instruction. When using Dual SPI instructions the DI and DO pins become bidirectional I/O pins; DQ₀ and DQ₁. All other operations use the standard SPI interface with single output signal.

Quad I/O SPI Modes

The device supports Quad input/output operation when using the Quad I/O Fast Read (EBh). This instruction allows data to be transferred to or from the Serial Flash memory at four to six times the rate possible with the standard SPI. The Quad Read instruction offer a significant improvement in continuous and random access transfer rates allowing fast code-shadowing to RAM or for application that cache code-segments to RAM for execution.

Figure 3. Quad SPI Modes



Page Programming

To program one data byte, two instructions are required: Write Enable (WREN), which is one byte, and a Page Program (PP) or Quad Input Page Program (QPP) sequence, which consists of four bytes plus data. This is followed by the internal Program cycle (of duration t_{PP}).

To spread this overhead, the Page Program (PP) or Quad Input Page Program (QPP) instruction allows up to 256 bytes to be programmed at a time (changing bits from 1 to 0) provided that they lie in consecutive addresses on the same page of memory.

Sector Erase, Half Block Erase, Block Erase and Chip Erase

The Page Program (PP) or Quad Input Page Program (QPP) instruction allows bits to be reset from 1 to 0. Before this can be applied, the bytes of memory need to have been erased to all 1s (FFh). This can be achieved a sector at a time, using the Sector Erase (SE) instruction, half a block at a time using the Half Block Erase (HBE) instruction, a block at a time using the Block Erase (BE) instruction or throughout the entire memory, using the Chip Erase (CE) instruction. This starts an internal Erase cycle (of duration t_{SE} , t_{HBE} , t_{BE} or t_{CE}). The Erase instruction must be preceded by a Write Enable (WREN) instruction.

Polling During a Write, Program or Erase Cycle

A further improvement in the time to Write Status Register (WRSR), Program (PP, QPP) or Erase (SE, HBE, BE or CE) can be achieved by not waiting for the worst case delay (t_W , t_{PP} , t_{SE} , t_{HBE} , t_{BE} or t_{CE}). The Write In Progress (WIP) bit is provided in the Status Register so that the application program can monitor its value, polling it to establish when the previous Write cycle, Program cycle or Erase cycle is complete.

Active Power, Stand-by Power and Deep Power-Down Modes

When Chip Select (CS#) is Low, the device is enabled, and in the Active Power mode. When Chip Select (CS#) is High, the device is disabled, but could remain in the Active Power mode until all internal cycles have completed (Program, Erase, Write Status Register). The device then goes into the Stand-by Power mode. The device consumption drops to I_{CC1} .

The Deep Power-down mode is entered when the specific instruction (the Enter Deep Power-down Mode (DP) instruction) is executed. The device consumption drops further to I_{CC2} . The device remains in this mode until another specific instruction (the Release from Deep Power-down Mode and Read Device ID (RDI) instruction) is executed.

All other instructions are ignored while the device is in the Deep Power-down mode. This can be used as an extra software protection mechanism, when the device is not in active use, to protect the device from inadvertent Write, Program or Erase instructions.

Write Protection

Applications that use non-volatile memory must take into consideration the possibility of noise and other adverse system conditions that may compromise data integrity. To address this concern the device provides the following data protection mechanisms:

- Power-On Reset and an internal timer (t_{PWR}) can provide protection against inadvertent changes while the power supply is outside the operating specification.
- Program, Erase and Write Status Register instructions are checked that they consist of a number of clock pulses that is a multiple of eight, before they are accepted for execution.
- All instructions that modify data must be preceded by a Write Enable (WREN) instruction to set the Write Enable Latch (WEL) bit. This bit is returned to its reset state by the following events:
 - Power-up
 - Write Disable (WRDI) instruction completion or Write Status Register (WRSR) instruction completion or Page Program (PP), Quad Input Page Program (QPP) instruction completion or Sector Erase (SE) instruction completion or Half Block Erase (HBE) / Block Erase (BE) instruction completion or Chip Erase (CE) instruction completion
 - Software/Hardware Reset completion
- The Block Protect (CMP, 4KBL, TB, BP2, BP1, BP0) bits allow part of the memory to be configured as read-only. This is the Software Protected Mode (SPM).
- The Write Protect (WP#) signal allows the Block Protect (CMP, 4KBL, TB, BP2, BP1, BP0) bits and Status Register Protect (SRP) bit to be protected. This is the Hardware Protected Mode (HPM).
- In addition to the low power consumption feature, the Deep Power-down mode offers extra software protection from inadvertent Write, Program and Erase instructions, as all instructions are ignored except one particular instruction (the Release from Deep Power-down instruction).

Table 3. Protected Area Sizes Sector Organization

Status Register Content						Memory Content			
CMP Bit	4KBL Bit	T/B Bit	SR.4 Bit	SR.3 Bit	SR.2 Bit	Protect Areas	Addresses	Density (KB)	Portion
0	0	0	0	0	0	None	None	None	None
0	0	0	0	0	1	Block 252 to 255	FC0000h-FFFFFh	256KB	Upper 1/64
0	0	0	0	1	0	Block 248 to 255	F80000h-FFFFFh	512KB	Upper 1/32
0	0	0	0	1	1	Block 240 to 255	F00000h-FFFFFh	1024KB	Upper 1/16
0	0	0	1	0	0	Block 224 to 255	E00000h-FFFFFh	2048KB	Upper 1/8
0	0	0	1	0	1	Block 192 to 255	C00000h-FFFFFh	4096KB	Upper 1/4
0	0	0	1	1	0	Block 128 to 255	800000h-FFFFFh	8192KB	Upper 1/2
0	0	0	1	1	1	Block 0 to 255	000000h-FFFFFh	16384KB	All
0	0	1	0	0	0	None	None	None	None
0	0	1	0	0	1	Block 0 to 3	000000h-03FFFFh	256KB	Lower 1/64
0	0	1	0	1	0	Block 0 to 7	000000h-07FFFFh	512KB	Lower 1/32
0	0	1	0	1	1	Block 0 to 15	000000h-0FFFFh	1024KB	Lower 1/16
0	0	1	1	0	0	Block 0 to 31	000000h-1FFFFh	2048KB	Lower 1/8
0	0	1	1	0	1	Block 0 to 63	000000h-3FFFFh	4096KB	Lower 1/4
0	0	1	1	1	0	Block 0 to 127	000000h-7FFFFh	8192KB	Lower 1/2
0	0	1	1	1	1	Block 0 to 255	000000h-FFFFFh	16384KB	All
0	1	0	0	0	0	None	None	None	None
0	1	0	0	0	1	Block 255	FFF000h-FFFFFh	4KB	Upper 1/4096
0	1	0	0	1	0	Block 255	FFE000h-FFFFFh	8KB	Upper 1/2048
0	1	0	0	1	1	Block 255	FFC000h-FFFFFh	16KB	Upper 1/1024
0	1	0	1	0	0	Block 255	FF8000h-FFFFFh	32KB	Upper 1/512
0	1	0	1	0	1	Block 255	FF8000h-FFFFFh	32KB	Upper 1/512
0	1	0	1	1	0	Block 255	FF8000h-FFFFFh	32KB	Upper 1/512
0	1	0	1	1	1	Block 0 to 255	000000h-FFFFFh	16384KB	All
0	1	1	0	0	0	None	None	None	None
0	1	1	0	0	1	Block 0	000000h-000FFFh	4KB	Lower 1/4096
0	1	1	0	1	0	Block 0	000000h-001FFFh	8KB	Lower 1/2048
0	1	1	0	1	1	Block 0	000000h-003FFFh	16KB	Lower 1/1024
0	1	1	1	0	0	Block 0	000000h-007FFFh	32KB	Lower 1/512
0	1	1	1	0	1	Block 0	000000h-007FFFh	32KB	Lower 1/512
0	1	1	1	1	0	Block 0	000000h-007FFFh	32KB	Lower 1/512
0	1	1	1	1	1	Block 0 to 255	000000h-FFFFFh	16384KB	All
1	0	0	0	0	0	Block 0 to 255	000000h-FFFFFh	16384KB	All
1	0	0	0	0	1	Block 0 to 251	000000h-FBFFFFh	16128KB	Lower 63/64

1	0	0	0	1	0	Block 0 to 247	000000h-F7FFFFh	15872KB	Lower 31/32
1	0	0	0	1	1	Block 0 to 239	000000h-EFFFFFFh	15360KB	Lower 15/16
1	0	0	1	0	0	Block 0 to 223	000000h-DFFFFFFh	14336KB	Lower 7/8
1	0	0	1	0	1	Block 0 to 191	000000h-BFFFFFFh	12288KB	Lower 3/4
1	0	0	1	1	0	Block 0 to 127	000000h-7FFFFFFh	8192KB	Lower 1/2
1	0	0	1	1	1	None	None	None	None
1	0	1	0	0	0	Block 0 to 255	000000h-FFFFFFFh	16384KB	All
1	0	1	0	0	1	Block 4 to 255	040000h-FFFFFFFh	16128KB	Upper 63/64
1	0	1	0	1	0	Block 8 to 255	080000h-FFFFFFFh	15872KB	Upper 31/32
1	0	1	0	1	1	Block 16 to 255	100000h-FFFFFFFh	15360KB	Upper 15/16
1	0	1	1	0	0	Block 32 to 255	200000h-FFFFFFFh	14336KB	Upper 7/8
1	0	1	1	0	1	Block 64 to 255	400000h-FFFFFFFh	12288KB	Upper 3/4
1	0	1	1	1	0	Block 128 to 255	800000h-FFFFFFFh	8192KB	Upper 1/2
1	0	1	1	1	1	None	None	None	None
1	1	0	0	0	0	Block 0 to 255	000000h-FFFFFFFh	16384KB	All
1	1	0	0	0	1	Block 0 to 255	000000h-FFEFFFFh	16380KB	Lower 4095/4096
1	1	0	0	1	0	Block 0 to 255	000000h-FFDFFFFh	16376KB	Lower 2047/2048
1	1	0	0	1	1	Block 0 to 255	000000h-FFBFFFFh	16368KB	Lower 1023/1024
1	1	0	1	0	0	Block 0 to 255	000000h-FF7FFFFh	16352KB	Lower 511/512
1	1	0	1	0	1	Block 0 to 255	000000h-FF7FFFFh	16352KB	Lower 511/512
1	1	0	1	1	0	Block 0 to 255	000000h-FF7FFFFh	16352KB	Lower 511/512
1	1	0	1	1	1	None	None	None	None
1	1	1	0	0	0	Block 0 to 255	000000h-FFFFFFFh	16384KB	All
1	1	1	0	0	1	Block 0 to 255	001000h-FFFFFFFh	16380KB	Upper 4095/4096
1	1	1	0	1	0	Block 0 to 255	002000h-FFFFFFFh	16376KB	Upper 2047/2048
1	1	1	0	1	1	Block 0 to 255	004000h-FFFFFFFh	16368KB	Upper 1023/1024
1	1	1	1	0	0	Block 0 to 255	008000h-FFFFFFFh	16352KB	Upper 511/512
1	1	1	1	0	1	Block 0 to 255	008000h-FFFFFFFh	16352KB	Upper 511/512
1	1	1	1	1	0	Block 0 to 255	008000h-FFFFFFFh	16352KB	Upper 511/512
1	1	1	1	1	1	None	None	None	None

INSTRUCTIONS

All instructions, addresses and data are shifted in and out of the device, most significant bit first. Serial Data Input (DI) is sampled on the first rising edge of Serial Clock (CLK) after Chip Select (CS#) is driven Low. Then, the one-byte instruction code must be shifted in to the device, most significant bit first, on Serial Data Input (DI), each bit being latched on the rising edges of Serial Clock (CLK).

The instruction set is listed in Instruction Set table. Every instruction sequence starts with a one-byte instruction code. Depending on the instruction, it might be followed by address bytes, or data bytes, or both or none. Chip Select (CS#) must be driven High after the last bit of the instruction sequence has been shifted in. In the case of a Read Data Bytes (READ), Read Data Bytes at Higher Speed (Fast_Read), Dual Output Fast Read (3Bh), Dual I/O Fast Read (BBh), Quad Output Fast Read (6Bh), Quad Input/ Output FAST_READ (EBh), Read Status Register (RDSR), Release from Deep Power-down, and Read Device ID (RDI) instruction, the shifted-in instruction sequence is followed by a data-out sequence. Chip Select (CS#) can be driven High after any bit of the data-out sequence is being shifted out.

In the case of a write instruction, Chip Select (CS#) must be driven High exactly at a byte boundary, otherwise the instruction is rejected, and is not executed. That is, Chip Select (CS#) must driven High when the number of clock pulses after Chip Select (CS#) being driven Low is an exact multiple of eight. For Page Program, if at any time the input byte is not a full byte, nothing will happen and WEL will not be reset.

In the case of multi-byte commands of Page Program (PP), Quad Input Page Program (QPP), and Release from Deep Power Down (RES) minimum number of bytes specified has to be given, without which, the command will be ignored.

In the case of Page Program, if the number of byte after the command is less than 4 (at least 1 data byte), it will be ignored too. In the case of SE and HBE / BE, exact 24-bit address is a must, any less or more will cause the command to be ignored.

All attempts to access the memory array during a Write Status Register cycle, Program cycle or Erase cycle are ignored, and the internal Write Status Register cycle, Program cycle or Erase cycle continues unaffected.

Table 4. Instruction Set

Instruction Name	Byte 1 Code	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6	n-Bytes
RSTEN	66h						
⁽¹⁾ RST	99h						
Write Resume	30h/7Ah						
Write Suspend	B0h/75h						
Write Enable (WERN)	06h						
Volatile Status Register Write Enable ⁽²⁾	50h						
Write Disable (WRDI)	04h						
Read Status Register (RDSR)	05h	(SR7-SR0) ⁽³⁾					continuous ⁽⁴⁾
Write Status Register (WRSR)	01h	SR7-SR0	(SR2.7-SR2.0) ⁽⁸⁾	(SR3.7-SR3.0) ⁽⁸⁾			
Read Status Register 2 (RDSR2)	09h/35h	(SR2.7-SR2.0) ⁽³⁾					continuous ⁽⁴⁾
Write Status Register 2 (WRSR2)	31h	SR2.7-SR2.0					
Read Status Register 3 (RDSR3)	95h/15h	(SR3.7-SR3.0) ⁽³⁾					continuous ⁽⁴⁾
Write Status Register 3 (WRSR3)	C0h/11h	SR3.7-SR3.0					
Deep Power-down	B9h						
Release from Deep Power-down, and read Device ID (RES)	ABh	dummy	dummy	dummy	(ID7-ID0)		(5)
Release from Deep Power-down (RDP)							
Manufacturer/ Device ID	90h	dummy	dummy	00h 01h	(M7-M0) (ID7-ID0)	(ID7-ID0) (M7-M0)	(6)
Read Identification (RDID)	9Fh	(M7-M0)	(ID15-ID8)	(ID7-ID0)	(7)		
Read OTP array	48h	A23-A16	A15-A8	A7-A0	Dummy	D7-D0	(Next Byte) Continuous
Program OTP array	42h	A23-A16	A15-A8	A7-A0	D7-D0	D7-D0	(Next Byte) Continuous
Erase OTP array	44h	A23-A16	A15-A8	A7-A0			
Read SFDP mode and Unique ID Number	5Ah	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	(Next Byte) Continuous

Note:

1. RST command only executed if RSTEN command is executed first. Any intervening command will disable Reset.
2. Volatile Status Register Write Enable command must precede WRSR command without any intervening commands to write data to Volatile Status Register.
3. Data bytes are shifted with Most Significant Bit first. Byte fields with data in parenthesis "()" indicate data being read from the device on the DO pin.
4. The Status Register contents will repeat continuously until CS# terminate the instruction.
5. The Device ID will repeat continuously until CS# terminates the instruction.
6. The Manufacturer ID and Device ID bytes will repeat continuously until CS# terminates the instruction.
00h on Byte 4 starts with MID and alternate with DID, 01h on Byte 4 starts with DID and alternate with MID.
7. (M7-M0) : Manufacturer, (ID15-ID8) : Memory Type, (ID7-ID0) : Memory Capacity.
8. WREN(01h) support 8 or 16 or 24 bit register value input for status register, status register 2 and status register 3.

Table 5. Instruction Set (Read Instruction)

Instruction Name	OP Code	Address bits	Dummy bits Clocks (Default)	Data Out	Remark
Read Data	03h	24 bits	0	(D7-D0, ...)	(Next Byte) continuous
Fast Read	0Bh	24 bits	8 bits / 8 clocks	(D7-D0, ...)	(Next Byte) continuous
Dual Output Fast Read	3Bh	24 bits	8 bits / 8 clocks	(D7-D0, ...)	(one byte Per 4 clocks, continuous)
Dual I/O Fast Read	BBh	24 bits	8 bits / 4 clocks	(D7-D0, ...)	(one byte Per 4 clocks, continuous)
Quad I/O Fast Read	EBh	24 bits	24 bits / 6 clocks	(D7-D0, ...)	(one byte per 2 clocks, continuous)
Quad Output Fast Read	6Bh	24 bits	8 bits / 8 clocks	(D7-D0, ...)	(one byte per 2 clocks, continuous)
Burst Read with Wrap	0Ch	24 bits	8 bits / 8 clocks	(D7-D0, ...)	(Next Byte) continuous

Table 6. Instruction Set (Program Instruction)

Instruction Name	OP Code	Address bits	Dummy bits Clocks (Default)	Data In	Remark
Page Program (PP)	02h	24 bits	0	(D7-D0, ...)	(Next Byte) continuous
Quad Input Page Program (QPP)	32h	24 bits	0	(D7-D0, ...)	(one byte per 2 clocks, continuous)

Table 7. Instruction Set (Erase Instruction)

Instruction Name	OP Code	Address bits	Dummy bits Clocks (Default)	Data In	Remark
Sector Erase (SE)	20h	24 bits			
32K Half Block Erase (HBE)	52h	24 bits			
64K Block Erase (BE)	D8h	24 bits			
Chip Erase (CE)	C7h/ 60h	0 bits			

Table 8. RPNC command

Instruction Name	Byte 0	Byte 1 (Cmd Type)	Byte2	Byte 3	Byte n	Byte n
Write Root Key Register	9Bh	00h	Counter Addr [7:0]	Reserved [7:0]	Byte 4-35 Root Key [255:0]	Byte 36-63 Truncated Sign [223:0]
Update HMAC Key Register	9Bh	01h	Counter Addr [7:0]	Reserved [7:0]	Byte 4-7 Key Date [31:0]	Byte 8-39 Signature [255:0]
Increment Monotonic Counter	9Bh	02h	Counter Addr [7:0]	Reserved [7:0]	Byte 4-7 Counter Data [31:0]	Byte 8-39 Signature [255:0]
Request Monotonic Counter	9Bh	03h	Counter Addr [7:0]	Reserved [7:0]	Byte 4-15 Tag [95:0]	Byte 16-47 Signature [255:0]
Reserved Commands	9Bh	04h~FFh		Reserved		

Instruction Name	Byte 0	Byte 1	Byte2	Byte 3-14	Byte 15-18	Byte19-50
Read RPNC Status/Data	96h	dummy	RPNC Status [7:0]	Tag [95:0]	Counter Data [31:0]	Signature [255:0]

Note:

1. All RPNC instructions are in Standard SPI format. Each Input / Output Byte requires 8 clocks.
2. The Reserved[7:0] field for RPNC OP1 must be all 0s (00000000'b).
3. The controller may terminate the Read RPNC Status/Data instruction at any time without going through the entire data output sequence.
4. When BUSY=1, from Byte-3 and beyond, the device will output the RPNC_Status[7:0] value continuously until CS# terminates the instruction. The device will not output Tag, Counter Data & Signature fields when BUSY=1. Once BUSY becomes 0, another OP2 command must be issued to read out the correct Tag, Counter Data & Signature fields.
5. All RPNC instructions are not support HOLD# function.

Table 9. Manufacturer and Device Identification

OP Code	(M7-M0)	(ID15-ID0)	(ID7-ID0)
ABh			17h
90h	1Ch		17h
9Fh	1Ch	7118h	

Reset-Enable (RSTEN) (66h) and Reset (RST) (99h)

The Reset operation is used as a system (software) reset that puts the device in normal operating Ready mode. This operation consists of two commands: Reset-Enable (RSTEN) and Reset (RST).

To reset the device the host drives CS# low, sends the Reset-Enable command (66h), and drives CS# high. Next, the host drives CS# low again, sends the Reset command (99h), and drives CS# high.

The Reset operation requires the Reset-Enable command followed by the Reset command. Any command other than the Reset command after the Reset-Enable command will disable the Reset-Enable.

A successful command execution will reset the status registers, see Reset-Enable and Reset Sequence Diagram figure for SPI Mode. A device reset during an active Program or Erase operation aborts the operation, which can cause the data of the targeted address range to be corrupted or lost. Depending on the prior operation, the reset timing may vary. Recovery from a Write operation requires more software latency time (t_{SR}) than recovery from other operations. It is recommended to check the WIP bit and WSE/WSP bits in Status register and Status register2 before issuing the Software Reset command.

Figure 4. Reset-Enable and Reset Sequence Diagram

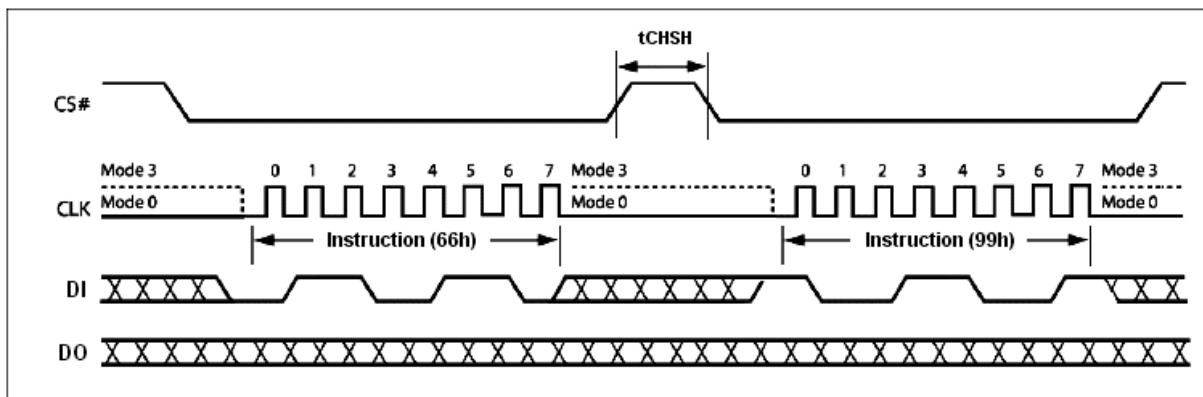
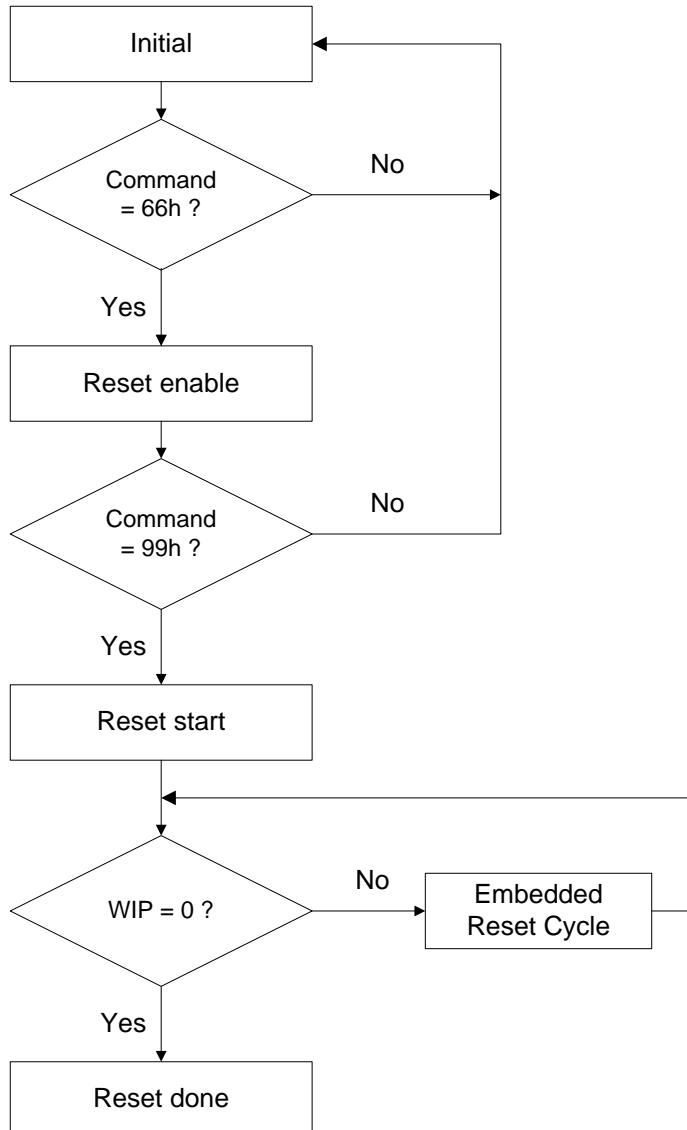


Figure 5. Software Reset Flow

Note:

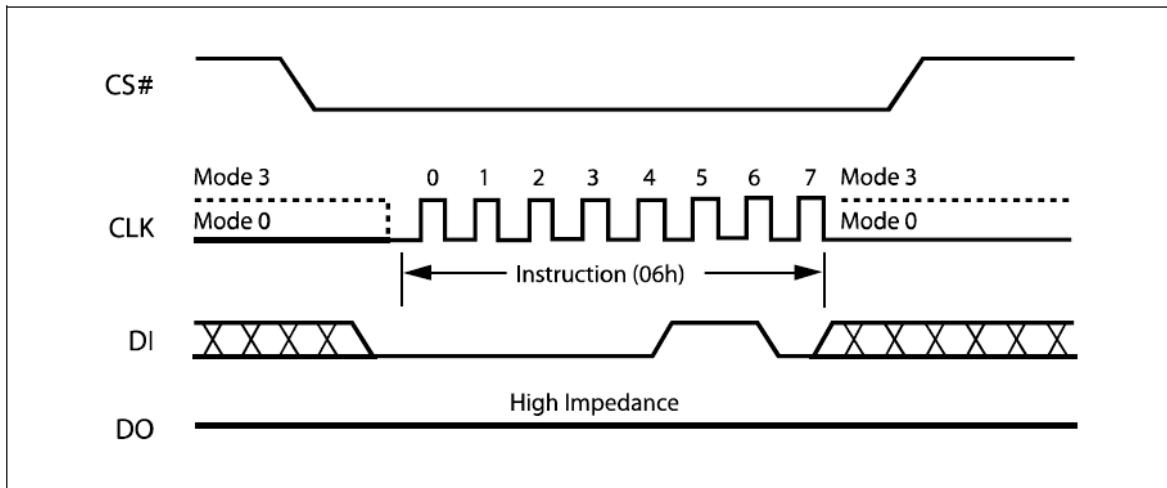
1. Reset-Enable (RSTEN) (66h) and Reset (RST) (99h) commands need to match standard SPI mode.
2. The reset command could be executed during embedded program and erase process to back to SPI mode.
3. This flow can release the device from Deep power down mode.
4. The Status Register Bit and Status Register 2/3 Bits will reset to default value after reset done.
5. If user reset device during erase, the embedded reset cycle software reset latency will take about 28 us in worst case.
6. User can't do software/ hardware reset command while doing erase operation.

Write Enable (WREN) (06h)

The Write Enable (WREN) instruction (Write Enable Instruction Sequence Diagram figure) sets the Write Enable Latch (WEL) bit. The Write Enable Latch (WEL) bit must be set prior to every Page Program (PP), Quad Input Page Program (QPP), Sector Erase (SE), Half Block Erase (HBE), Block Erase (BE), Chip Erase (CE) and Write Status Register (WRSR) instruction.

The Write Enable (WREN) instruction is entered by driving Chip Select (CS#) Low, sending the instruction code, and then driving Chip Select (CS#) High.

Figure 6. Write Enable Instruction Sequence Diagram

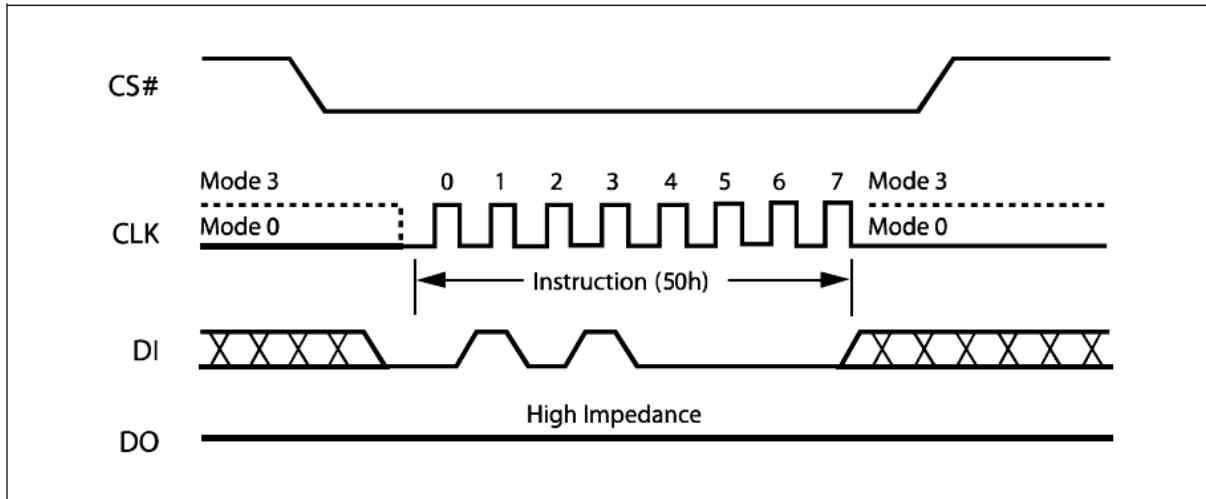


Volatile Status Register Write Enable (50h)

This feature enable user to change memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. The Volatile Status Register Write Enable (50h) command won't set the Write Enable Latch (WEL) bit, it is valid for 'Write Status Register' (01h), WRSR2 and WRSR3 commands to change the Volatile Status Register bit values.

To write to Volatile Status Register, issue the Volatile Status Register Write Enable (50h) command prior issuing WRSR (01h) or WRSR2 or WRSR3. The Status Register bits will be refresh to Volatile Status Register (SR[7:2] or SR2[7:0] or SR3[7:0]) within tSHSL2 (50ns). Upon power off or the execution of a Software/Hardware Reset, the volatile Status Register bit values will be lost, and the non-volatile Status Register bit values will be restored. The instruction sequence is shown in Volatile Status Register Write Enable Instruction Sequence Diagram figure.

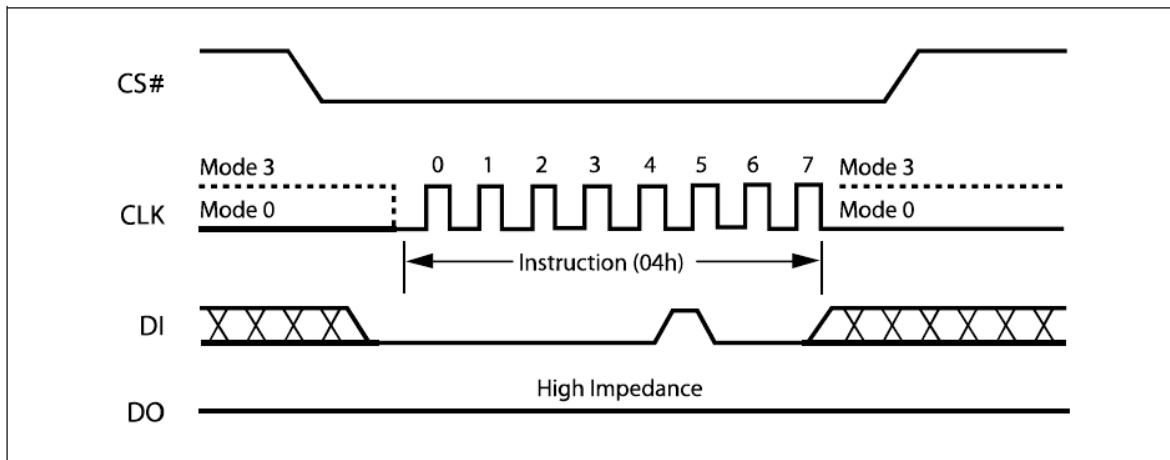
Figure 7. Volatile Status Register Write Enable Instruction Sequence Diagram



Write Disable (WRDI) (04h)

The Write Disable instruction (Write Disable Instruction Sequence Diagram figure) resets the Write Enable Latch (WEL) bit in the Status Register to a 0. The Write Disable instruction is entered by driving Chip Select (CS#) low, shifting the instruction code “04h” into the DI pin and then driving Chip Select (CS#) high. Note that the WEL bit is automatically reset after Power-up and upon completion of the Write Status Register, Page Program, Sector Erase, Half Block Erase (HBE), Block Erase (BE) and Chip Erase instructions.

Figure 8. Write Disable Instruction Sequence Diagram



Read Status Register (RDSR) (05h)

The Read Status Register (RDSR) instruction allows the Status Register to be read. The Status Register may be read at any time, even while a Program, Erase or Write Status Register cycle is in progress. When one of these cycles is in progress, it is recommended to check the Write In Progress (WIP) bit before sending a new instruction to the device. It is also possible to read the Status Register continuously, as shown in Read Status Register Instruction Sequence Diagram figure.

Figure 9. Read Status Register Instruction Sequence Diagram

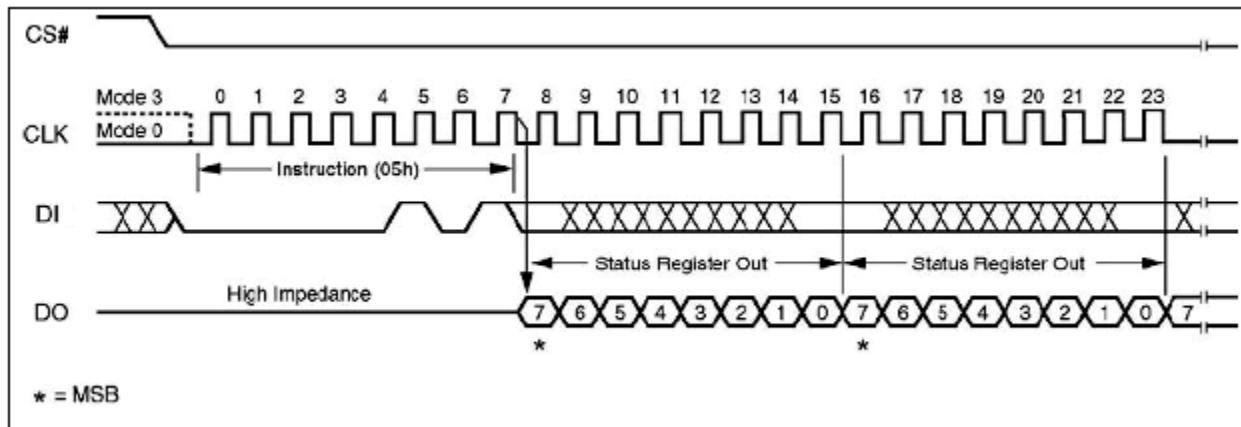


Table 10. Status Register Bit Locations

SR7	SR6	SR5	SR4	SR3	SR2	SR1	SR0
SRP bit (Status Register Protect)	4KBL bit (4KB Boot Lock)	TB bit (Top / Bottom Protect)	BP2 bit (Block Protect)	BP1 bit (Block Protect)	BP0 bit (Block Protect)	WEL bit (Write Enable Latch)	WIP bit (Write In Progress bit)
1 = status register write disable	0 = 64KB-Block (default 0) (note 2)	1 = Bottom 0 = Top (default 0) (note 2)	(note 1)	(note 1)	(note 1)	1 = write enable 0 = not write enable	1 = write operation 0 = not in write operation
Non-volatile / Volatile bit	Non-volatile / Volatile bit	Non-volatile / Volatile bit	Non-volatile / Volatile bit	Non-volatile / Volatile bit	Non-volatile / Volatile bit	indicator bit	indicator bit

Note:

1. See the "Protected Area Sizes Sector Organization" table.

The status and control bits of the Status Register are as follows:

SRP bit. The Status Register Protect (SRP) bit is operated in conjunction with the Write Protect (WP#) signal. The Status Register Write Protect (SRP) bit and Write Protect (WP#) signal allow the device to be put in the Hardware Protected mode (when the Status Register Protect (SRP) bit is set to 1, and Write Protect (WP#) is driven Low). In this mode, the non-volatile bits of the Status Register (SRP, CMP, 4KBL, TB, BP2, BP1, BP0) become read-only bits and the Write Status Register (WRSR) instruction is no longer accepted for execution.

4KBL bit. The 4KB Boot Lock bit (4KBL) is set by WRSR command. It is used to set the protection area size as block (64KB) or sector (4KB).

TB bit. The Top/Bottom Protect Bit (TB) controls if the Block Protect Bits (BP2, BP1, BP0) protect from the Top (TB = 0) or the Bottom (TB = 1) of the array as shown in the Status Register Memory Protection table. It also controls if the Top (TB=0) or the Bottom (TB=1) 64KB-block/sector is protected when Boot Lock feature is enabled. The factory default setting is TB = 0. The TB bit can be set with the Write Status Register instruction.

BP2, BP1, BP0 bits. The Block Protect (BP2, BP1, BP0) bits are non-volatile. They define the size of the area to be software protected against Program and Erase instructions. These bits are written with the Write Status Register (WRSR) instruction. When one or both of the Block Protect (BP2, BP1, BP0) bits is set to 1, the relevant memory area (as defined in Protected Area Sizes Sector Organization table.) becomes protected against Page Program (PP), Quad Input Page Program (QPP), Sector Erase (SE) and , Half Block Erase (HBE), Block Erase (BE), instructions. The Block Protect (BP2, BP1, BP0) bits can be written and provided that the Hardware Protected mode has not been set. The Chip Erase (CE) instruction is executed if and only if all Block Protect (BP2, BP1, BP0) bits are 0.

WEL bit. The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write Status Register, Program or Erase instruction is accepted.

WIP bit. The Write In Progress (WIP) bit indicates whether the memory is busy with a Write Status Register, Program or Erase cycle. When set to 1, such a cycle is in progress, when reset to 0 no such cycle is in progress.

Read Status Register 2 (RDSR 2) (09h/35h)

The Read Status Register 2 (RDSR2) instruction allows the Status Register 2 to be read. The Status Register 2 may be read at any time, even while a Write Suspend or Write Resume cycle is in progress. When one of these bytes is in progress, it is recommended to check the Write In Progress (WIP) bit before sending a new instruction to the device. It is also possible to read the Read Status Register 2 continuously, as shown in Read Status Register 2 Instruction Sequence Diagram figure.

Figure 10. Read Status Register 2 Instruction Sequence Diagram

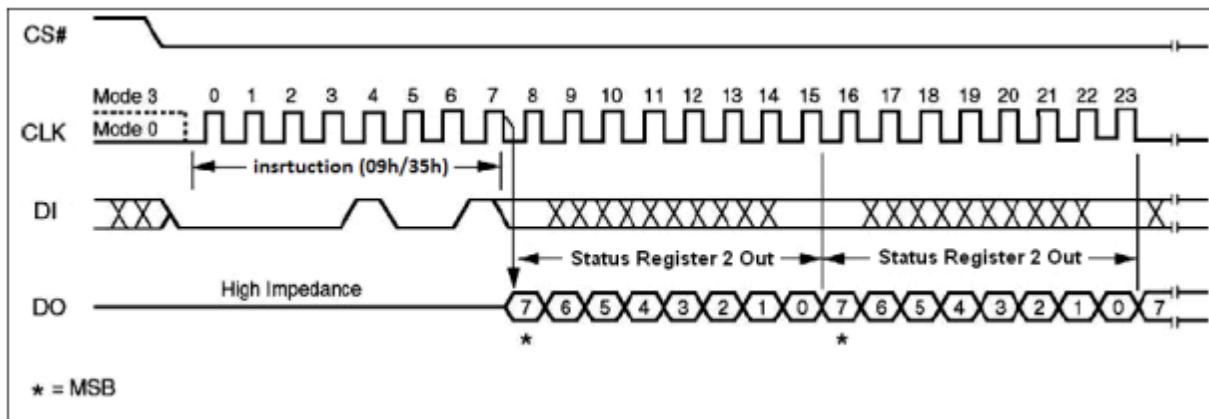


Table 11. Status Register 2 Bit Locations

SR2.7	SR2.6	SR2.5	SR2.4	SR2.3	SR2.2	SR2.1	SR2.0
WSE bit (Write Suspend Erase status bit)	CMP bit	SPL0 bit	SPL1 bit	SPL2 bit	WSP bit (Write Suspend Program bits)	QE bit	
1 = Erase suspended 0 = Erase is not suspended	(note 2)	1 = OTP1 sector is protected	1 = OTP2 sector is protected	1 = OTP3 sector is protected	1 = Program suspended 0 = Program is not suspended	1 = WP# and HOLD#/RESET# disable 0 = WP# and HOLD#/RESET# enable (default 1)	Reserved bit
Indicator bit	Non-volatile / Volatile bit	OTP bit	OTP bit	OTP bit	Indicator bit	Non-volatile / Volatile bit	

Note:

1. The default of each Indicator bit is “0” at Power-up or after reset.
2. See the “Protected Area Sizes Sector Organization” table.

The status and control bits of the Suspend Status Register 2 are as follows:

WSE bit. The Write Suspend Erase Status (WSE) bit indicates when an Erase operation has been suspended. The WSE bit is “1” after the host issues a suspend command during an Erase operation. Once the suspended Erase resumes, the WSE bit is reset to “0”.

CMP bit. The Complement Protect bit (CMP) is a non-volatile bit in Status Register 2. It is used in conjunction with 4KBL, TB, BP2, BP1, BP0 bits to provide mode flexibility for the array protection. The default setting is CMP=0.

SPL0 bit. The SPL0 bit is non-volatile One Time Program (OTP) bit in status register that provide the write protect control and status to the security sector 0. User can read/program/erase security sector 0 as normal sector while SPL0 value is equal 0, after SPL0 is programmed with 1 by WRSR command, the security sector 0 is protected from program and erase operation. The SPL0 bit can only be programmed once.

SPL1 bit. The SPL1 bit is non-volatile One Time Program (OTP) bit in status register that provide the write protect control and status to the security sector 1. User can read/program/erase security sector 1 as normal sector while SPL1 value is equal 0, after SPL1 is programmed with 1 by WRSR command, the security sector 1 is protected from program and erase operation. The SPL1 bit can only be programmed once.

SPL2 bit. The SPL2 bit is non-volatile One Time Program (OTP) bit in status register that provide the write protect control and status to the security sector 2. User can read/program/erase security sector 2 as normal sector while SPL2 value is equal 0, after SPL2 is programmed with 1 by WRSR command, the security sector 2 is protected from program and erase operation. The SPL2 bit can only be programmed once.

WSP bit. The Write Suspend Program Status (WSP) bit indicates when a Program operation has been suspended. The WSP is “1” after the host issues a suspend command during the Program operation. Once the suspended Program resumes, the WSP bit is reset to “0”.

QE bit. The Quad Enable (QE) bit is a non-volatile bit and the default value is “1” to support Quad Input/Output Fast Read (EBh) directly without additional setting. However, WP# and HOLD#/RESET# can be enabled by setting QE=“0”.

Reserved bit. Status Register 2 bit locations SR2.0 is reserved for future use. Current devices will read 0 for these bit locations. It is recommended to mask out the reserved bit when testing the Suspend Status Register. Doing this will ensure compatibility with future devices.

Read Status Register 3 (RDSR 3) (95h/15h)

The Read Status Register 3 (RDSR3) instruction allows the Status Register 3 to be read. The Status Register 3 may be read at any time when one of these bytes is in progress, it is recommended to check the Write In Progress (WIP) bit before sending a new instruction to the device. It is also possible to read the Read Status Register 3 continuously, as shown in Read Status Register 3 Instruction Sequence Diagram figure.

Figure 11. Read Status Register 3 Instruction Sequence Diagram

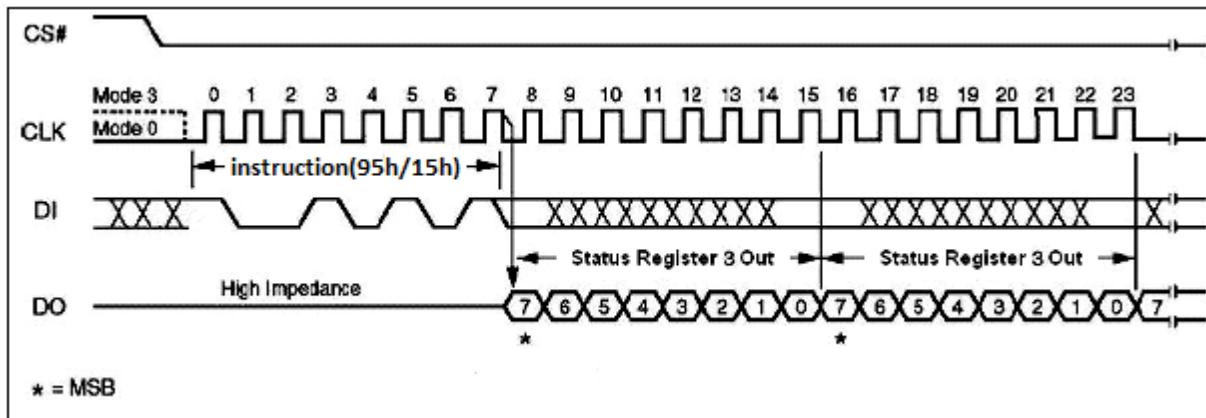


Table 12. Status Register 3 Bit Locations

SR3.7	SR3.6	SR3.5	SR3.4	SR3.3	SR3.2	SR3.1	SR3.0
HRSW bit (HOLD#/RESET# switch)	Output Drive Strength bit		Burst Length bit	Blank check bit	Reserved bit		
1 = RESET# enable 0 = HOLD# enable (default 0)	00 = 67% (default) 01 = 100% 10 = 50% (1/2) drive 11 = 33% (1/3) drive	00 = 8 Bytes(default) 01 = 16 Bytes 10 = 32 Bytes 11 = 64 Bytes	1 = flash is blank after ship out (default) 0 = flash had been programmed	Indicator bit			
Non-volatile/volatile bit	Non-volatile / volatile bit	Non-volatile / volatile bit					

The status and control bits of the Status Register 3 are as follows:

HRSW bit. The HOLD#/RESET# switch bit (HRSW bit), Non-Volatile / Volatile bit, the HRSW bit is used to determine whether HOLD# or RESET# function should be implemented on the hardware pin. When it is “0” (factory default), the pin acts as HOLD#; when it is “1”, the pin acts as RESET#. However, HOLD# or RESET# functions are only available when QE bit is “0”. If QE bit is set to “1”, the HOLD# and RESET# functions are disabled, the pin acts as a dedicated data I/O pin.

Output Driving Strength bit. The Output Driving Strength bits indicate the status of output Drive Strength in I/O pins.

Burst Length bit. The Burst Length bits indicate the status of wrap burst read length.

Blank check bit. This bit is related with whole chip blank as factory default. Once any byte is programmed, this bit turns to 0 and will not be restored by further erase operation.

Reserved bit. SR3.1 and SR3.0 are reserved for future use.

Write Status Register (WRSR) (01h)

The Write Status Register (WRSR) instruction allows new values to be written to the Status Register. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded and executed, the device sets the Write Enable Latch (WEL).

The Write Status Register (WRSR) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code and the data byte or data bytes on Serial Data Input (DI). The WRSR instruction also support multi bytes data input to set other status registers.

The instruction sequence is shown in Write Status Register Instruction Sequence Diagram figure. The Write Status Register (WRSR) instruction has no effect on SR1 and SR0 of the Status Register. Chip Select (CS#) must be driven High after the eighth or 16th or 32th bit of the data byte has been latched in. If not, the Write Status Register (WRSR) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Write Status Register cycle (whose duration is t_W) is initiated. While the Write Status Register cycle is in progress, the Status Register may still be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Status Register cycle, and is 0 when it is completed. When the cycle is completed, the Write Enable Latch (WEL) is reset.

The Write Status Register (WRSR) instruction allows the user to change the values of the Block Protect (4KBL, TB, BP2, BP1, BP0) bits, to define the size of the area that is to be treated as read-only, as defined in Protected Area Sizes Sector Organization table. The Write Status Register (WRSR) instruction also allows the user to set or reset the Status Register Protect (SRP) bit in accordance with the Write Protect (WP#) signal. The Status Register Protect (SRP) bit and Write Protect (WP#) signal allow the device to be put in the Hardware Protected Mode (HPM). The Write Status Register (WRSR) instruction is not executed once the Hardware Protected Mode (HPM) is entered.

Figure 12. Write Status Register Instruction Sequence Diagram

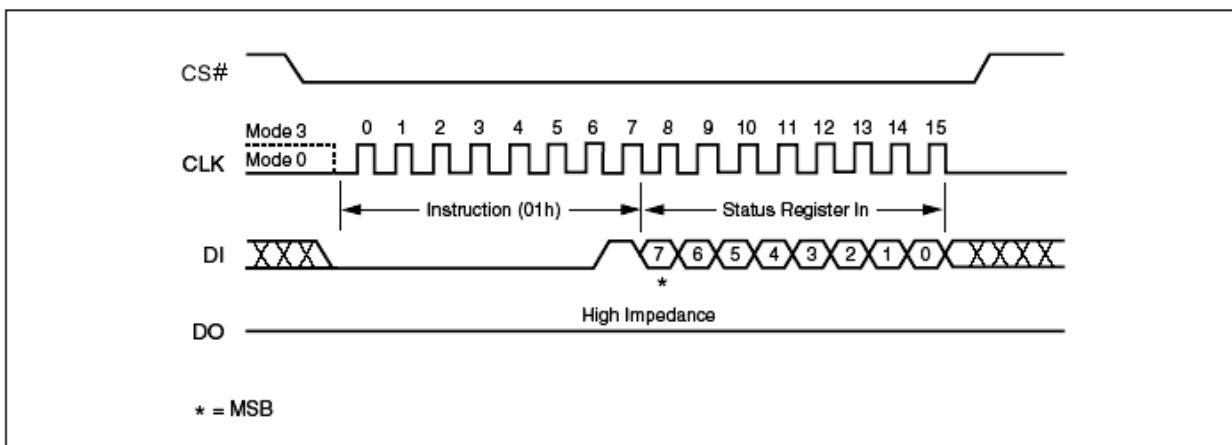
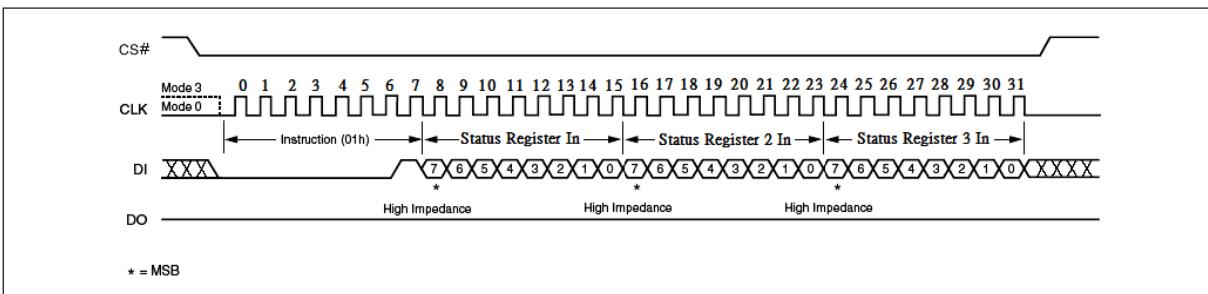


Figure 13. Write Status Register Instruction Sequence Diagram (multi byte)



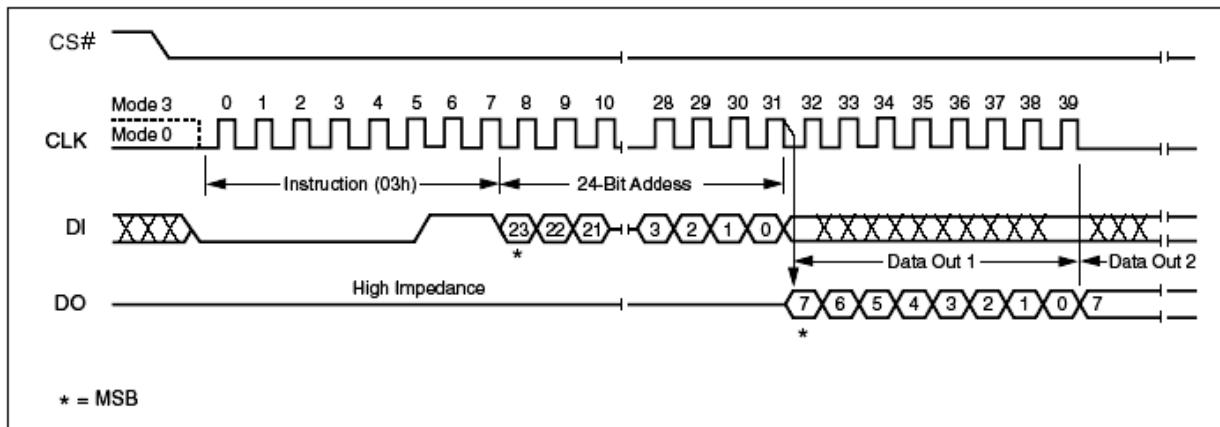
Read Data Bytes (READ) (03h)

The device is first selected by driving Chip Select (CS#) Low. The instruction code for the Read Data Bytes (READ) instruction is followed by a 3-byte address (A23-A0), each bit being latched-in during the rising edge of Serial Clock (CLK). Then the memory contents, at that address, is shifted out on Serial Data Output (DO), each bit being shifted out, at a maximum frequency f_R , during the falling edge of Serial Clock (CLK).

The instruction sequence is shown in Read Data Instruction Sequence Diagram figure. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes (READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The Read Data Bytes (READ) instruction is terminated by driving Chip Select (CS#) High. Chip Select (CS#) can be driven High at any time during data output. Any Read Data Bytes (READ) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

Figure 14. Read Data Instruction Sequence Diagram



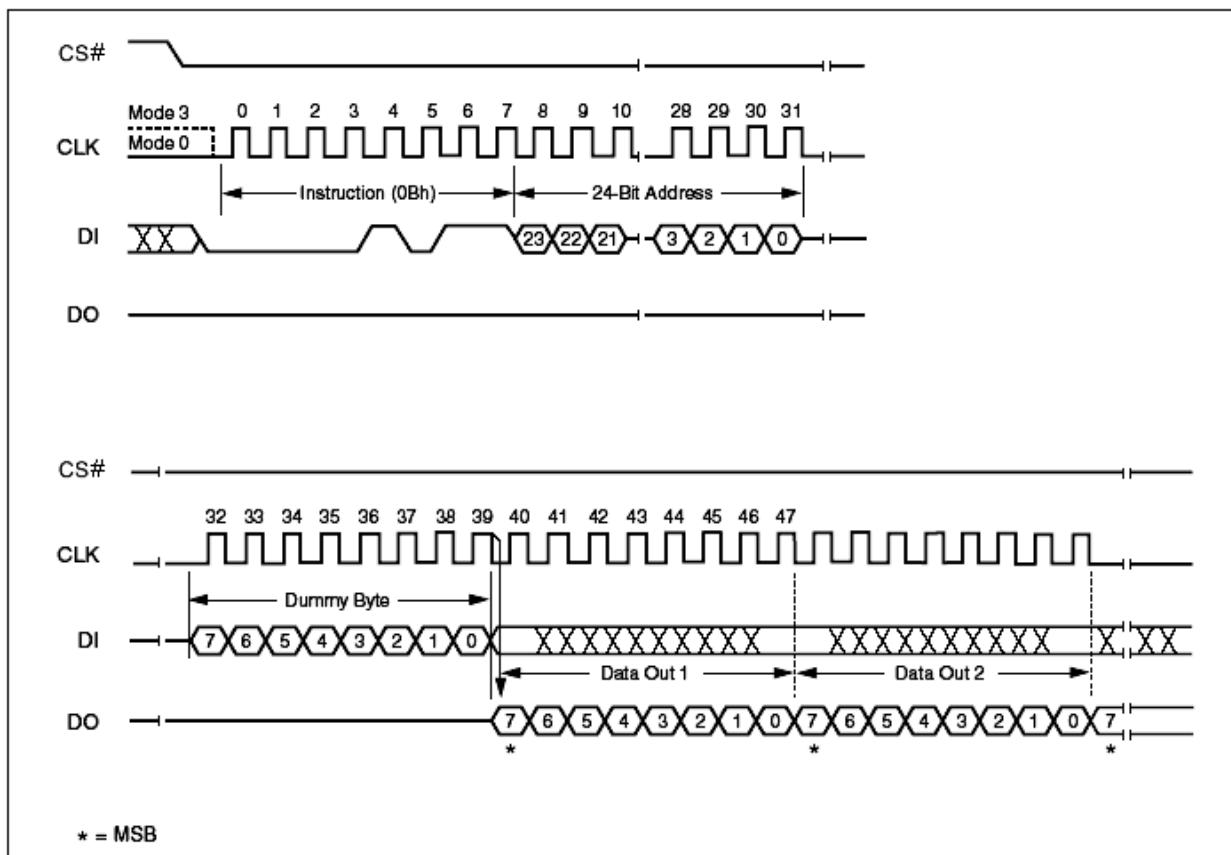
Read Data Bytes at Higher Speed (FAST_READ) (0Bh)

The device is first selected by driving Chip Select (CS#) Low. The instruction code for the Read Data Bytes at Higher Speed (FAST_READ) instruction is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of Serial Clock (CLK). Then the memory contents, at that address, is shifted out on Serial Data Output (DO), each bit being shifted out, at a maximum frequency F_R , during the falling edge of Serial Clock (CLK).

The instruction sequence is shown in Fast Read Instruction Sequence Diagram figure. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes at Higher Speed (FAST_READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The Read Data Bytes at Higher Speed (FAST_READ) instruction is terminated by driving Chip Select (CS#) High. Chip Select (CS#) can be driven High at any time during data output. Any Read Data Bytes at Higher Speed (FAST_READ) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

Figure 15. Fast Read Instruction Sequence Diagram

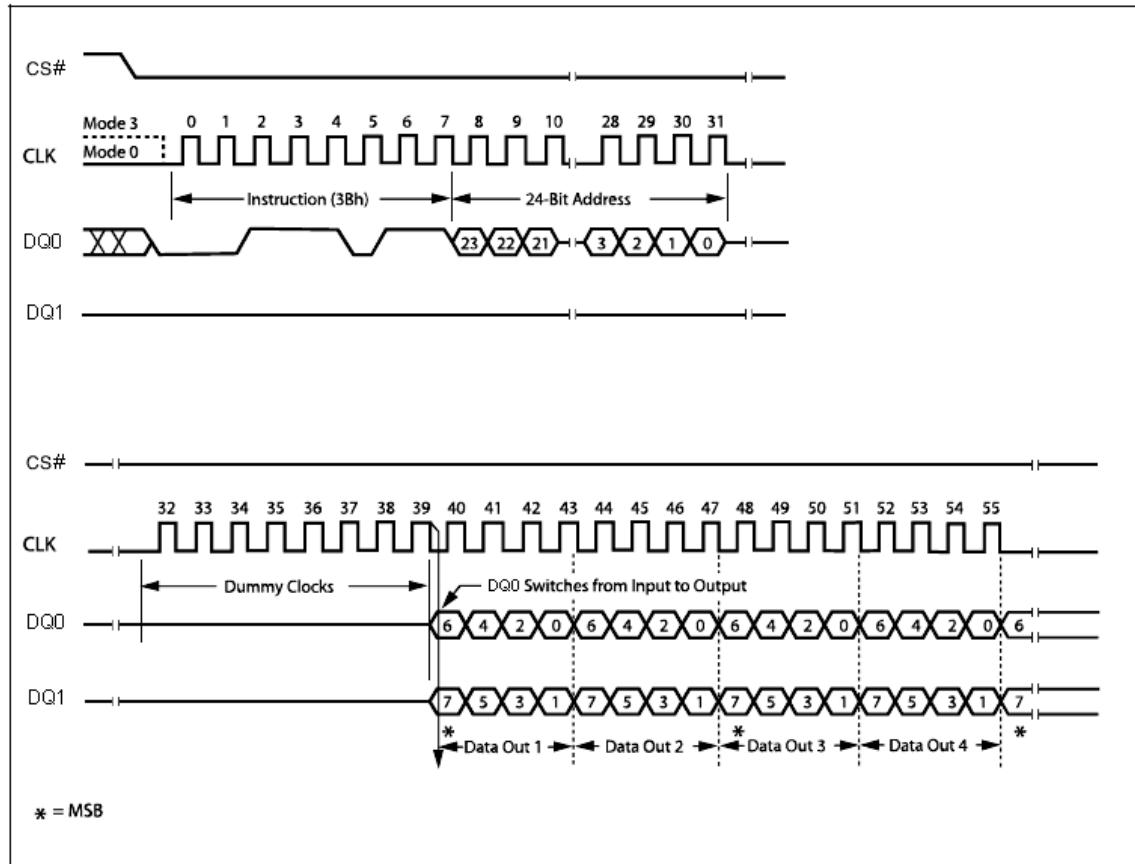


Dual Output Fast Read (3Bh)

The Dual Output Fast Read (3Bh) is similar to the standard Fast Read (0Bh) instruction except that data is output on two pins, DQ₀ and DQ₁, instead of just DQ₀. This allows data to be transferred from the device at twice the rate of standard SPI devices. The Dual Output Fast Read instruction is ideal for quickly downloading code from to RAM upon power-up or for applications that cache code-segments to RAM for execution.

Similar to the Fast Read instruction, the Dual Output Fast Read instructions can operate at the highest possible frequency of F_R (see AC Electrical Characteristics). This is accomplished by adding eight “dummy clocks” after the 24-bit address as shown in Dual Output Fast Read Instruction Sequence Diagram figure. The dummy clocks allow the device’s internal circuits additional time for setting up the initial address. The input data during the dummy clock is “don’t care”. However, the DI pin should be high-impedance prior to the falling edge of the first data out clock.

Figure 16. Dual Output Fast Read Instruction Sequence Diagram

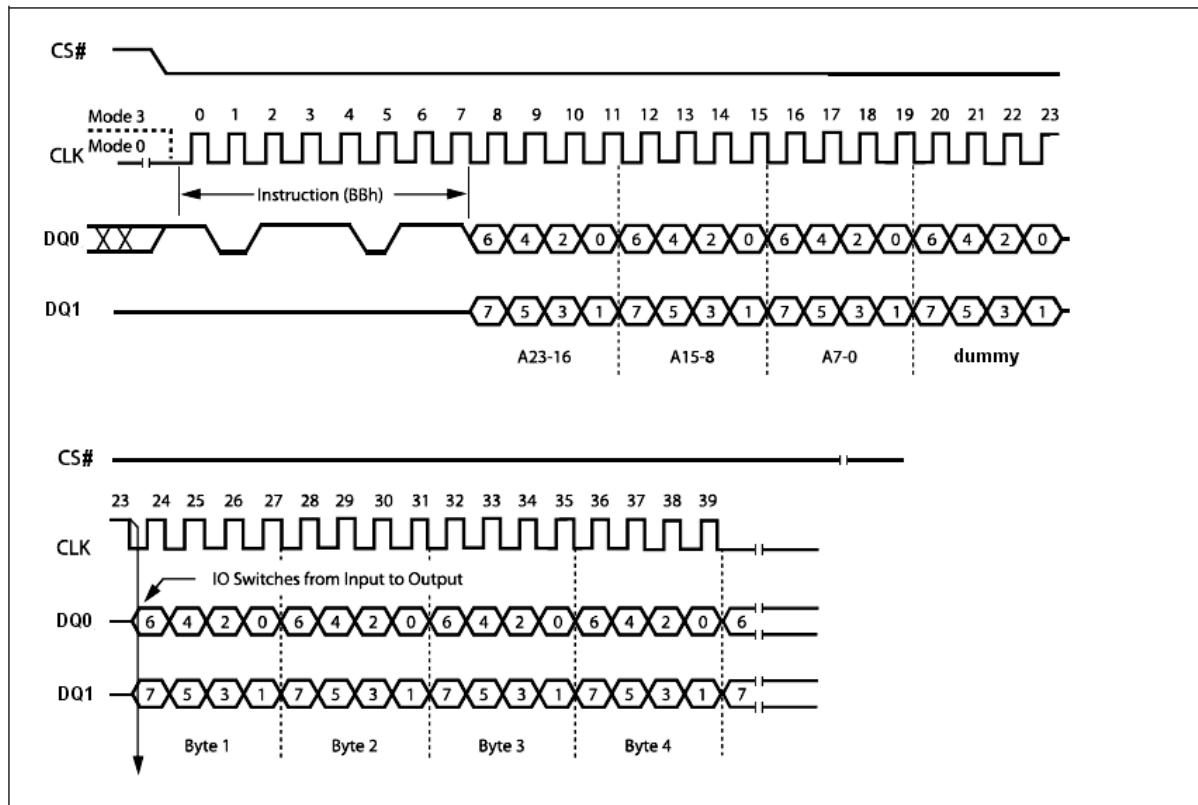


Dual Input / Output FAST_READ (BBh)

The Dual I/O Fast Read (BBh) instruction allows for improved random access while maintaining two IO pins, DQ₀ and DQ₁. It is similar to the Dual Output Fast Read (3Bh) instruction but with the capability to input the Address bits (A23-0) two bits per clock.

The Dual I/O Fast Read instruction enable double throughput of Serial Flash in read mode. The address is latched on rising edge of CLK, and data of every two bits (interleave 2 I/O pins) shift out on the falling edge of CLK at a maximum frequency. The first address can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single Dual I/O Fast Read instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing Dual I/O Fast Read instruction, the following address/dummy/data out will perform as 2-bit instead of previous 1-bit, as shown in Dual Input / Output Fast Read Instruction Sequence Diagram figure.

Figure 17. Dual Input / Output Fast Read Instruction Sequence Diagram



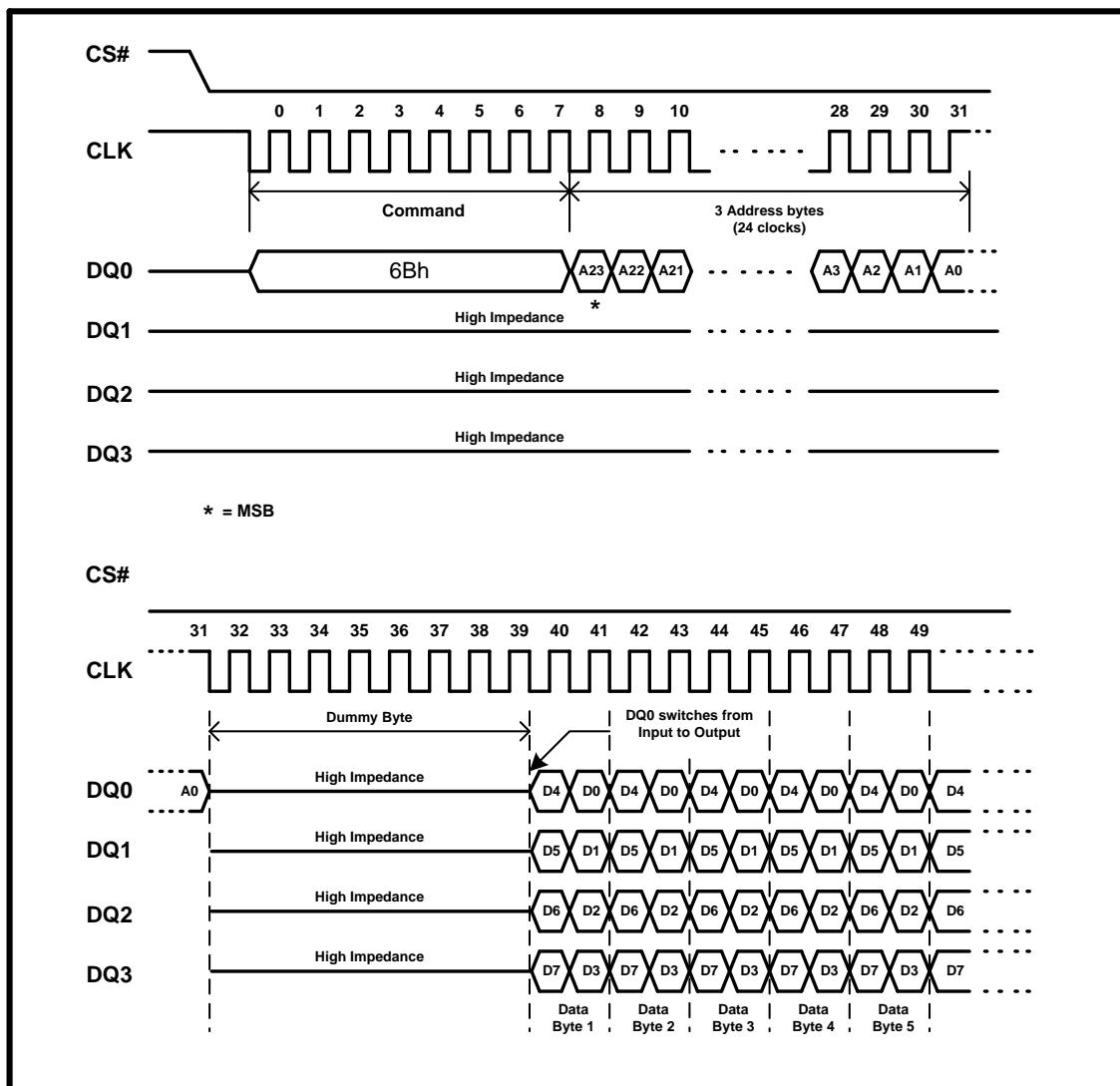
Quad Output Fast Read (6Bh)

The Quad Output Fast Read (6Bh) instruction is similar to the Dual Output Fast Read (3Bh) instruction except that data is output through four pins, DQ₀, DQ₁, DQ₂ and DQ₃ and eight dummy clocks are required prior to the data output.

The Quad Output Fast Read (6Bh) address is latching on rising edge of CLK, and data of every four bits (interleave on 4 I/O pins) shift out on the falling edge of CLK at a maximum frequency F_R . The first address can be any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single Quad Output Fast Read instruction. The address counter rolls over to 0 when the highest address has been reached.

The sequence of issuing Quad Output Fast Read (6Bh) instruction is: CS# goes low -> sending Quad Output Fast Read (6Bh) instruction -> 24-bit address on DQ₀ -> 8 dummy clocks -> data out interleave on DQ₃, DQ₂, DQ₁ and DQ₀ -> to end Quad Output Fast Read (6Bh) operation can use CS# to high at any time during data out, as shown in Quad Output Fast Read Instruction Sequence Diagram figure. The WP# (DQ2) and HOLD#/RESET# (DQ3) need to drive high before address input if QE bit in Status Register is 0.

Figure 18. Quad Output Fast Read Instruction Sequence Diagram



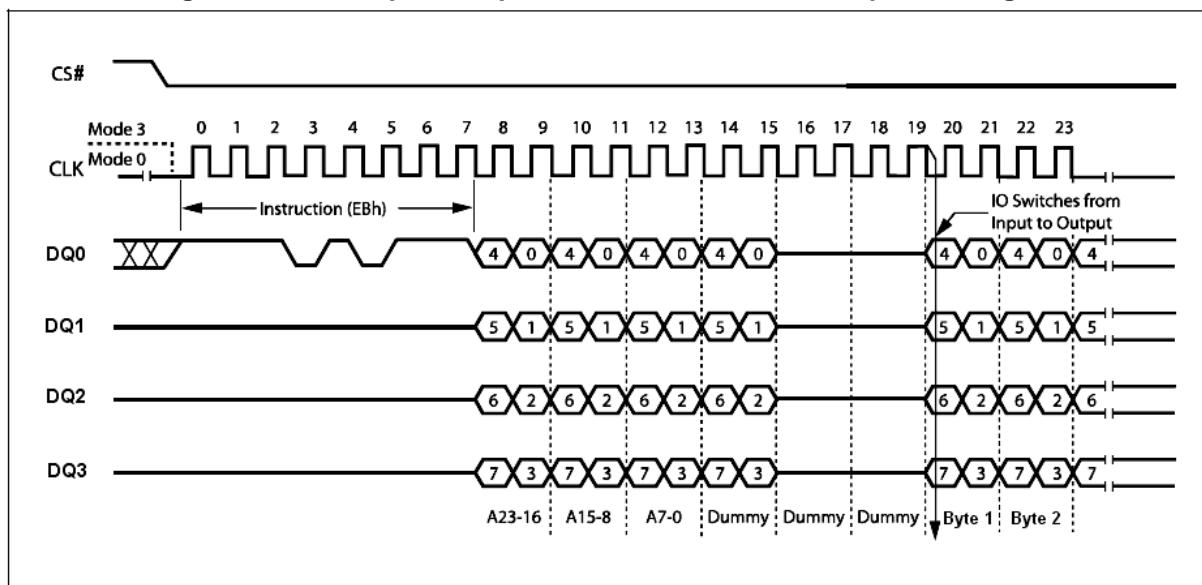
Quad Input / Output FAST_READ (EBh)

The Quad Input/ Output FAST_READ (EBh) instruction is similar to the Dual I/O Fast Read (BBh) instruction except that address and data bits are input and output through four pins, DQ₀, DQ₁, DQ₂ and DQ₃ and six dummy clocks are required prior to the data output.

The Quad Input/ Output FAST_READ (EBh) instruction enable quad throughput of Serial Flash in read mode. The address is latching on rising edge of CLK, and data of every four bits (interleave on 4 I/O pins) shift out on the falling edge of CLK at a maximum frequency F_R . The first address can be any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single Quad Input/ Output FAST_READ instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing Quad Input/ Output FAST_READ instruction, the following address/dummy/data out will perform as 4-bit instead of previous 1-bit.

The sequence of issuing Quad Input/ Output FAST_READ (EBh) instruction is: CS# goes low -> sending Quad Input/ Output FAST_READ (EBh) instruction -> 24-bit address interleave on DQ₃, DQ₂, DQ₁ and DQ₀ -> 6 dummy clocks -> data out interleave on DQ₃, DQ₂, DQ₁ and DQ₀ -> to end Quad Input/ Output FAST_READ (EBh) operation can use CS# to high at any time during data out, as shown in Quad Input / Output Fast Read Instruction Sequence Diagram figure.

Figure 19. Quad Input / Output Fast Read Instruction Sequence Diagram



Read Burst (0Ch)

This device supports Read Burst with wrap in both SPI mode. To execute a Read Burst with wrap operation the host drivers CS# low, and sends the Read Burst with wrap (0Ch) command cycle, followed by three address bytes and one dummy byte (8 clocks) in SPI mode (Read Burst Instruction Sequence Diagram figure).

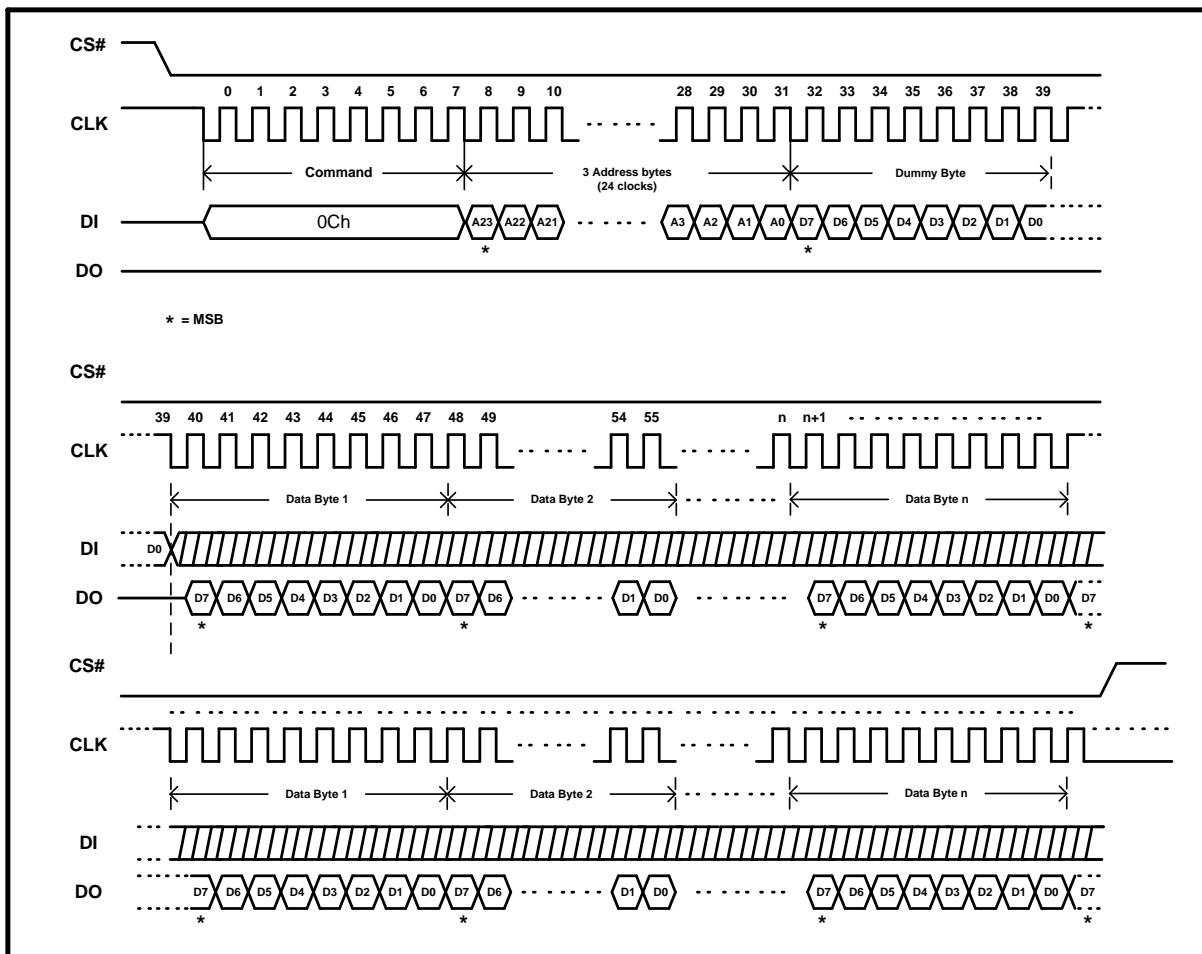
After the dummy byte, the device outputs data on the falling edge of the CLK signal starting from the specific address location. The data output stream is continuous through all addresses until terminated by a low-to high transition of CS# signal.

During Read Burst, the internal address point automatically increments until the last byte of the burst reached, then jumps to first byte of the burst. All bursts are aligned to addresses within the burst length, see Burst Address Range table. For example, if the burst length is 8 bytes, and the start address is 06h, the burst sequence should be: 06h, 07h, 00h, 01h, 02h, 03h, 04h, 05, 06, etc. The pattern would repeat until the command was terminated by pulling CS# as high status.

Table 13. Burst Address Range

Burst length	Burst wrap (A[7:A0]) address range
8 Bytes (default)	00-07H, 08-0FH, 10-17H, 18-1FH...
16 Bytes	00-0FH, 10-1FH, 20-2FH, 30-3FH...
32 Bytes	00-1FH, 20-3FH, 40-5FH, 60-7FH...
64 Bytes	00-3FH, 40-7FH, 80-BFH, C0-FFH

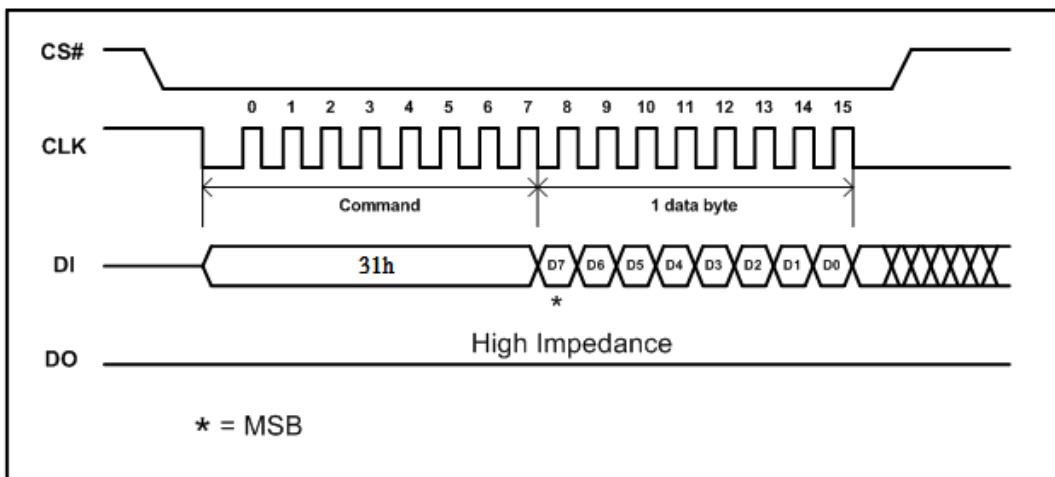
Figure 20. Read Burst Instruction Sequence Diagram



Write Status Register 2 (31h/01h)

The Write Status Register 2 (31h) command can be used to set SPL0/SPL1/SPL2 OTP bits, QE bit and CMP bit. To set these bits to the host driver CS# low, sends the Write Status Register 2 (31h) and one data byte, then drivers CS# high most significant nibble first. 01h (WRSR) command also can set status register 2.

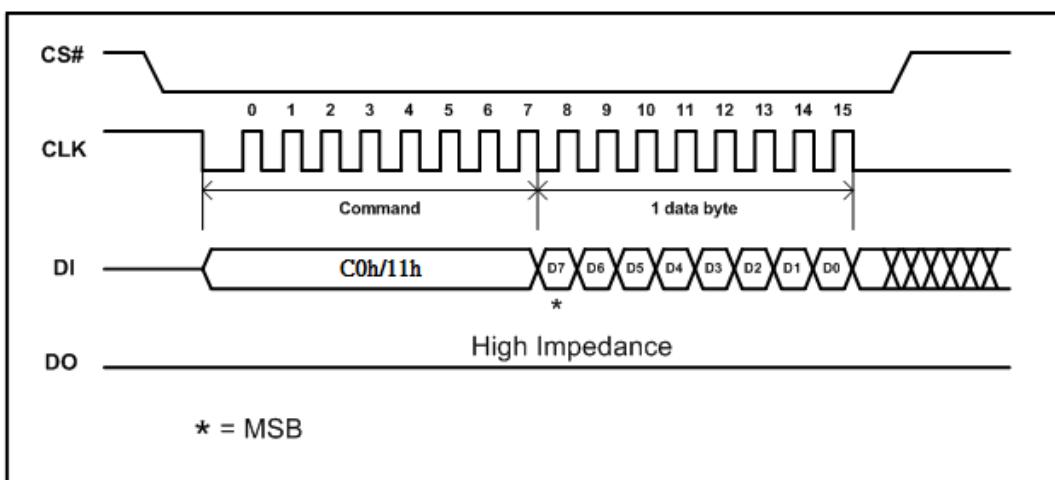
Figure 21. Write Status Register 2 Instruction Sequence Diagram



Write Status Register 3 (C0h/11h/01h)

The Write Status Register 3 (C0h/11h) command can be used to set output drive strength in I/O pins, HOLD/RESET# selection and burst read length setting. To set these bits to the host driver CS# low, sends the Write Status Register 3 (C0h or 11h) and one data byte, then drivers CS# high most significant nibble first. 01h (WRSR) command also can set status register 3.

Figure 22. Write Status Register 3 Instruction Sequence Diagram



Page Program (PP) (02h)

The Page Program (PP) instruction allows bytes to be programmed in the memory. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Page Program (PP) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, three address bytes and at least one data byte on Serial Data Input (DI). If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data that goes beyond the end of the current page are programmed from the start address of the same page (from the address whose 8 least significant bits (A7-A0) are all zero). Chip Select (CS#) must be driven Low for the entire duration of the sequence.

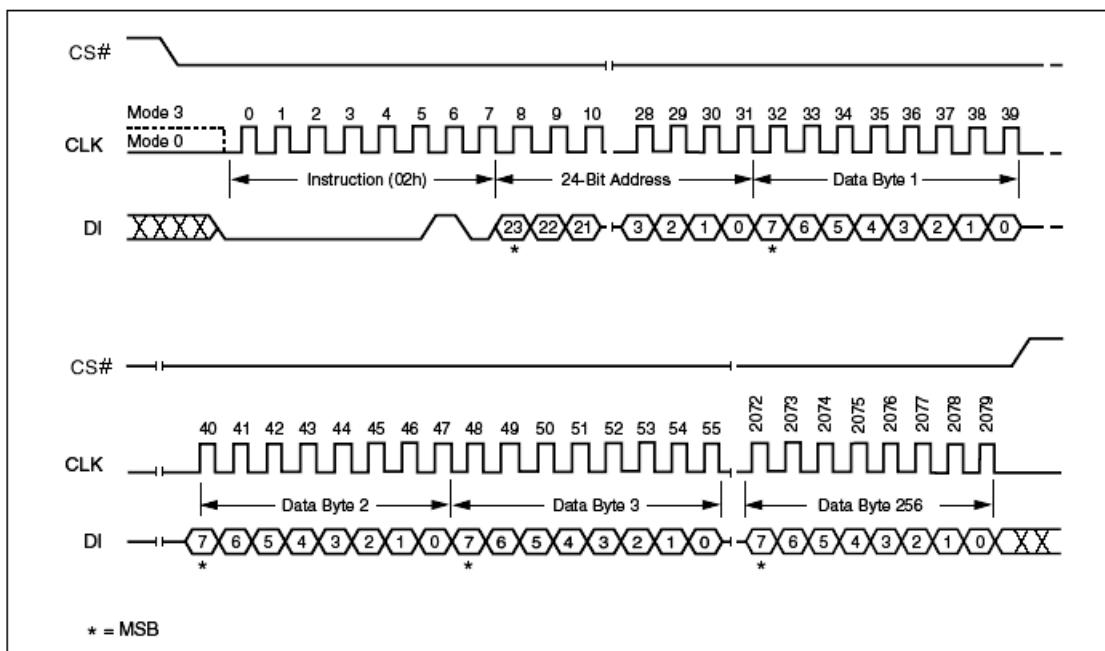
The instruction sequence is shown in Page Program Instruction Sequence Diagram figure. If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be programmed correctly within the same page. If less than 256 Data bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other bytes of the same page.

Chip Select (CS#) must be driven High after the eighth bit of the last data byte has been latched in, otherwise the Page Program (PP) instruction is not executed.

As soon as Chip Select (CS#) is driven high, the self-timed Page Program cycle (whose duration is t_{PP}) is initiated. While the Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Page Program (PP) instruction applied to a page which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Protected Area Sizes Sector Organization table) is not executed.

Figure 23. Page Program Instruction Sequence Diagram

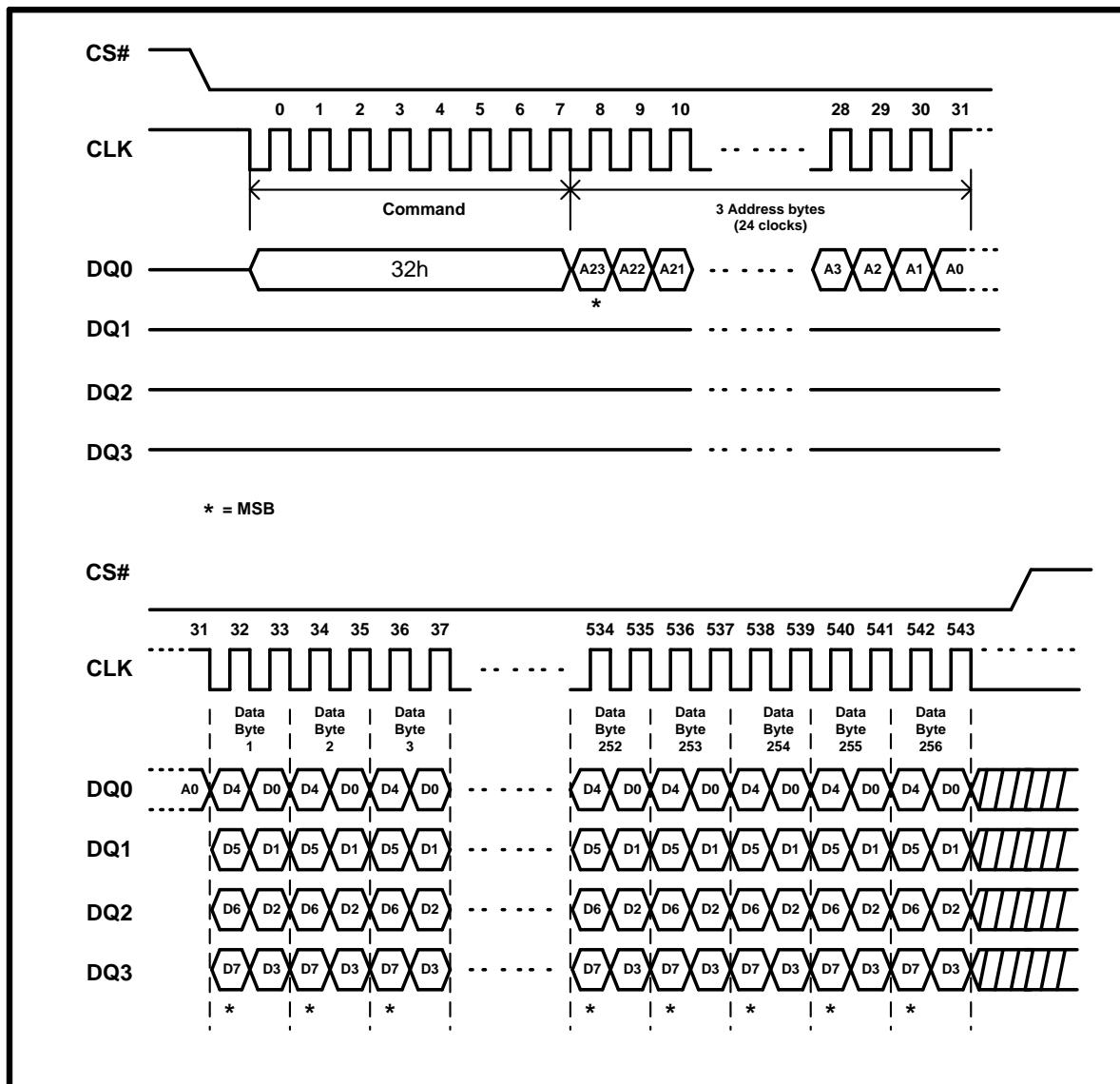


Quad Input Page Program (QPP) (32h)

The Quad Page Program (QPP) instruction allows up to 256 bytes of data to be programmed at previously erased (FFh) memory locations using four pins: DQ₀, DQ₁, DQ₂ and DQ₃. The Quad Page Program can improve performance for PROM Programmer and applications that have slow clock speeds < 5 MHz. Systems with faster clock speed will not realize much benefit for the Quad Page Program instruction since the inherent page program time is much greater than the time it take to clock-in the data.

To use Quad Page Program (QPP) the WP# and HOLD#/RESET# Disable (QE) bit in Status Register must be set to 1. A Write Enable instruction must be executed before the device will accept the Quad Page Program (QPP) instruction (SR.1, WEL=1). The instruction is initiated by driving the CS# pin low then shifting the instruction code "32h" followed by a 24-bit address (A23-A0) and at least one data byte, into the IO pins. The CS# pin must be held low for the entire length of the instruction while data is being sent to the device. All other functions of Quad Page Program (QPP) are identical to standard Page Program. The Quad Page Program (QPP) instruction sequence is shown in Quad Input Page Program Instruction Sequence Diagram (SPI Mode only) figure.

Figure 24. Quad Input Page Program Instruction Sequence Diagram (SPI Mode only)



Write Suspend (B0h/75h)

Write Suspend allows the interruption of Sector Erase, Block Erase or Page Program operations in order to erase, program, or read data in another portion of memory. The original operation can be continued with Write Resume command. The instruction sequence is shown in Write Suspend Instruction Sequence Diagram figure.

Only one write operation can be suspended at a time; if an operation is already suspended, the device will ignore the Write Suspend command. Write Suspend during Chip Erase is ignored; Chip Erase is not a valid command while a write is suspended.

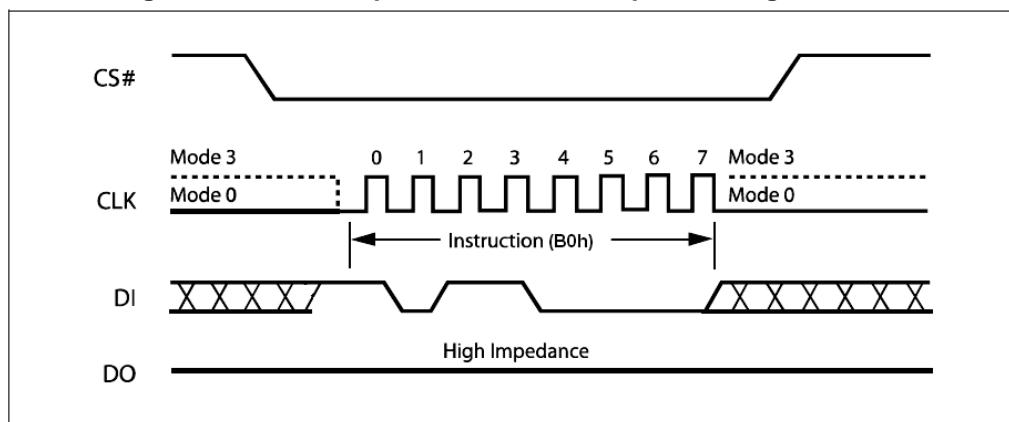
Suspend to suspend ready timing: 28 us.

Resume to another suspend timing: min 0.3us. typ. 200 us.

Note:

User can use resume to another suspend minimum timing for issue next suspend after resume, but the device needs equal or longer typical time to make other progress after resume command.

Figure 25. Write Suspend Instruction Sequence Diagram



Write Suspend During Sector Erase or Block Erase

Issuing a Write Suspend instruction during Sector Erase or Block Erase allows the host to program or read any block that was not being erased. The device will ignore any programming commands pointing to the suspended sector(s). Any attempt to read from the suspended sector(s) will output unknown data because the Sector or Block Erase will be incomplete.

To execute a Write Suspend operation, the host drives CS# low, sends the Write Suspend command cycle (B0h), then drives CS# high. A cycle is two nibbles long, most significant nibble first. The Suspend Status register indicates that the erase has been suspended by changing the WSE bit from "0" to "1", but the device will not accept another command until it is ready. To determine when the device will accept a new command, poll the WIP bit in the Suspend Status register or after issue program suspend command, latency time 28 us is needed before issue another command. For "Suspend to Read", "Resume to Read", "Resume to Suspend" timing specification please note Suspend to Read Latency, Resume to Read Latency and Resume to Suspend Latency figure.

Write Suspend During Page Programming

Issuing a Write Suspend instruction during Page Programming allows the host to erase any sector or read any page that is not being programmed. Erase commands pointing to the suspended sector(s) will be ignored. Any attempt to read from the suspended page will output unknown data because the program will be incomplete.

To execute a Write Suspend operation, the host drives CS# low, sends the Write Suspend command cycle (B0h), then drives CS# high. A cycle is two nibbles long, most significant nibble first. The Suspend Status register indicates that the programming has been suspended by changing the WSP bit from "0" to "1", but the device will not accept another command until it is ready. To determine when the device will accept a new command, poll the WIP bit in the Suspend Status register or after issue program suspend command, latency time 28 us is needed before issue another command. For "Suspend to Read", "Resume to Read", "Resume to Suspend" timing specification please note Suspend to Read Latency, Resume to Read Latency and Resume to Suspend Latency figure.

Figure 26. Suspend to Read Latency

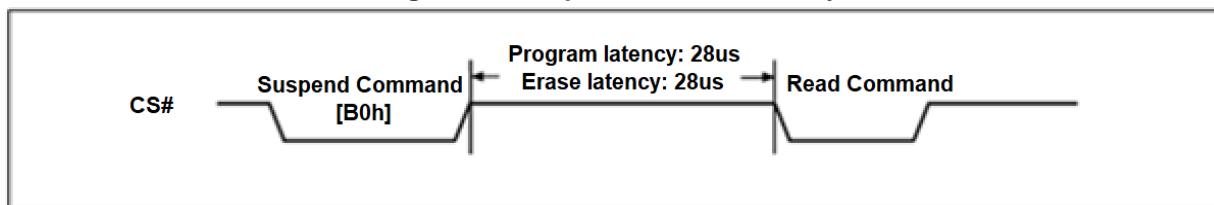
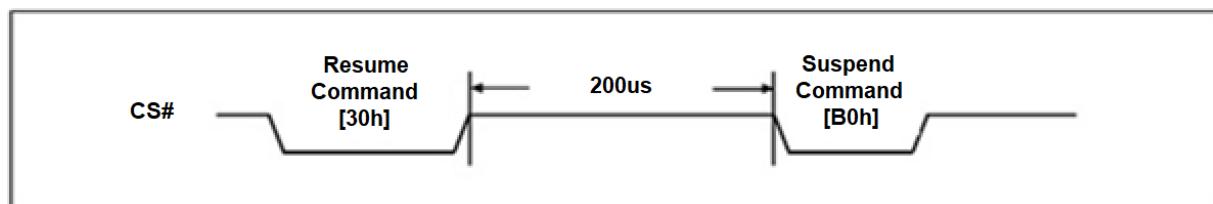


Figure 27. Resume to Read Latency



Figure 28. Resume to Suspend Latency



Write Resume (30h/7Ah)

Write Resume restarts a Write command that was suspended, and changes the suspend status bit in the Status register 2 (WSE or WSP) back to "0".

The instruction sequence is shown in Write Resume Instruction Sequence Diagram figure. To execute a Write Resume operation, the host drives CS# low, sends the Write Resume command cycle (30h), then drives CS# high. A cycle is two nibbles long, most significant nibble first. To determine if the internal, self-timed Write operation completed, poll the WIP bit in the Suspend Status register, or wait the specified time t_{SE} , t_{HBE} , t_{BE} or t_{PP} for Sector Erase, Block Erase, or Page Programming, respectively. The total write time before suspend and after resume will not exceed the uninterrupted write times t_{SE} , t_{HBE} , t_{BE} or t_{PP} . Resume to another suspend operation requires latency time of 200 us.

Figure 29. Write Resume Instruction Sequence Diagram

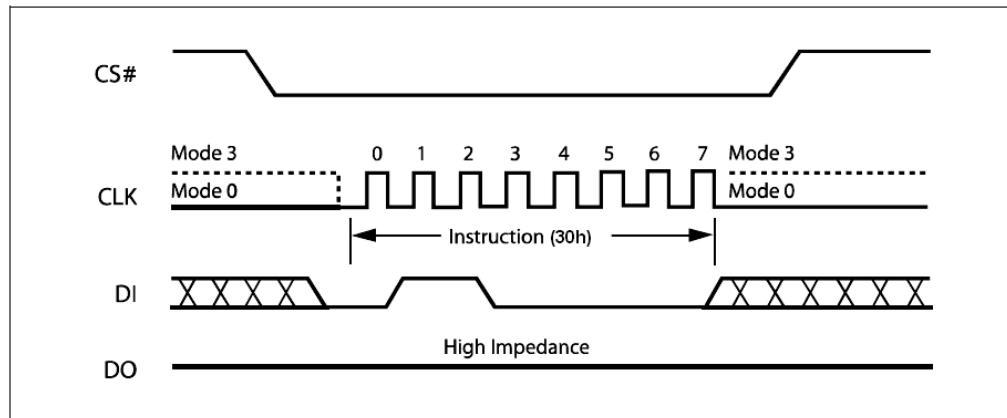
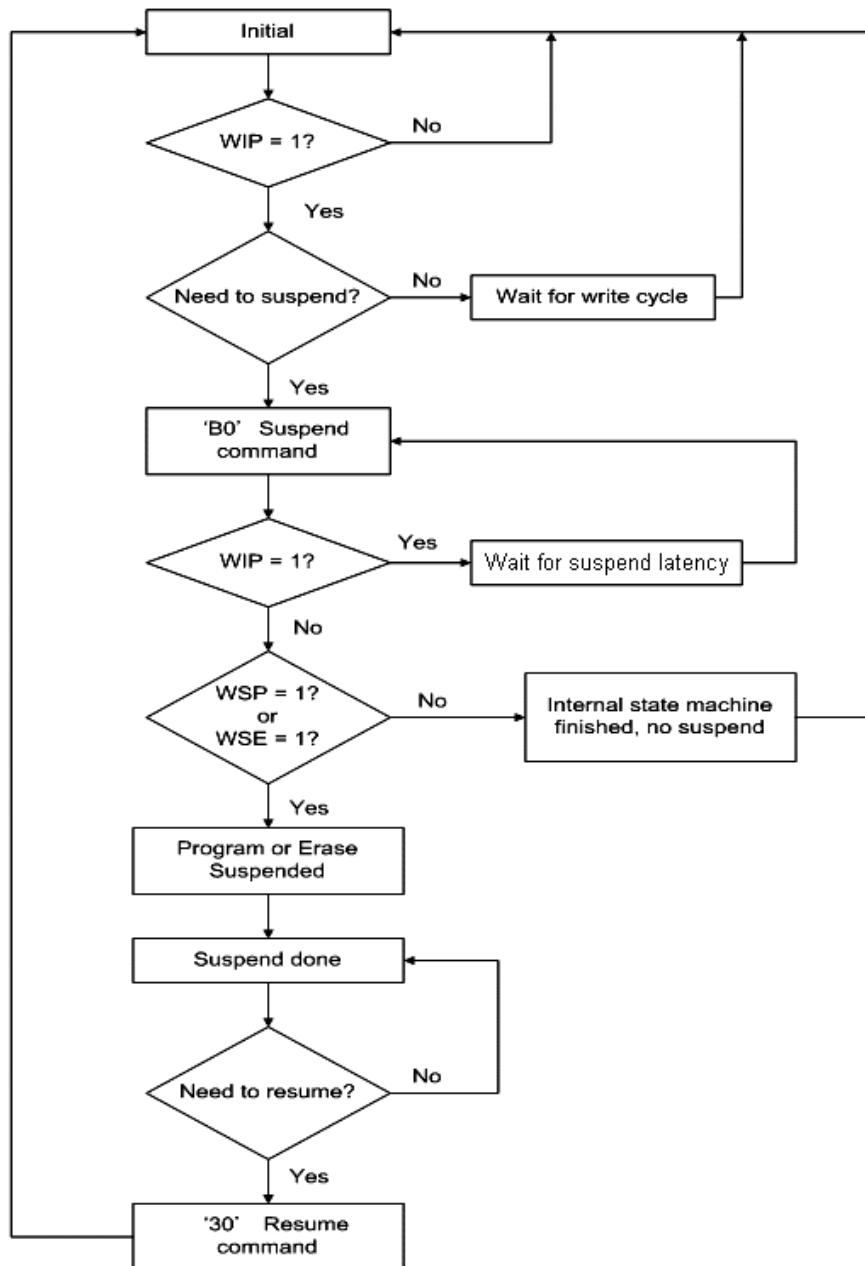


Figure 30. Write Suspend / Resume Flow



Note:

1. The 'WIP' can be either checked by command '09' or '05' polling.
2. 'Wait for write cycle' can be referring to maximum write cycle time or polling the WIP.
3. 'Wait for suspend latency', after issue program suspend command, latency time 28 us is needed before issue another command or polling the WIP.
4. The 'WSP' and 'WSE' can be checked by command '09' polling.
5. 'Suspend done' means the chip can do further operations allowed by suspend spec.

Sector Erase (SE) (20h)

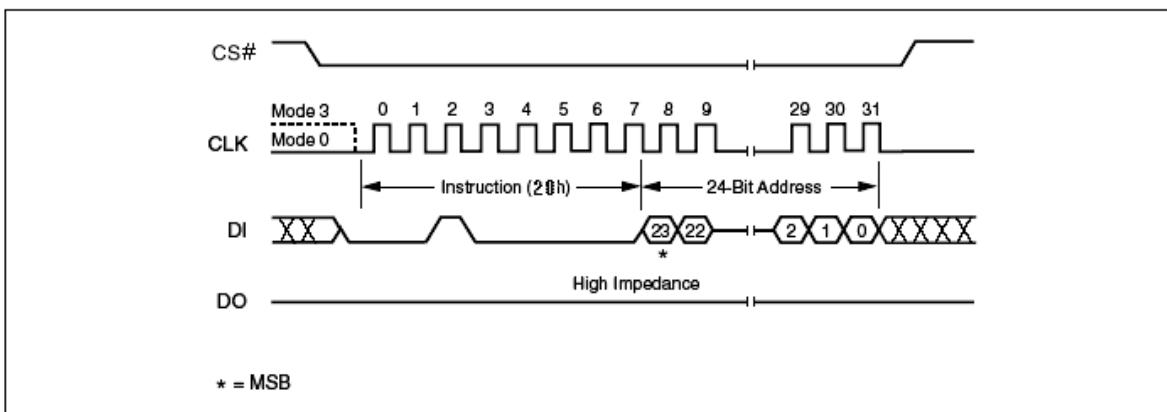
The Sector Erase (SE) instruction sets to 1 (FFh) all bits inside the chosen sector. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Sector Erase (SE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, and three address bytes on Serial Data Input (DI). Any address inside the Sector (see Uniform Block Sector Architecture table) is a valid address for the Sector Erase (SE) instruction. Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Sector Erase Instruction Sequence Diagram figure. Chip Select (CS#) must be driven High after the eighth bit of the last address byte has been latched in, otherwise the Sector Erase (SE) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Sector Erase cycle (whose duration is t_{SE}) is initiated. While the Sector Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Sector Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Sector Erase (SE) instruction applied to a sector which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Protected Area Sizes Sector Organization table) or Boot Lock feature will be ignored.

Figure 31. Sector Erase Instruction Sequence Diagram



32KB Half Block Erase (HBE) (52h)

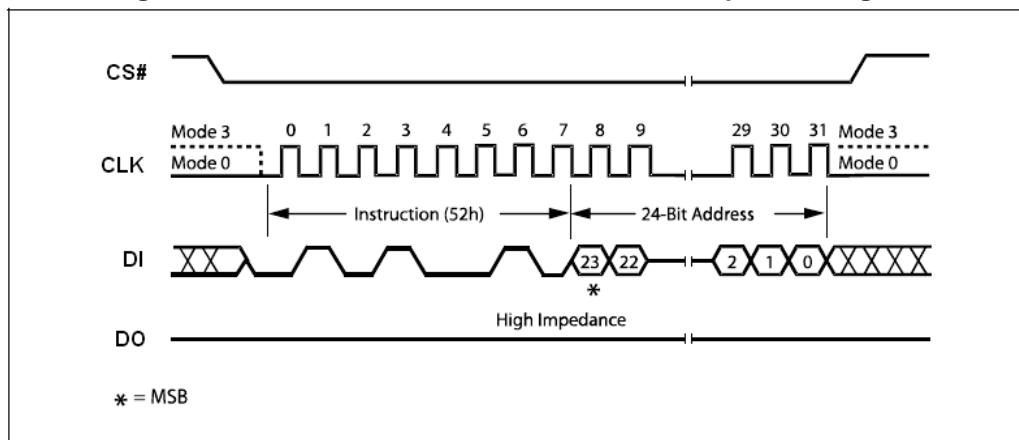
The Half Block Erase (HBE) instruction sets to 1 (FFh) all bits inside the chosen block. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Half Block Erase (HBE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, and three address bytes on Serial Data Input (DI). Any address inside the Block (see Uniform Block Sector Architecture table) is a valid address for the Half Block Erase (HBE) instruction. Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in 32KB Half Block Erase Instruction Sequence Diagram figure. Chip Select (CS#) must be driven High after the eighth bit of the last address byte has been latched in, otherwise the Half Block Erase (HBE) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Block Erase cycle (whose duration is t_{HBE}) is initiated. While the Half Block Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Half Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Half Block Erase (HBE) instruction applied to a block which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Protected Area Sizes Sector Organization table) or Boot Lock feature will be ignored.

Figure 32. 32KB Half Block Erase Instruction Sequence Diagram



64K Block Erase (BE) (D8h)

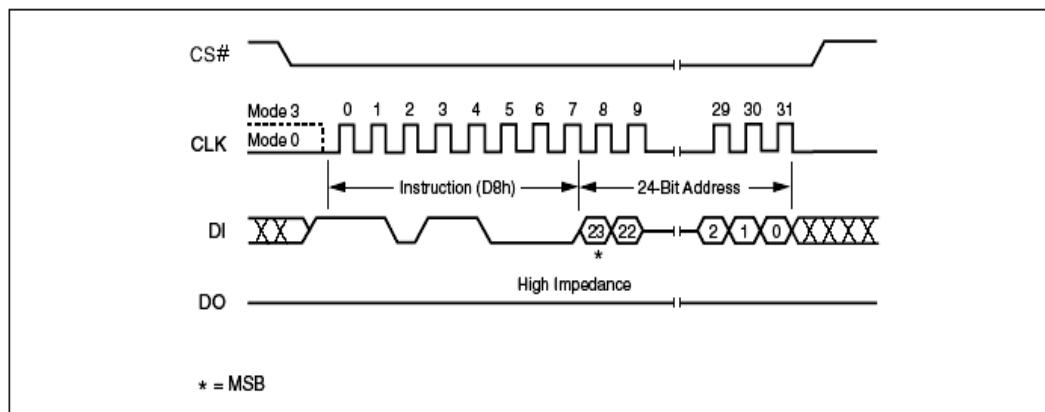
The Block Erase (BE) instruction sets to 1 (FFh) all bits inside the chosen block. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Block Erase (BE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, and three address bytes on Serial Data Input (DI). Any address inside the Block (see Uniform Block Sector Architecture table) is a valid address for the Block Erase (BE) instruction. Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in 64K Block Erase Instruction Sequence Diagram figure. Chip Select (CS#) must be driven High after the eighth bit of the last address byte has been latched in, otherwise the Block Erase (BE) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Block Erase cycle (whose duration is t_{BE}) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Block Erase (BE) instruction applied to a block which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Protected Area Sizes Sector Organization table) or Boot Lock feature will be ignored.

Figure 33. 64K Block Erase Instruction Sequence Diagram



Chip Erase (CE) (C7h/60h)

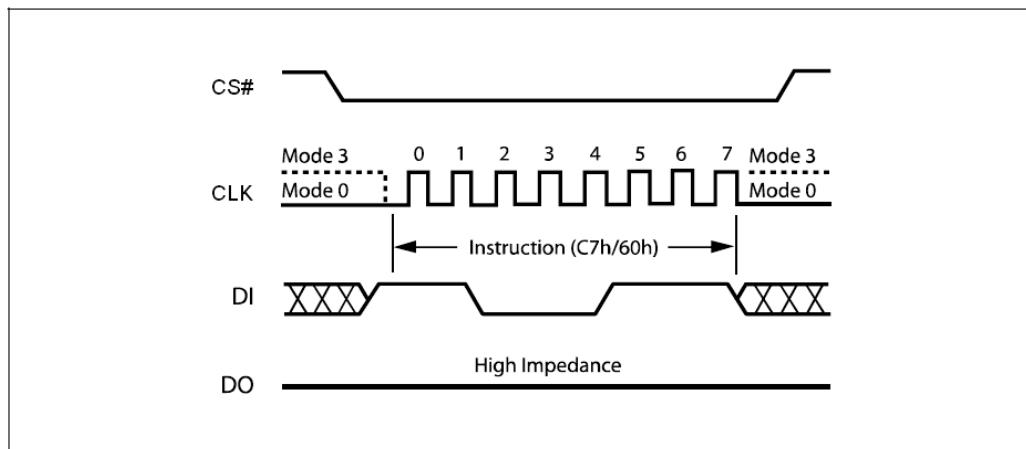
The Chip Erase (CE) instruction sets all bits to 1 (FFh). Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Chip Erase (CE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code on Serial Data Input (DI). Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Chip Erase Instruction Sequence Diagram figure. Chip Select (CS#) must be driven High after the eighth bit of the instruction code has been latched in, otherwise the Chip Erase instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Chip Erase cycle (whose duration is t_{CE}) is initiated. While the Chip Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Chip Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

The Chip Erase (CE) instruction is executed only if all Block Protect (BP3, BP2, BP1, BP0) bits are 0. The Chip Erase (CE) instruction is ignored if one or more blocks are protected.

Figure 34. Chip Erase Instruction Sequence Diagram



Deep Power-down (DP) (B9h)

Executing the Deep Power-down (DP) instruction is the only way to put the device in the lowest consumption mode (the Deep Power-down mode). It can also be used as an extra software protection mechanism, while the device is not in active use, since in this mode, the device ignores all Write, Program and Erase instructions.

Driving Chip Select (CS#) High deselects the device, and puts the device in the Standby mode (if there is no internal cycle currently in progress). But this mode is not the Deep Power-down mode. The Deep Power-down mode can only be entered by executing the Deep Power-down (DP) instruction, to reduce the standby current (from I_{CC1} to I_{CC2} , as specified in DC Characteristics table.)

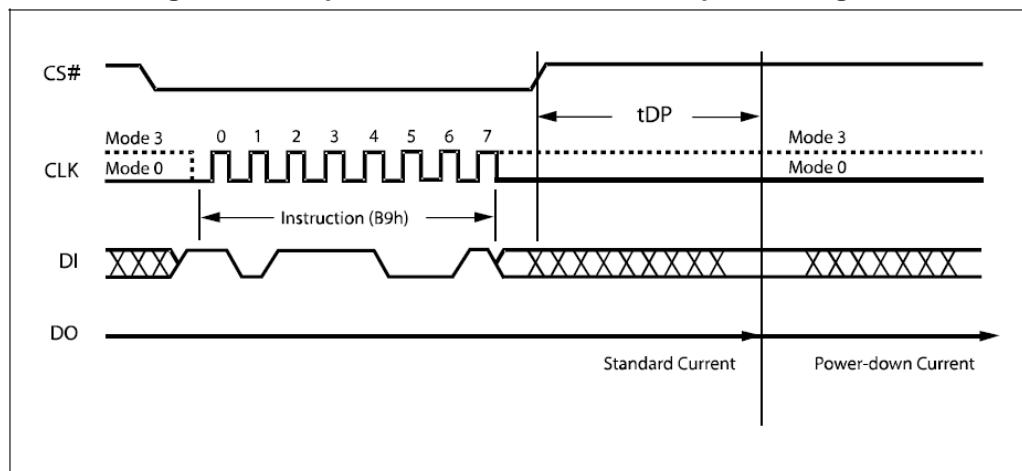
Once the device has entered the Deep Power-down mode, all instructions are ignored except the Release from Deep Power-down, Read Device ID (RDI) and Software Reset instruction which release the device from this mode. The Release from Deep Power-down and Read Device ID (RDI) instruction also allows the Device ID of the device to be output on Serial Data Output (DO).

The Deep Power-down mode automatically stops at Power-down, and the device always Powers-up in the Standby mode. The Deep Power-down (DP) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code on Serial Data Input (DI). Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Deep Power-down Instruction Sequence Diagram figure. Chip Select (CS#) must be driven High after the eighth bit of the instruction code has been latched in, otherwise the Deep Power-down (DP) instruction is not executed. As soon as Chip Select (CS#) is driven High, it requires a delay of t_{DP} before the supply current is reduced to I_{CC2} and the Deep Power-down mode is entered.

Any Deep Power-down (DP) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

Figure 35. Deep Power-down Instruction Sequence Diagram



Release from Deep Power-down and Read Device ID (RDI)

Once the device has entered the Deep Power-down mode, all instructions are ignored except the Release from Deep Power-down and Read Device ID (RDI) instruction. Executing this instruction takes the device out of the Deep Power-down mode.

Please note that this is not the same as, or even a subset of, the JEDEC 16-bit Electronic Signature that is read by the Read Identifier (RDID) instruction. The old-style Electronic Signature is supported for reasons of backward compatibility, only, and should not be used for new designs. New designs should, instead, make use of the JEDEC 16-bit Electronic Signature, and the Read Identifier (RDID) instruction.

When used only to release the device from the power-down state, the instruction is issued by driving the CS# pin low, shifting the instruction code “ABh” and driving CS# high as shown in Release Power-down Instruction Sequence Diagram figure. After the time duration of t_{RES1} (See AC Characteristics) the device will resume normal operation and other instructions will be accepted. The CS# pin must remain high during the t_{RES1} time duration.

When used only to obtain the Device ID while not in the power-down state, the instruction is initiated by driving the CS# pin low and shifting the instruction code “ABh” followed by 3-dummy bytes. The Device ID bits are then shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Release Power-down Instruction Sequence Diagram figure. The Device ID value for the device are listed in Manufacturer and Device Identification table. The Device ID can be read continuously. The instruction is completed by driving CS# high.

When Chip Select (CS#) is driven High, the device is put in the Stand-by Power mode. If the device was not previously in the Deep Power-down mode, the transition to the Stand-by Power mode is immediate. If the device was previously in the Deep Power-down mode, though, the transition to the Standby Power mode is delayed by t_{RES2} , and Chip Select (CS#) must remain High for at least t_{RES2} (max), as specified in AC Characteristics table. Once in the Stand-by Power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

Except while an Erase, Program or Write Status Register cycle is in progress, the Release from Deep Power-down and Read Device ID (RDI) instruction always provides access to the 8bit Device ID of the device, and can be applied even if the Deep Power-down mode has not been entered.

Any Release from Deep Power-down and Read Device ID (RDI) instruction while an Erase, Program or Write Status Register cycle is in progress, is not decoded, and has no effect on the cycle that is in progress.

Figure 36. Release Power-down Instruction Sequence Diagram

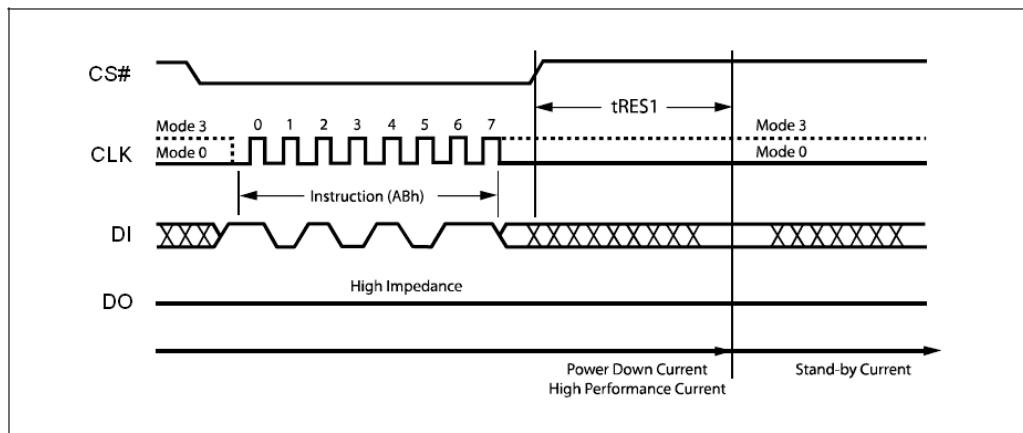
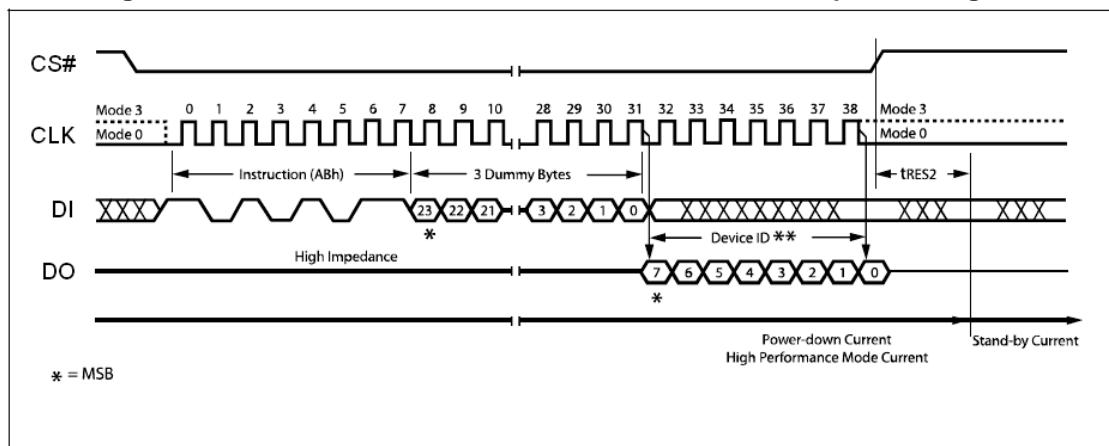


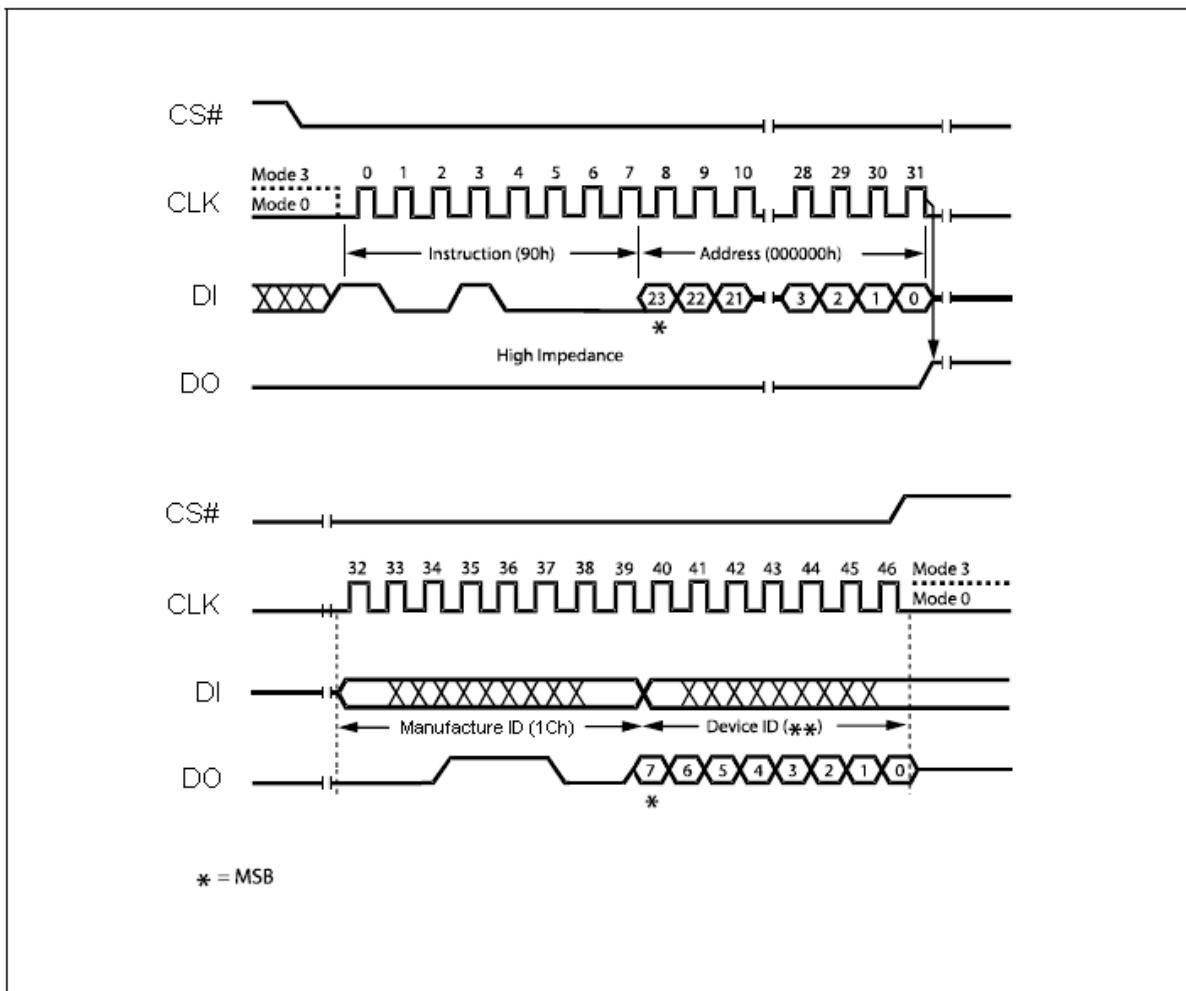
Figure 37. Release Power-down / Device ID Instruction Sequence Diagram


Read Manufacturer / Device ID (90h)

The Read Manufacturer/Device ID instruction is an alternative to the Release from Power-down / Device ID instruction that provides both the JEDEC assigned manufacturer ID and the specific device ID.

The Read Manufacturer/Device ID instruction is very similar to the Release from Power-down / Device ID instruction. The instruction is initiated by driving the CS# pin low and shifting the instruction code "90h" followed by a 24-bit address (A23-A0) of 000000h. After which, the Manufacturer ID for (1Ch) and the Device ID are shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Read Manufacturer / Device ID Diagram figure. The Device ID values for the device are listed in Manufacturer and Device Identification table. If the 24-bit address is initially set to 000001h the Device ID will be read first.

Figure 38. Read Manufacturer / Device ID Diagram



Read Identification (RDID) (9Fh)

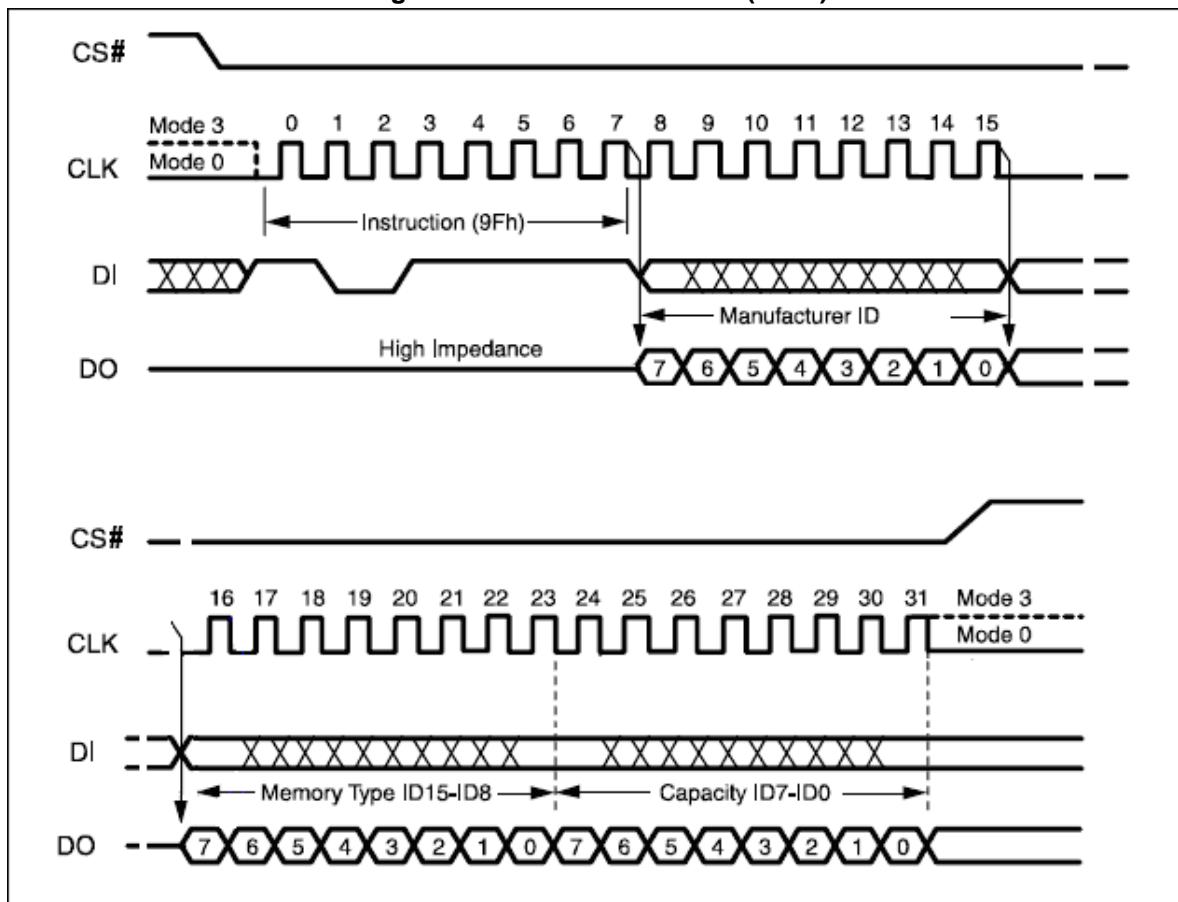
The Read Identification (RDID) instruction allows the 8-bit manufacturer identification to be read, followed by two bytes of device identification. The device identification indicates the memory type in the first byte, and the memory capacity of the device in the second byte.

Any Read Identification (RDID) instruction while an Erase or Program cycle is in progress, is not decoded, and has no effect on the cycle that is in progress. The Read Identification (RDID) instruction should not be issued while the device is in Deep Power down mode.

The device is first selected by driving Chip Select Low. Then, the 8-bit instruction code for the instruction is shifted in. This is followed by the 24-bit device identification, stored in the memory, being shifted out on Serial Data Output , each bit being shifted out during the falling edge of Serial Clock . The instruction sequence is shown in Read Identification (RDID) figure. The Read Identification (RDID) instruction is terminated by driving Chip Select High at any time during data output.

When Chip Select is driven High, the device is put in the Standby Power mode. Once in the Standby Power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

Figure 39. Read Identification (RDID)



Program OTP array (42h)

The Program OTP array operation is similar to the Page Program instruction. It allows from one byte to 256 bytes of security register data to be programmed at previously erased (FFh) memory locations. A Write Enable instruction must be executed before the device will accept the Program OTP array Instruction. The instruction is initiated by driving the CS# pin low then shifting the instruction code “42h” followed by a 24-bit address (A23-A0) and at least one data byte, into the DI pin. The CS# pin must be held low for the entire length of the instruction while data is being sent to the device.

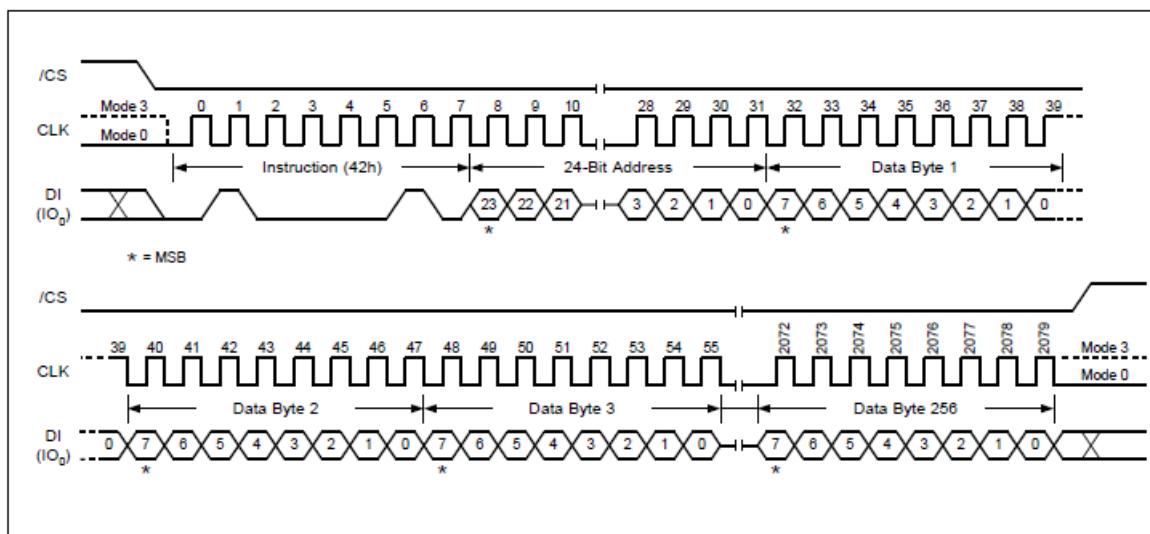
The Program OTP array instruction sequence is shown in Program OTP array figure. The OTP array Lock Bits (SPL0-SPL3) in Status Register 2 can be used to OTP protect the OTP array data. Once a lock bit is set to 1, the corresponding OTP array will be permanently locked, Program OTP array instruction to that register will be ignored.

Table 14. OTP Sector Address

Sector	Sector Size	Address Range
4095	512 byte	FFF000h – FFF1FFh
4094	512 byte	FFE000h – FFE1FFh
4093	512 byte	FFD000h – FFD1FFh

Note: The OTP sector is mapping to sector 4095, 4094 and 4093.

Figure 40. Program OTP array

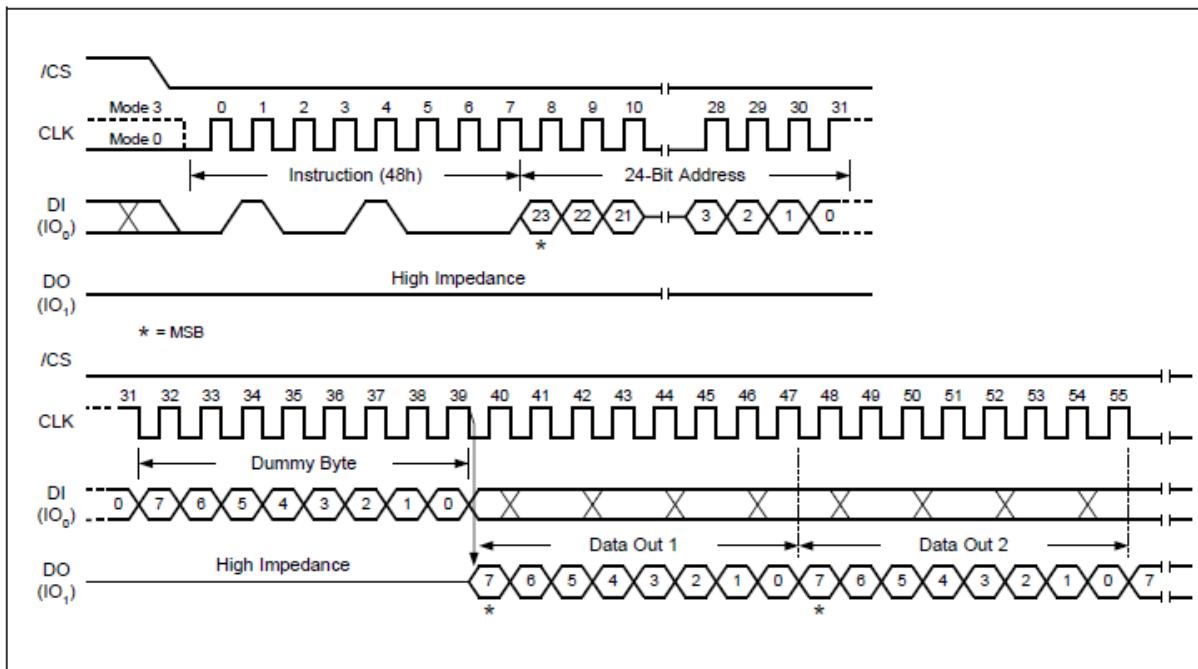


Read OTP array (48h)

The Read OTP array instruction is similar to the Fast Read instruction and allows one or more data bytes to be sequentially read from one of the three OTP array. The instruction is initiated by driving the CS# pin low and then shifting the instruction code “48h” followed by a 24-bit address (A23-A0) and eight “dummy” clocks into the DI pin.

The code and address bits are latched on the rising edge of the CLK pin. After the address is received, the data byte of the addressed memory location will be shifted out on the DO pin at the falling edge of CLK with most significant bit (MSB) first. The byte address is automatically incremented to the next byte address after each byte of data is shifted out. Once the byte address reaches the last byte of the register (byte address FFh), it will reset to address 00h, the first byte of the register, and continue to increment. The instruction is completed by driving CS# high. The Read OTP array instruction sequence is shown in Read OTP array figure. If a Read OTP array instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not have any effects on the current cycle. The Read OTP array instruction allows clock rates from D.C. to a maximum of F_R (see AC Electrical Characteristics).

Figure 41. Read OTP array



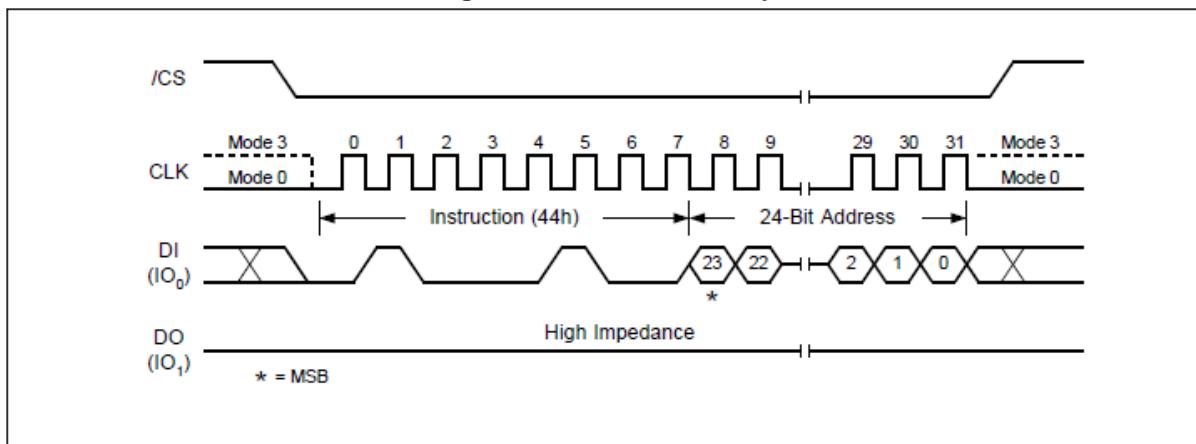
Erase OTP array (44h)

The device offers three set of 512-byte OTP array which can be erased and programmed individually. These registers may be used by the system manufacturers to store security and other important information separately from the main memory array.

The Erase OTP array instruction is similar to the Sector Erase instruction. A Write Enable instruction must be executed before the device will accept the Erase OTP array Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low and shifting the instruction code “44h” followed by a 24-bit address (A23-A0) to erase one of the three security registers.

The Erase OTP array instruction sequence is shown in Erase OTP array figure. The CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the instruction will not be executed. After CS# is driven high, the self-timed Erase OTP array operation will commence for a time duration of tSE (See AC Characteristics). While the Erase OTP array cycle is in progress, the Read Status Register instruction may still be accessed for checking the status of the WIP bit. The WIP bit is a 1 during the erase cycle and becomes a 0 when the cycle is finished and the device is ready to accept other instructions again. After the Erase OTP array cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Security Register Lock Bits (SPL0-3) in the Status Register-2 can be used to OTP protect the security registers. Once a lock bit is set to 1, the corresponding security register will be permanently locked, Erase OTP array instruction to that register will be ignored.

Figure 42. Erase OTP array



Read SFDP Mode and Unique ID Number (5Ah) (the SFDP table length support 512 byte length include unique ID)

Read SFDP Mode

Device features Serial Flash Discoverable Parameters (SFDP) mode. Host system can retrieve the operating characteristics, structure and vendor specified information such as identifying information, memory size, operating voltage and timing information of this device by SFDP mode.

The device is first selected by driving Chip Select (CS#) Low. The instruction code for the Read SFDP Mode is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of Serial Clock (CLK). Then the memory contents, at that address, is shifted out on Serial Data Output (DO), each bit being shifted out, at a maximum frequency F_R , during the falling edge of Serial Clock (CLK).

The instruction sequence is shown in Read SFDP Mode Instruction Sequence Diagram figure. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Serial Flash Discoverable Parameters (SFDP) instruction. When the highest address is reached, the address counter rolls over to 0x00h, allowing the read sequence to be continued indefinitely. The Serial Flash Discoverable Parameters (SFDP) instruction is terminated by driving Chip Select (CS#) High. Chip Select (CS#) can be driven High at any time during data output. Any Read Data Bytes at Serial Flash Discoverable Parameters (SFDP) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

Figure 43. Read SFDP Mode Instruction Sequence Diagram

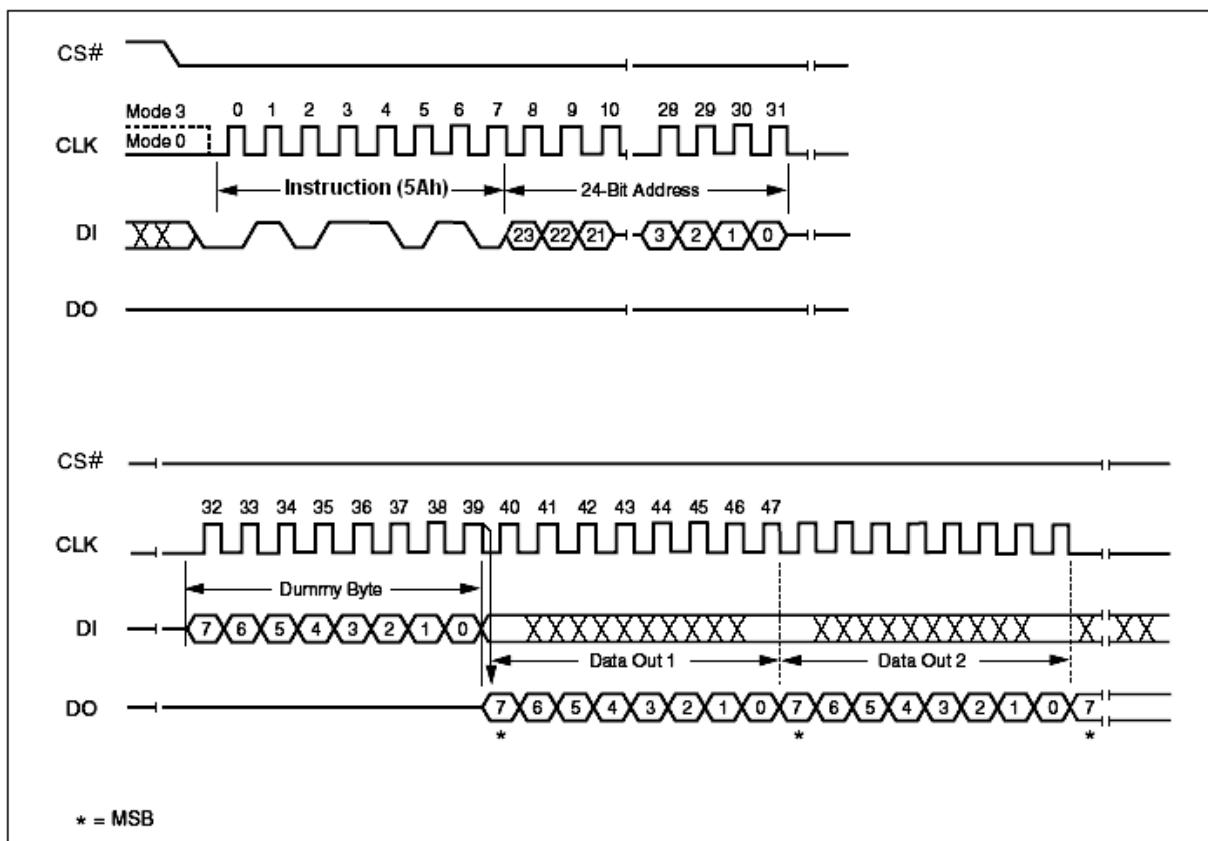


Table 15. Serial Flash Discoverable Parameters (SDFP) Signature and Parameter Identification Data Value (Advanced Information)

Description	Address (h) (Byte Mode)	Address (Bit)	Data (h)	Comment
SDFP Signature	00h	07 : 00	53h	Signature [31:0]: Hex: 50444653
	01h	15 : 08	46h	
	02h	23 : 16	44h	
	03h	31 : 24	50h	
SDFP Minor Revision Number	04h	07 : 00	06h	Star from 0x06
SDFP Major Revision Number	05h	15 : 08	01h	Star from 0x01
Number of Parameter Headers (NPH)	06h	23 : 16	03h	4 parameter header
Unused	07h	31 : 24	FFh	Reserved
ID Number	08h	07 : 00	00h	JEDEC ID
Parameter Table Minor Revision Number	09h	15 : 08	06h	Star from 0x06
Parameter Table Major Revision Number	0Ah	23 : 16	01h	Star from 0x01
Parameter Table Length (in DW)	0Bh	31 : 24	10h	16 DWORDs
Parameter Table Pointer (PTP)	0Ch	07 : 00	30h	000030h
	0Dh	15 : 08	00h	
	0Eh	23 : 16	00h	
Unused	0Fh	31 : 24	FFh	Reserved
ID Number (Vender ID)	10h	07:00	1Ch	
Parameter Table Minor revision Number	11h	15:08	00h	Start from 00h
Parameter Table Major Revision Number	12h	23:16	01h	Start from 01h
Parameter Table Length (in DW)	13h	31:24	04h	
Parameter Table Pointer (PTP)	14h	07:00	10h	
	15h	15:08	01h	
	16h	23:16	00h	
Unused	17h	31:24	FFh	
ID Number (4byte address)	18h	07:00	84h	
Parameter Table Minor revision Number	19h	15:08	00h	
Parameter Table Major Revision Number	1Ah	23:16	01h	
Parameter Table Length (in DW)	1Bh	31:24	02h	
Parameter Table Pointer (PTP)	1Ch	07:00	C0h	
	1Dh	15:08	00h	
	1Eh	23:16	00h	
Unused	1Fh	31:24	FFh	
ID Number (RPCMC)	20h	07:00	03h	RPCMC
Parameter Table Minor revision Number	21h	15:08	00h	
Parameter Table Major Revision Number	22h	23:16	01h	
Parameter Table Length (in DW)	23h	31:24	02h	
Parameter Table Pointer (PTP)	24h	07:00	F0h	
	25h	15:08	00h	
	26h	23:16	00h	
Unused	27h	31:24	FFh	

Table 16. Parameter ID (0) (Advanced Information) 1/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment		
Block / Sector Erase sizes Identifies the erase granularity for all Flash Components	30h	00	01b	E5h	00 = reserved 01 = 4KB erase 10 = reserved 11 = 64KB erase		
Write Granularity		01			0 = No, 1 = Yes		
Write Enable Instruction Required for Writing to Volatile Status Register		02	1b		0: Block Protect bits in device's status register are solely non-volatile or may be programmed either as volatile using the 50h instruction for write enable or non-volatile using the 06h instruction for write enable.		
Write Enable Opcode Select for Writing to Volatile Status Register		03	0b		0: 50h 1: 06h		
Unused		04	0b		Reserved		
		05	111b				
		06					
		07					
4 Kilo-Byte Erase Opcode	31h	08	20h	20h	4 KB Erase Support (FFh = not supported)		
		09					
		10					
		11					
		12					
		13					
		14					
		15					
Supports (1-1-2) Fast Read Device supports single input opcode & address and dual output data Fast Read	32h	16	1b	F1h	0 = not supported 1 = supported		
Address Byte Number of bytes used in addressing for flash array read, write and erase.		17	00b		00 = 3-Byte 01 = 3- or 4-Byte (e.g. defaults to 3-Byte mode; enters 4-Byte mode on command) 10 = 4-Byte 11 = reserved		
Supports Double Data Rate (DDR) Clocking Indicates the device supports some type of double transfer rate clocking.		18			0 = not supported 1 = supported		
Supports (1-2-2) Fast Read Device supports single input opcode, dual input address, and dual output data Fast Read		19	0b		0 = not supported 1 = supported		
Supports (1-4-4) Fast Read Device supports single input opcode, quad input address, and quad output data Fast Read		20	1b		0 = not supported 1 = supported		
Supports (1-1-4) Fast Read Device supports single input opcode & address and quad output data Fast Read		21	1b		0 = not supported 1 = supported		
Unused		22	1b		0 = not supported 1 = supported		
		23	1b		Reserved		
Unused	33h	24	FFh	FFh	Reserved		
		25					
		26					
		27					
		28					
		29					
		30					
		31					

Table 16. Parameter ID (0) (Advanced Information) 2/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (h)	Comment
Flash Memory Density	37h : 34h	31 : 00	7FFFFFFFh	128 Mbits

Table 16. Parameter ID (0) (Advanced Information) 3/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
(1-4-4) Fast Read Number of Wait states (dummy clocks) needed before valid output	38h	00	00100b	44h	4 dummy clocks
		01			
		02			
		03			
		04			
		05	010b		8 mode bits
		06			
		07			
		08			
(1-4-4) Fast Read Opcode Opcode for single input opcode, quad input address, and quad output data Fast Read.	39h	09	EBh	EBh	
		10			
		11			
		12			
		13			
		14			
		15			
(1-1-4) Fast Read Number of Wait states (dummy clocks) needed before valid output	3Ah	16	01000b	08h	8 dummy clocks
		17			
		18			
		19			
		20	000b		Not supported
		21			
		22			
		23			
(1-1-4) Fast Read Opcode Opcode for single input opcode & address and quad output data Fast Read.	3Bh	31 : 24	6Bh	6Bh	

Table 16. Parameter ID (0) (Advanced Information) 4/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
(1-1-2) Fast Read Number of Wait states (dummy clocks) needed before valid output	3Ch	00	01000b	08h	8 dummy clocks
		01			
		02			
		03			
		04			
	3Ch	05	000b		Not supported
		06			
		07			
(1-1-2) Fast Read Opcode	3Dh	15 : 08	3Bh	3Bh	Not supported
Opcode for single input opcode & address and dual output data Fast Read.					
(1-2-2) Fast Read Number of Wait states (dummy clocks) needed before valid output	3Eh	16	00100b	04h	4 dummy clocks
		17			
		18			
		19			
		20			
	3Eh	21	000b		Not supported
		22			
		23			
(1-2-2) Fast Read Opcode	3Fh	31 : 24	BBh	BBh	Not supported
Opcode for single input opcode, dual input address, and dual output data Fast Read.					

Table 16. Parameter ID (0) (Advanced Information) 5/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment	
Supports (2-2-2) Fast Read Device supports dual input opcode & address and dual output data Fast Read.	40h	00	0b	EEh	0 = not supported 1 = supported	
Reserved. These bits default to all 1's		01	111b		Reserved	
		02				
		03				
Supports (4-4-4) Fast Read Device supports Quad input opcode & address and quad output data Fast Read.		04	0b		0 = not supported 1 = supported (EQPI Mode)	
Reserved. These bits default to all 1's		05	111b		Reserved	
		06				
		07				
Reserved. These bits default to all 1's		31 : 08	FFh	FFh	Reserved	

Table 16. Parameter ID (0) (Advanced Information) 6/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment	
Reserved. These bits default to all 1's	45h : 44h	15 : 00	FFh	FFh	Reserved	
(2-2-2) Fast Read Number of Wait states (dummy clocks) needed before valid output	46h	16	00000b	00h	Not supported	
		17				
		18				
		19				
		20			Not supported	
		21	000b	FFh		
		22				
		23				
(2-2-2) Fast Read Opcode Opcode for dual input opcode & address and dual output data Fast Read.	47h	31 : 24	FFh	FFh	Not supported	

Table 16. Parameter ID (0) (Advanced Information) 7/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment	
Reserved. These bits default to all 1's	49h : 48h	15 : 00	FFh	FFh	Reserved	
(4-4-4) Fast Read Number of Wait states (dummy clocks) needed before valid output	4Ah	16	00000b	00h	4 dummy clocks	
		17				
		18				
		19				
		20			8 mode bits	
		21	000b	FFh		
		22				
		23				
(4-4-4) Fast Read Opcode Opcode for quad input opcode/address, quad output data Fast Read.	4Bh	31 : 24	FFh	FFh	Must Enter EQPI Mode firstly	

Table 16. Parameter ID (0) (Advanced Information) 8/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (h)	Comment
Sector Type 1 Size	4Ch	07 : 00	0Ch	4 KB
Sector Type 1 Opcode	4Dh	15 : 08	20h	
Sector Type 2 Size	4Eh	23 : 16	0Fh	32 KB
Sector Type 2 Opcode	4Fh	31 : 24	52h	

Table 16. Parameter ID (0) (Advanced Information) 9/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (h)	Comment
Sector Type 3 Size	50h	07 : 00	10h	64 KB
Sector Type 3 Opcode	51h	15 : 08	D8h	
Sector Type 4 Size	52h	23 : 16	00h	Not Supported
Sector Type 4 Opcode	53h	31 : 24	FFh	Not Supported

Table 16. Parameter ID (0) (Advanced Information) 10/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
Multiplier from typical erase time to maximum erase time (max time = 2*(count+1)*erase typical time)	54h	03:00	0100b	24h	count
Erase type 1 Erase, typical time (typical time = (count + 1)*units)		07:04 08	00010b		count
55h	10:09	01b	62h	units : 00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s	
	Erase type 2 Erase, typical time (typical time = (count + 1)*units)			15:11	01100b
56h	17:16	01b	C9h	units : 00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s	
	Erase type 3 Erase, typical time (typical time = (count + 1)*units)			22:18 23	10010b
57h	24	01b	00h	Units: 00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s	
	Erase type 4 Erase, typical time (typical time = (count + 1)*units)			29:25	00000b
	31:30	00b		Units : 00b: 1 ms, 01b: 16 ms, 10b: 128 ms, 11b: 1 s	

Table 16. Parameter ID (0) (Advanced Information) 11/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment	
Multiplier from typical time to max time for Page or byte program (maximum time = 2 * (count + 1)*typical time)	58h	03:00	0010b	82h	count	
Page Size		07:04	1000b		Page	
Page Program typical time (typical page program time = (count+1)*units)	59h	12:08	00111b	E7h	count	
Byte Program typical time, first byte (first byte typical time = (count+1)*units)		13	1b		Units : 0:8us, 1:64us	
5Ah	15:14	0111b	count			
	Byte Program typical time, additional byte (additional byte time = (count+1)*units)		17:16		39h	Units : 0:1us, 1:8us
			18	0b		count
Chip Erase, typical time	5Bh	22:19	0111b	CFh	Units: 0:1us, 1:8us	
		23	0b		count	
Reserved		28:24	01111b		Units : 00b:16ms, 01b:256ms, 10b:4s, 11b:64s	
		30:29	10b		Reserved	
		31	1b			

Table 16. Parameter ID (0) (Advanced Information) 12/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
Prohibited Operations During Program suspend	5Ch	03:00	0100b	44h	xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) xx0xb: May not initiate a new page program anywhere (program nesting not permitted) x1xxb: May not initiate a read in the program suspended page size 1xxxb: The erase and program restrictions in bits 1:0 are sufficient
Prohibited Operations During Erase suspend		07:04	0100b		xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) xx0xb: May not initiate a page program anywhere x0xxb: Refer to vendor datasheet for read restrictions 0xxxb: Additional erase or program restrictions apply
Reserved	5Dh	08	1b	87h	reserved
Program Resume to Suspend interval		12:09	0011b		Count of fixed units of 64us
Suspend in-progress program max latency (max latency=(count+1)*unitis)		15:13	11100b		count
Erase resume to Suspend interval (latency=(count+1)*64us)	5Eh	17:16	01b	37h	Units : 00b:128ns, 01b:1us, 10b:8us, 11b:64us
		19:18			Count of fixed units of 64us
		23:20	0011b		count
Suspend in-progress erase max latency	5Fh	28:24	11100b	3Ch	Units : 00b: 128ns, 01b:1us, 10b:8us, 11b:64us
		30:29	01b		0:supported 1:not supported
		31	0b		

Table 16. Parameter ID (0) (Advanced Information) 13/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (h)	Comment
Program Resume Instruction	60h	07:00	30h	
Program Suspend Instruction	61h	15:08	B0h	
Resume Instruction	62h	23:16	30h	
Suspend Instruction	63h	31:24	B0h	

Table 16. Parameter ID (0) (Advanced Information) 14/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
Reserved	64h	01:00	11b	F7h	Reserved
Status Register Polling Device Busy		07:02	111101b		Bit 2: Read WIP bit [0] by 05h Read instruction Bit 3: Read bit 7 of Status Register by 70h Read instruction (0=not supported 1=support) Bit 07:04, Reserved: 1111b
Exit Deep Power down to next operation delay (delay=(count+1)*units)	65h	12:08	00010b	A2h	count
		14:13	01b		Units : 00b:128ns, 01b:1us, 10b:8us, 11b:64us
Exit Deep Power down Instruction	66h	15	10101011b (ABh)	D5h	
		22:16			
Enter Deep Power down Instruction	67h	23	10111001b (B9h)	5Ch	
		30:24			
Deep Power down Supported		31	0b		0:suppored 1:not supported

Table 16. Parameter ID (0) (Advanced Information) 15/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
4-4-4 mode disable sequences	68h	03:00	0000b	00h	xxx1b: issue FFh instruction 1xxxb: issue the Soft Reset 66/99 sequence
4-4-4 mode enable sequences		07:04	00000b		x_xx1xb: issue instruction 38h
0-4-4 mode supported		08			0: not supported 1:supported
0-4-4 mode Exit Method		09	0b		xx_xxx1b: Mode Bits[7:0] = 00h will terminate this mode at the end of the current read operation. xx_xx1xb: If 3-Byte address active, input Fh on DQ0-DQ3 for 8 clocks. If 4-Byte address active, input Fh on DQ0-DQ3 for 10 clocks. xx_x1xb: Reserved xx_1xxxb: Input Fh (mode bit reset) on DQ0-DQ3 for 8 clocks. x1_xxxxb: Mode Bit[7:0]≠Axh 1x_xxxxb: Reserved
0-4-4 Mode entry Method	69h	15:10	100100b	90h	xxx1b: Mode Bits[7:0] = A5h Note: QE must be set prior to using this mode x1xxb: Mode Bit[7:0]=Axh 1xxxb: Reserved
Quad Enable Requirements		19:16	1000b		000b: No QE bit. Detects 1-1-4/1-4-4 reads based on instruction 010b: QE is bit 6 of Status Register. where 1=Quad Enable or 0=not Quad Enable 111b: Not Supported
HOLD or RESET Disable by bit 4 of Ext Register		22:20	100b		0:not supported
Reserved	6Bh	31:24	FFh	FFh	Reserved

Table 16. Parameter ID (0) (Advanced Information) 16/16

Description	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
Volatile or Non-Volatile Register and Write Enable Instruction for Status Register 1	6Ch	06:00	1101000b	E8h	xxx_1xxxb: Non-Volatile/Volatile status register 1 powers-up to last written value in the nonvolatile status register, use instruction 06h to enable write to non-volatile status register. Volatile status register may be activated after power-up to override the non-volatile status register, use instruction 50h to enable write and activate the volatile status register. x1x_xxxxb: Reserved 1xx_xxxxb: Reserved NOTE If the status register is read-only then this field will contain all zeros in bits 4:0.
Reserved		07	1b		reserved
Soft Reset and Rescue Sequence Support	6Dh	13:08 09 10 11 12 13	010000b	10h	x1_xxxxb: issue reset enable instruction 66h, then issue reset instruction 99h. The reset enable, reset sequence may be issued on 1, 2, or 4 wires depending on the device operating mode.
Exit 4-byte Address	6Eh	15:14 18:16 23:19	00000b 11000b	C0h	x1_xxxx_xxxxb: Reserved 1x_xxxx_xxxxb: Reserved
Enter 4-Byte Address	6Fh	31:24	10000000b	80h	1xxx_xxxxb: Reserved

Table 17. Parameter ID (1) (Advanced Information-4byte address instruction)

Description (4byte address instruction)	Address (h) (Byte Mode)	Address (Bit)	Data (b/h)	Data (h)	Comment
Support for 1-1-1 Read Command, Instruction=13h	C0h	00	0b	00h	0:not supported 1:supported
Support for 1-1-1 Fast Read Command, Instruction=0Ch		01	0b		0:not supported 1:supported
Support for 1-1-2 Fast Read Command, Instruction=3Ch		02	0b		0:not supported 1:supported
Support for 1-2-2 Fast Read Command, Instruction=BCh		03	0b		0:not supported 1:supported
Support for 1-1-4 Fast Read Command, Instruction=ECh		04	0b		0:not supported 1:supported
Support for 1-4-4 Fast Read Command, Instruction=ECh		05	0b		0:not supported 1:supported
Support for 1-1-1 Page Program Command, Instruction=12h		06	0b		0:not supported 1:supported
Support for 1-1-4 Page Program Command, Instruction=34h		07	0b		0:not supported 1:supported
Support for 1-4-4 Page Program Command, Instruction=3Eh	C1h	08	0b	00h	0:not supported 1:supported
Support for Erase Command-Type 1 size, instruction loop in next Dword		09	0b		0:not supported 1:supported
Support for Erase Command-Type 2 size, instruction lookup in next Dword		10	0b		0:not supported 1:supported
Support for Erase Command-Type 3 size, instruction lookup in next Dword		11	0b		0:not supported 1:supported
Support for Erase Command-Type 4 size, instruction lookup in next Dword		12	0b		0:not supported 1:supported
Support for 1-1-1 DTR Read Command, Instruction=0Eh		13	0b		0:not supported 1:supported
Support for 1-2-2 DTR Read Command, Instruction=BEd		14	0b		0:not supported 1:supported
Support for 1-4-4 DTR Read Command, Instruction=EEh		15	0b		0:not supported 1:supported
Support for volatile individual sector lock Read command, Instruction=E0h	C2h	16	0b	F0h	0=not supported
Support for volatile individual sector lock Write command, Instruction=E1h		17	0b		0=not supported
Support for non-volatile individual sector lock read command, Instruction=E2h		18	0b		0=not supported
Support for non-volatile individual sector lock write command, Instrucion=E3h		19	0b		0=not supported
Reserved		23:20	1111b		
Reserved	C3h	31:24	FFh	FFh	
Instruction for Erase Type 1	C4h	07:00	FFh	FFh	
Instruction for Erase Type 2	C5h	15:08	FFh	FFh	
Instruction for Erase Type 3	C6h	23:16	FFh	FFh	
Instruction for Erase Type 4	C7h	31:24	FFh	FFh	

Table 18. RPMD Parameter ID

Description	Address (h) (Byte Mode)	Address (Bit)	Data (Binary)	Data (Word)	Comment
Flash Hardening	F0h	00	0b	38h	Flash Hardening is supported
MC_Size		01	0b		Monotonic counter size is 32bit
Busy_Polling_Method		02	0b		Poll for OP1 busy using OP2 RPMD status
Reserved		03	1b		Must be 1
Number_Counter-1		07:04	0011b		Number of support counter-1 Suggest value=3
OP1	F1h	15 : 08	9Bh	9Bh	OP1
OP2	F2h	23 : 16	96h	96h	OP2
Update_Rate	F3h	27 : 24	0000b	F0h	Update Rate=5*2**update_Rate (s)
Reserved		31 : 28	1111b		Must be 1
Read Counter Polling Delay (Typ) to calculate HMAC two times	F4h	04 : 00	0 1010b	AAh	Counter
		06:05	01b		Unit 01: 16us
		07	1b		Reserved
Write Counter Polling Short Delay	F5h	12 : 08	1 0100b	B4h	Polling_Short_delay_write_counter
		14 :13	01b		Unit 01 16us
		15	1b		Reserved
Write Counter Polling Long Delay	F6h	20 : 16	1 0100b	B4h	Polling_long_delay_write_counter
		22 : 21	01b		Unit 01: 16ms
		23	1b		Reserved
Reserved	F7h	31 : 24	FFh	FFh	Must be 1

Table 19. Parameter ID (2) (Advanced Information-ESMT flash parameter)

Description (ESMT Flash Parameter Tables)	Address (h) (Byte Mode)	Address (Bit)	Data (h/b)	Data (h)	Comment
V_{CC} Supply Max Voltage	111h:110h	07:00 15:08	00h 36h	00h 36h	3600h=3.6V
V_{CC} Supply Min Voltage	113h:112h	23:16 31:24	00h 27h	00h 27h	2700h=2.7V
HW RESET# pin	115h:114h	00	1b	9Fh	0:not support 1:supported
HW HOLD# pin		01	1b		0:not support 1:supported
Deep Power down Supported		02	1b		0:not support 1:supported
SW Reset		03	1b		0:not support 1:supported
SW Reset Instruction		07:04 11:08	99h		
Program Suspend/Resume		12	1b	F9h	0:not support 1:supported
Erase Suspend/Resume		13	1b		0:not support 1:supported
Unused		14	1b		
Wrap Read Mode		15	1b		0:not support 1:supported
Wrap Read Instruction	116h	23:16	0Ch	0Ch	
Wrap Read data length	117h	31:24	64h	64h	64h:8B&16B &32B&64B
Individual block lock	11Bh:118h	00	0b	FCh	0:not support 1:supported
Individual block lock bit		01	0b		0:volatile 1:nonvolatile
Individual block lock Instruction		07:02 09:08	FFh		
Individual block lock Volatile protect bit default protect status		10	0b	CBh	0:protect 1:unprotect
Secured OTP		11	1b		0:not support 1:supported
Read Lock		12	0b		0:not support 1:supported
Permanent Lock		13	0b		0:not support 1:supported
Unused		15:14	11b		
Unused		31:16	FFh	FFh	
Unused	11F:11Ch		FFh	FFh	

Read Unique ID Number

The Read Unique ID Number instruction accesses a factory-set read-only 96-bit number that is unique to each device. The ID number can be used in conjunction with user software methods to help prevent copying or cloning of a system. The Read Unique ID instruction is initiated by driving the CS# pin low and shifting the instruction code "5Ah" followed by a three bytes of addresses, 0x1E0h, and one byte of dummy clocks. After which, the 96-bit ID is shifted out on the falling edge of CLK as shown in Read SFDP Mode Instruction Sequence Diagram figure.

Table 20. Unique ID Number

Description	Address (h) (Byte Mode)	Address (Bit)	Data (h)	Comment
Unique ID Number	1E0h : 1EBh	95 : 00	By die	

Write Root Key Register (9Bh + 00h)

This command is used by the SPI Flash Controller to initialize the Root Key Register corresponding to the received Counter Address with the received Root Key. It is expected to be used in an OEM manufacturing environment when the SPI Flash Controller and SPI Flash are powered together for the first time.

After the command is issued on the interface the SPI Flash device must ensure that the received transaction is error free. This includes checking following conditions:

- Payload size is correct. (include OP1 is 64 bytes)
- Counter Address falls within the range of supported counters.
- The Root Key Register corresponding to the requested Counter Address was previously ninitialized. [Root_Key_Reg_Init_State[Counter_Address] = 0xFFh]
- Truncated signature field is the same as least significant 224 bits of HMAC-SHA-256 based signature computed based on received input parameters.

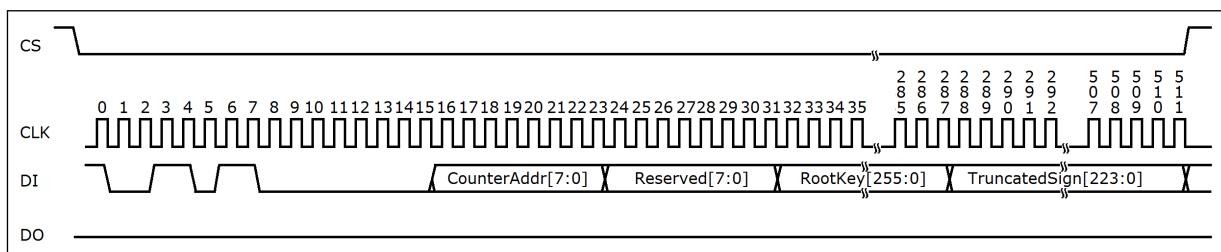
If the received transaction is error free SPI Flash device successfully executes the command and posts “successful completion” in the RPMD Status Register. This command must be executed to ensure that power cycling in the middle of command execution is properly handled. This requires that the internal state tracking the root key register initialization is written as the last operation of the command execution.

(Root Key Reg Init State[Counter Address] = 0)

Root Key Register Write with root key is = 256'hFF...FF is used as a temporary key. When this request is received error-free Root_Key_Reg_Init_State[Counter_Address] is not affected. Instead only the corresponding Monotonic Counter is initialized to 0 if previously uninitialized. This state is tracked as separate state using MC_Init_State[Counter_Address]. This state is used to leave the monotonic counters at the current value when an error free Root Key Register Write operation is received. (Both 256'hFF..FF and non 256'hFF..FF)

Once this command is successfully executed with a non 256'hFF..FF Root Key, the device will not accept the "Write Root Key Register" command any more, and the Root Key value cannot be read out by any instructions.

Figure 44. Write Root Key Instruction Sequence Diagram



Update HMAC Key (9Bh + 01h)

This command is used by the SPI Flash Controller to update the HMAC-Key register corresponding to the received Counter Address with a new HMAC key calculated based on received input. This command must be issued once only on every power cycle event on the interface. This allows the HMAC key storage to be implemented using volatile memory. Status register busy indication is expected to indicate busy for double the amount of Read_Counter_Polling_Delay specified in SFDP table since this command performs two distinct HMAC-SHA-256 computations.

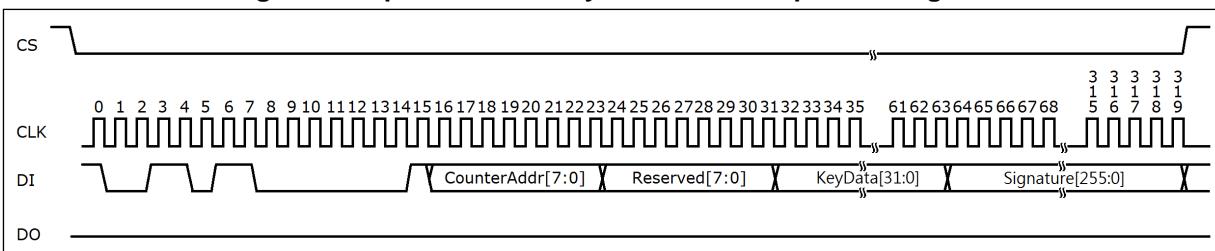
After the command is issued on the interface the SPI Flash device must ensure that the received transaction is error free. This includes checking following conditions:

- Payload size is correct. (including OP1 = 40 bytes)
- Counter Address falls within the range of supported counters.
- The Monotonic Counter corresponding to the requested Counter Address was previously initialized.
- Signature matches the HMAC-SHA-256 based signature computed based on received input parameters. This command performs two HMAC-SHA-256 operations.

If the received transaction is error free, the SPI Flash device successfully executes the command and posts “successful completion” in the RPMC Status Register.

If the received transaction has errors, the SPI Flash device does not execute the transaction and posts the corresponding error in the RPMC Status Register.

Figure 45. Update HMAC Key Instruction Sequence Diagram



Increment Monotonic Counter (9Bh + 02h)

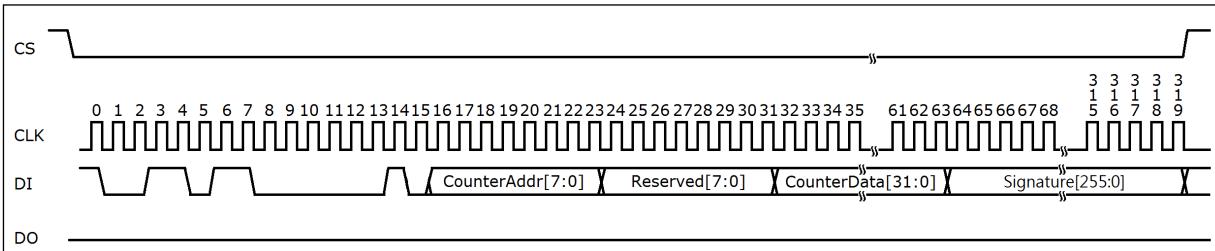
This command is used by the SPI Flash Controller to increment the Monotonic counter by 1 inside the SPI Flash Device.

After the command is issued on the interface the SPI Flash device must ensure that the received transaction is error free. This includes checking following conditions:

- Payload size is correct. (including OP1 = 40 bytes)
- Counter Address falls within the range of supported counters.
- The Monotonic Counter corresponding to the requested Counter Address was previously initialized.
- The HMAC Key Register corresponding to the requested Counter Address was previously initialized.
- The requested Signature matches the HMAC-SHA-256 based signature computed based on received input parameters.
- The received Counter Data matches the current value of the counter read from the SPI Flash.

If the received transaction is error free, the SPI Flash device successfully executes the command and posts “successful completion” in the RPMC Status Register. The increment counter implementation should make sure that the counter increment operation is performed in a power glitch aware manner.

Figure 46. Increment Monotonic Counter Instruction Sequence Diagram



Request Monotonic Counter (9Bh + 03h)

This command is used by the SPI Flash Controller to request the Monotonic counter value inside the SPI Flash Device.

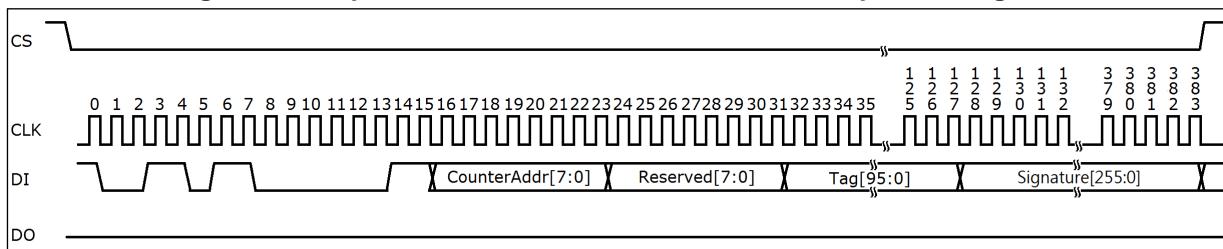
After the command is issued on the interface the SPI Flash device must ensure that the received transaction is error free. This includes checking following conditions:

- Payload size is correct. (including OP1 = 48 bytes)
- Counter Address falls within the range of supported counters.
- The Monotonic Counter corresponding to the requested Counter Address was previously initialized.
- The HMAC Key Register corresponding to the requested Counter Address was previously initialized.
- The requested Signature matches the HMAC-SHA-256 based signature computed based on received input parameters.

If the received transaction is error free, the SPI Flash device successfully executes the command and posts “successful completion” in the RPMC Status Register. In response to this command, the SPI flash reads the monotonic counter addressed by counter address. It calculates HMAC-SHA-256 signatures the second time, based on following parameters.

- HMAC Message[127:0] = Tag [95:0], Counter_Data_Read[31:0]
- HMAC Key[255:0] = HMAC_Key_Register[Counter_Address][255:0]

Figure 47. Request Monotonic Counter Instruction Sequence Diagram



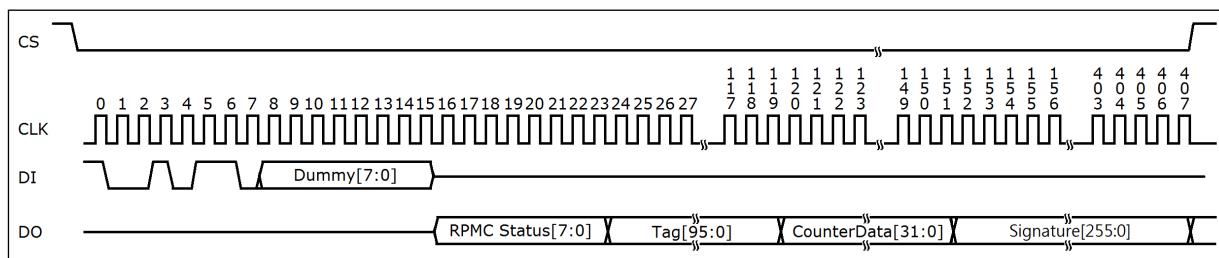
Reserved RPMC Commands (9Bh + 04h~FFh)

If the SPI Flash Controller issues any of the reserved command-types, the SPI Flash Device must return Error status in the RPMC Status Register. It asserts bit 2 to indicate that a reserved command-type was issued.

Read RPMC Status / Data (96h)

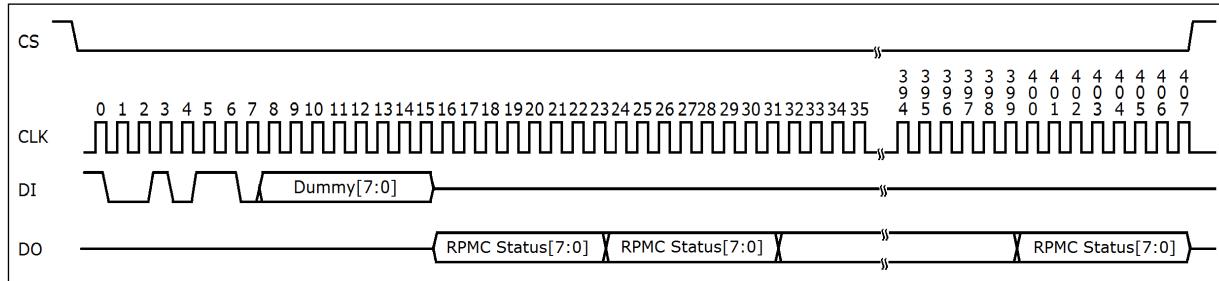
This command is used by the SPI Flash Controller to read the RPMC status from any previously issued OP1 command. In addition, if previous OP1 command is Request Monotonic Counter and if SPI Flash returns successful completion (BUSY=0) in the RPMC Status Register, then it must also return valid values in the Tag, Counter Data and Signature field. If there're other error flags, the values returned in Tag, Counter and Signature field are invalid. The controller may abort the read prematurely prior to completely reading the entire payload. This may occur when the controller wants to simply read the RPMC status or when it observes an error being returned in the RPMC status field. The controller may also continue reading past the defined payload size of 49 bytes. Since this is an error condition, the SPI Flash may return any data past the defined payload size. The controller must ignore the data.

Figure 48. Read RPMC Status / Data Instruction Sequence Diagram (BUSY=0)



When BUSY=1, from Byte-3 and beyond, the device will output the RPMC_Status[7:0] value continuously until CS# terminates the instruction. The device will not output Tag, CounterData & Signature fields when BUSY=1. Once BUSY becomes 0, another OP2 command must be issued to read out the correct Tag, CounterData & Signature fields.

Figure 49. Read RPMC Status Instruction Sequence Diagram (BUSY=1)



Power-up Timing

All functionalities and DC specifications are specified for a V_{CC} ramp rate of greater than 1V per 100 ms (0V to 2.7V in less than 270 ms). See Power-Up Timing table and Power-Up Timing figure for more information.

Figure 50. Power-up Timing

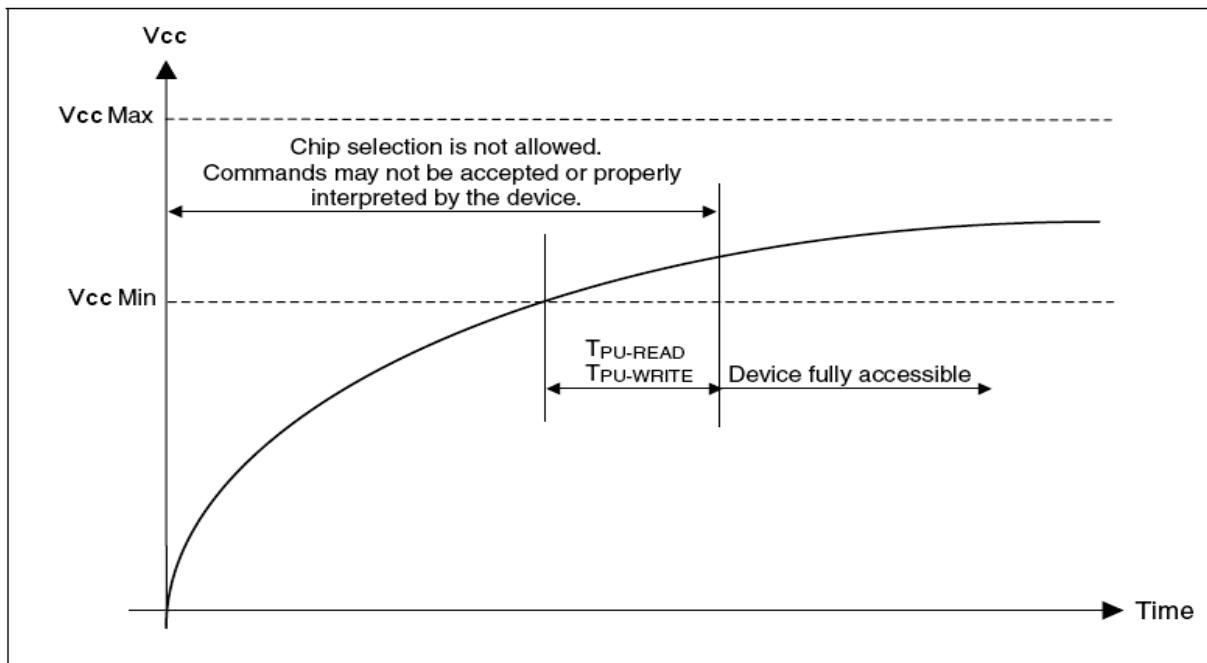


Table 21. Power-Up Timing

Symbol	Parameter	Min.	Unit
$T_{PU-READ}^{*1}$	V_{CC} Min to Read Operation	100	μs
$T_{PU-WRITE}^{*1}$	V_{CC} Min to Write Operation	100	μs

Note:

1. This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.

INITIAL DELIVERY STATE

The device is delivered with the memory array erased: all bits are set to 1 (each byte contains FFh). The Status Register contains 00h (all Status Register bits are 0).

DC Characteristics and Operating Conditions

Table 22. DC Characteristics

($T_A = -40^\circ\text{C}$ to 85°C ; $V_{CC} = 2.7\text{-}3.6\text{V}$)

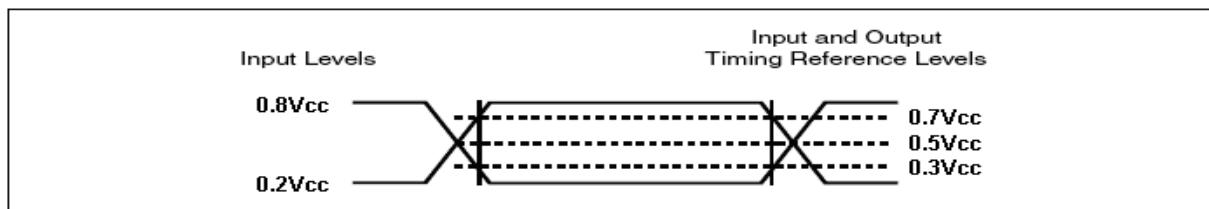
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{LI}	Input Leakage Current		-	1	± 2	μA
I_{LO}	Output Leakage Current		-	1	± 2	μA
I_{CC1}	Standby Current	$CS\# = V_{CC}$, $V_{IN} = V_{SS}$ or V_{CC}	-	1	20	μA
I_{CC2}	Deep Power-down Current	$CS\# = V_{CC}$, $V_{IN} = V_{SS}$ or V_{CC}	-	1	20	μA
I_{CC3}	Operating Current (READ)	$CLK = 0.1 V_{CC} / 0.9 V_{CC}$ at 104 MHz, DQ = open	-	12	18	mA
		$CLK = 0.1 V_{CC} / 0.9 V_{CC}$ at 104 MHz, Quad Output Read, DQ = open	-	16	22	mA
I_{CC4}	Operating Current (PP)	$CS\# = V_{CC}$	-	9	30	mA
I_{CC5}	Operating Current (WRSR)	$CS\# = V_{CC}$	-	-	25	mA
I_{CC6}	Operating Current (SE)	$CS\# = V_{CC}$	-	13	25	mA
I_{CC7}	Operating Current (BE)	$CS\# = V_{CC}$	-	15	25	mA
I_{CC9}	RPMC OP1 Write Only	$CS\# = V_{CC}$		15	20	mA
I_{CC10}	RPMC OP1 & Array Read	$CLK = 0.1 V_{CC} / 0.9 V_{CC}$, DQ = open		19	40	mA
I_{CC11}	RPMC OP1 & Array Program / Erase	$CS\# = V_{CC}$		35	45	mA
I_{CC12}	RPMC OP2 Read Only	$CLK = 0.1 V_{CC} / 0.9 V_{CC}$			30	mA
I_{CC13}	RPMC OP2 & Array Program / Erase	$CLK = 0.1 V_{CC} / 0.9 V_{CC}$		30	45	mA
V_{IL}	Input Low Voltage		-0.5	-	$0.2 V_{CC}$	V
V_{IH}	Input High Voltage		$0.7 V_{CC}$	-	$V_{CC}+0.4$	V
V_{OL}	Output Low Voltage	$I_{OL} = 100 \mu\text{A}$, $V_{CC} = V_{CC}$ Min.	-	-	0.3	V
V_{OH}	Output High Voltage	$I_{OH} = -100 \mu\text{A}$, $V_{CC} = V_{CC}$ Min.	$V_{CC}-0.2$	-	-	V

AC Timing Input / Output Conditions

Table 23. AC Measurement Conditions

Symbol	Parameter	Min.	Max.	Unit
C_L	Load Capacitance		30	pF
	Input Rise and Fall Times	-	5	ns
	Input Pulse Voltages	0.2V _{CC}	to 0.8V _{CC}	V
	Input Timing Reference Voltages	0.3V _{CC}	to 0.7V _{CC}	V
	Output Timing Reference Voltages	V _{CC} / 2		V

Figure 51. Measurement I/O Waveform



AC Timing Input / Output Conditions

Table 24. AC Characteristics

($T_A = -40^\circ\text{C}$ to 85°C ; $V_{CC} = 2.7\text{-}3.6\text{V}$)

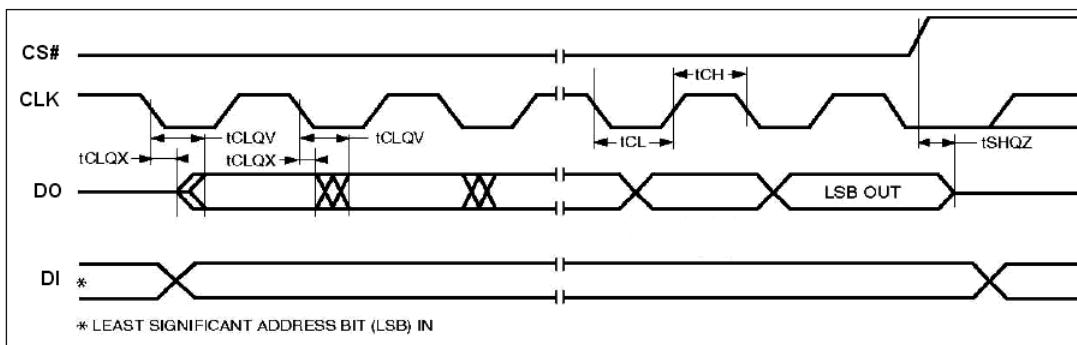
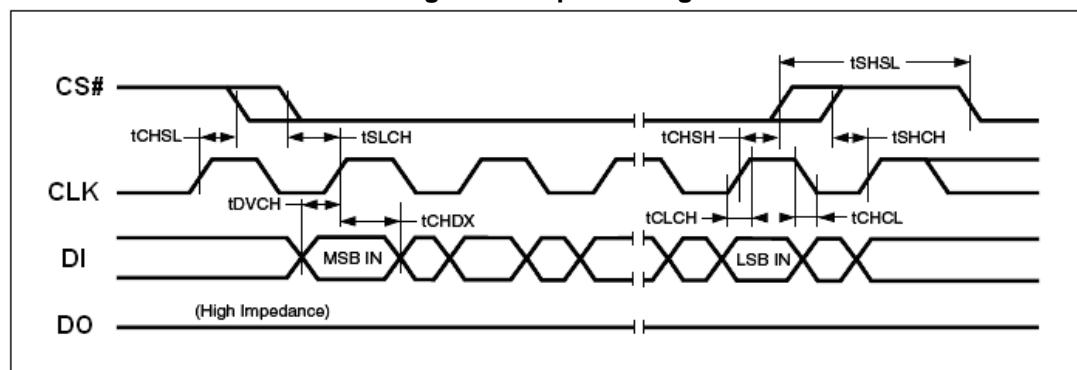
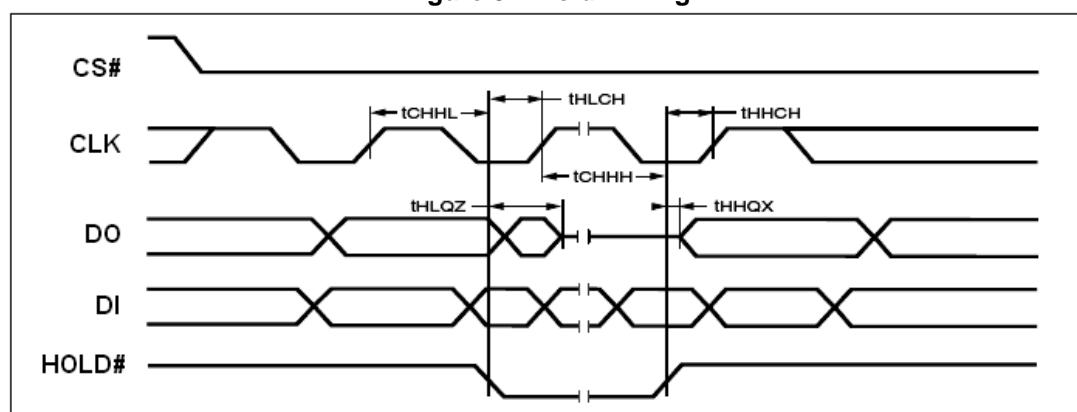
Symbol	Alt	Parameter	Min	Typ	Max	Unit
F_R	f_C	Serial SPI Clock Frequency for: PP, QPP, SE, HBE, BE, CE, DP, RES, RDP, WREN, WRDI, WRSR, WRSR3, Fast Read	D.C.	-	104	MHz
		Serial SPI Clock Frequency for: RDSR, RDSR3, RDID	D.C.	-	104	MHz
		Serial Dual/Quad Clock Frequency for: PP, QPP, SE, HBE, BE, CE, DP, RES, RDP, WREN, WRDI, WRSR, WRSR3, RDSR, RDSR3, RDID, Fast Read, Dual Output Fast Read, Dual I/O Fast Read, Quad I/O Fast Read	D.C.	-	104	MHz
		Serial Quad Clock Frequency for: Quad Output Fast Read, Quad I/O Fast Read	D.C.	-	104	MHz
f_R		Serial Clock Frequency for READ	D.C.	-	50	MHz
F_R	f_C	Serial Clock Frequency for RPNC	D.C.	-	80	MHz
t_{CH}^{*1}		Serial Clock High Time	3.5	-	-	ns
t_{CL}^{*1}		Serial Clock Low Time	3.5	-	-	ns
t_{CH}^{*1}		Serial Clock High Time (RPNC)	5	-	-	ns
t_{CL}^{*1}		Serial Clock Low Time (RPNC)	5	-	-	ns
t_{CLCH}^{*2}		Serial Clock Rise Time (Slew Rate)	0.1	-	-	V / ns
t_{CHCL}^{*2}		Serial Clock Fall Time (Slew Rate)	0.1	-	-	V / ns
t_{SLCH}	t_{CSS}	CS# Active Setup Time	5	-	-	ns
t_{CHSH}		CS# Active Hold Time	5	-	-	ns
t_{SHCH}		CS# Not Active Setup Time	5	-	-	ns
t_{CHSL}		CS# Not Active Hold Time	5	-	-	ns
t_{SHSL}	t_{CSH}	CS# High Time for read	30	-	-	ns
		CS# High Time for program/erase	30	-	-	ns
		CS# High Time for RPNC	50	-	-	ns
t_{SHSL}^{*2}	t_{CSH}	Volatile Register Write Time	50	-	-	ns
t_{SHQZ}^{*2}	t_{DIS}	Output Disable Time	-	-	6	ns
		Output Disable Time (RPNC)	-	-	10	ns
t_{CLQX}	t_{HO}	Output Hold Time	0	-	-	ns
t_{DVCH}	t_{DSU}	Data In Setup Time	2	-	-	ns
t_{CHDX}	t_{DH}	Data In Hold Time	3	-	-	ns
		Data In Hold Time (RPNC)	3	-	-	ns
t_{HLCH}		HOLD# Low Setup Time (Relative to CLK)	5	-	-	ns
t_{HHCH}		HOLD# High Setup Time (Relative to CLK)	5	-	-	ns
t_{CHHH}		HOLD# Low Hold Time (Relative to CLK)	5	-	-	ns
t_{CHHL}		HOLD# High Hold Time (Relative to CLK)	5	-	-	ns

Table 24. AC Characteristics (Continued)

Symbol	Alt	Parameter		Min	Typ	Max	Unit
tCLQV	tv	Output Valid from CLK (30pF)		-	-	8	ns
		Output Valid from CLK (15pF)		-	-	6	ns
		Output Valid from CLK (RPMC)		-	-	7.5	ns
tWHL3		Write Protect Setup Time before CS# Low		20	-	-	ns
tSHWL3		Write Protect Hold Time after CS# High		100	-	-	ns
t _{D^P} ^{*2}		CS# High to Deep Power-down Mode		-	-	3	μs
t _{RES1} ^{*2}		CS# High to Standby Mode without Electronic Signature read		-	-	3	μs
t _{RES2} ^{*2}		CS# High to Standby Mode with Electronic Signature read		-	-	1.8	μs
t _W		Write Status Register Cycle Time		-	10	50	ms
t _{PP}		Page Programming Time		-	0.5	3	ms
t _{SE}		Sector Erase Time		-	0.04	0.3	s
t _{HBE}		Half Block Erase Time		-	0.2	1	s
t _{BE}		Block Erase Time		-	0.3	2	s
t _{CE}		Chip Erase Time		-	60	200	s
t _{KEY}		RPMC Write Root Key Register		-	280	500	μs
t _{HMAC}		RPMC Update HMAC Key Register		-	140	400	μs
t _{INC1}		RPMC Increment Monotonic Counter		-	120	300	μs
t _{INC2}		RPMC Increment Monotonic Counter (Counter Switching)		-	120	300	ms
t _{REQ}		RPMC Request Monotonic Counter		-	150	400	μs
t _{HRST}		RESET# low period to reset the device		1	-	-	μs
t _{HRSL}		RESET# high to next instruction		28	-	-	μs
t _{SHRV}		Deselect to RESET# valid in quad mode		8	-	-	ns
t _{SR}		Software Reset Latency	WIP = write operation	-	-	28	μs
			WIP = not in write operation	-	-	0	μs

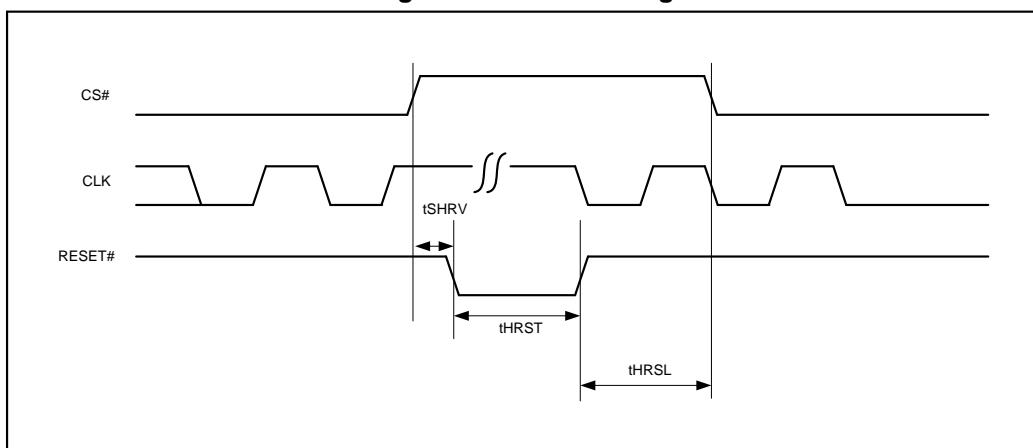
Note:

1. $t_{CH} + t_{CL}$ must be greater than or equal to $1/f_C$.
2. Value guaranteed by characterization, not 100% tested in production.
3. Only applicable as a constraint for a Write status Register instruction when Status Register Protect Bit is set at 1.

Figure 52. Serial Output Timing

Figure 53. Input Timing

Figure 54. Hold Timing


Note: All RPMD instructions are not support HOLD# function.

Figure 55. Reset Timing



ABSOLUTE MAXIMUM RATINGS

Stresses above the values so mentioned above may cause permanent damage to the device. These values are for a stress rating only and do not imply that the device should be operated at conditions up to or above these values. Exposure of the device to the maximum rating values for extended periods of time may adversely affect the device reliability.

Table 25. Absolute Ratings

Parameter	Value	Unit
Storage Temperature	-65 to +150	°C
Output Short Circuit Current ^{*1}	200	mA
Input and Output Voltage (with respect to ground) ^{*2}	-0.5 to V _{cc} +0.5	V
V _{cc}	-0.5 to V _{cc} +0.5	V

Note:

1. No more than one output shorted at a time. Duration of the short circuit should not be greater than one second.
2. Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, inputs may undershoot V_{ss} to -1.0V for periods of up to 50ns and to -2.0V for periods of up to 20ns. See figure below. Maximum DC voltage on output and I/O pins is V_{cc} + 0.5V. During voltage transitions, outputs may overshoot to V_{cc} + 1.5V for periods up to 20ns. See figure below.

RECOMMENDED OPERATING RANGES ^{*1}

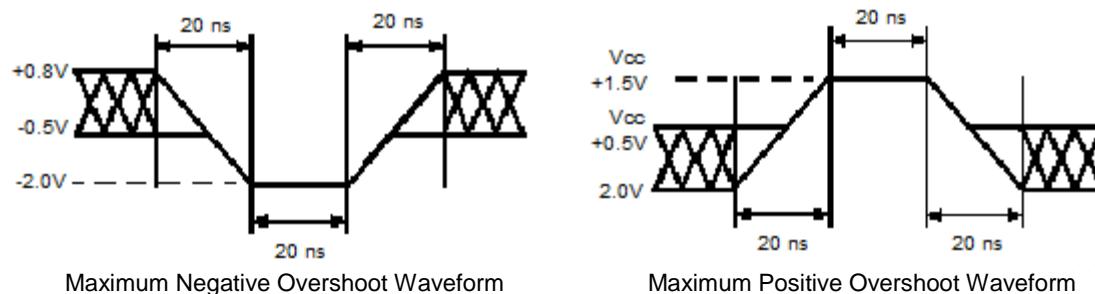
Table 26. Operating Conditions

Parameter	Value	Unit
Ambient Operating Temperature Industrial Devices	-40 to 85	°C
Operating Supply Voltage V _{cc}	Full: 2.7 to 3.6	V

Note:

1. Recommended Operating Ranges define those limits between which the functionality of the device is guaranteed.

Figure 56. Overshoot Waveform



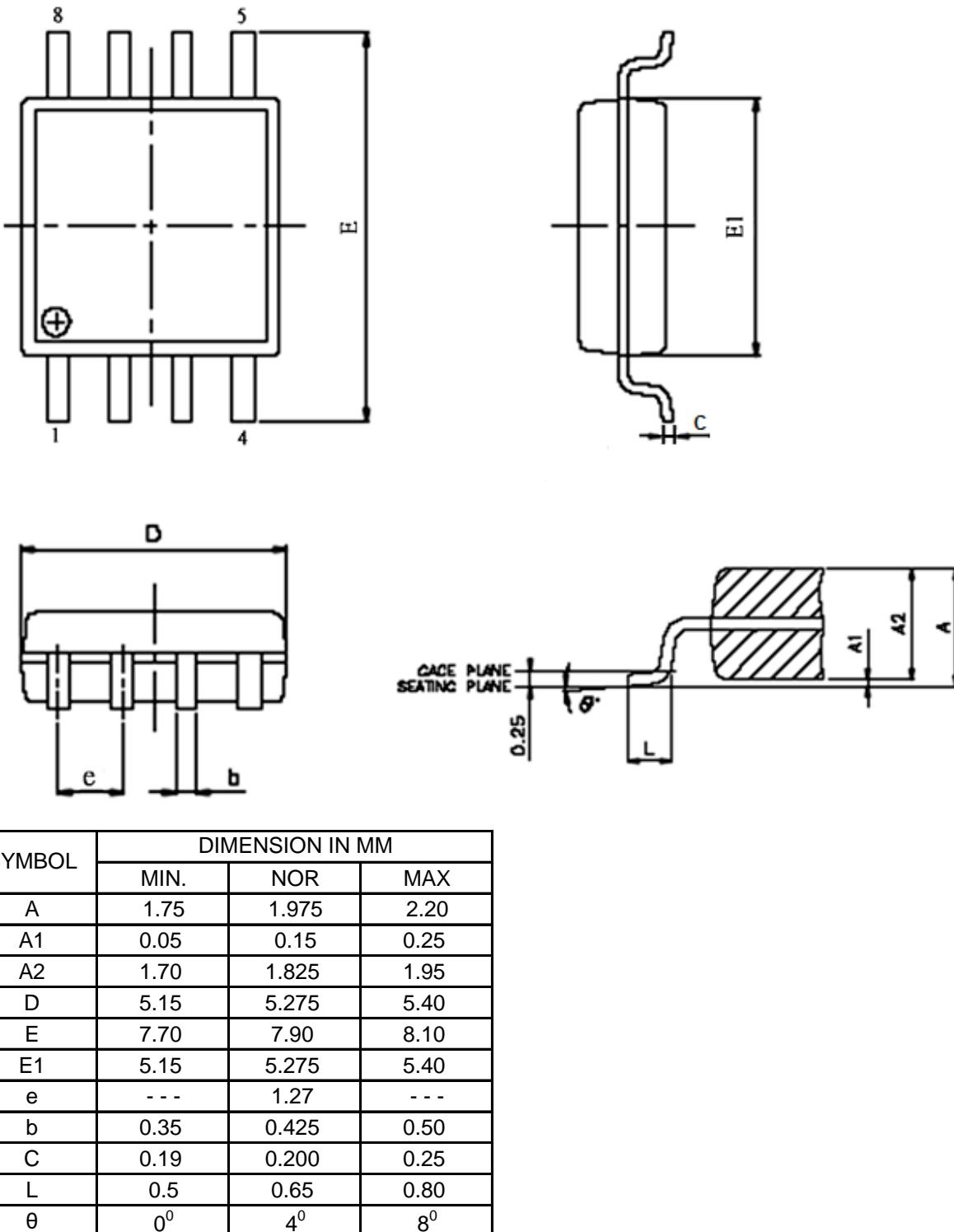
Input / Output Capacitance

Table 27. CAPACITANCE

($V_{CC} = 2.7\text{-}3.6V$)

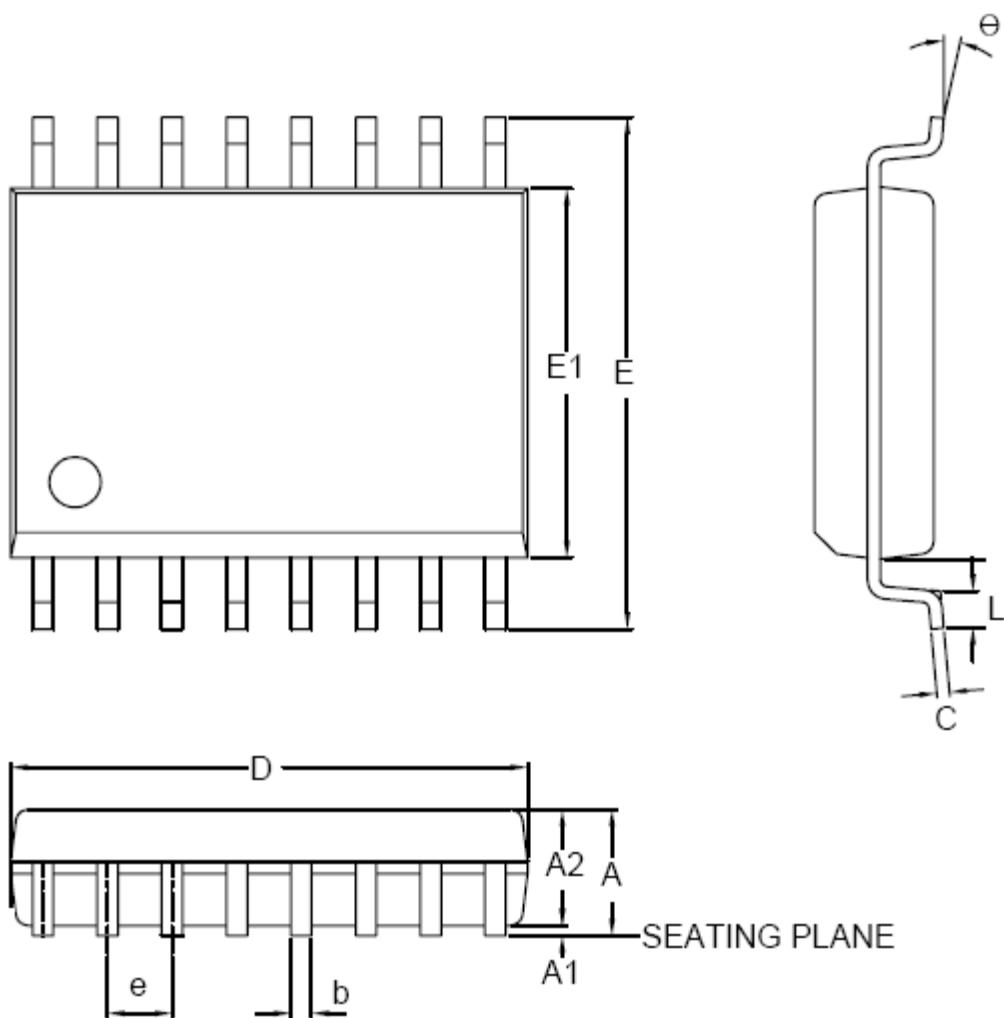
Parameter Symbol	Parameter Description	Test Setup	Typ	Max	Unit
C_{IN}	Input Capacitance	$V_{IN} = 0$	-	6	pF
C_{OUT}	Output Capacitance	$V_{OUT} = 0$	-	8	pF

Note: Sampled only, not 100% tested, at $T_A = 25^\circ\text{C}$ and a frequency of 20 MHz.

PACKAGE MECHANICAL
Figure 57. SOP 200 mil (official name = 208 mil)


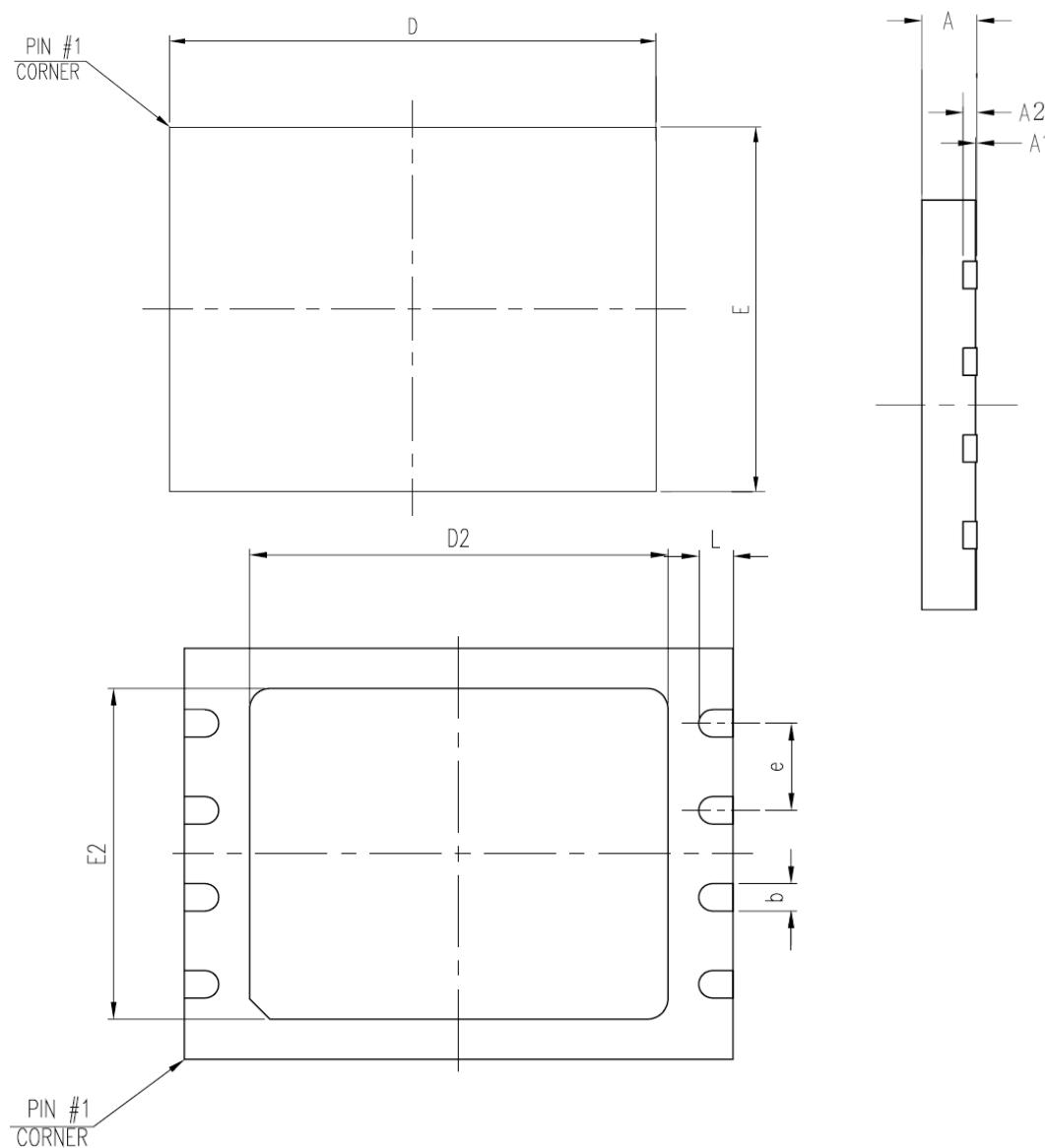
Note : 1. Coplanarity: 0.1 mm

 2. Max. allowable mold flash is 0.15 mm
 at the pkg ends, 0.25 mm between leads.

Figure 58. 16-LEAD SOP 300 mil


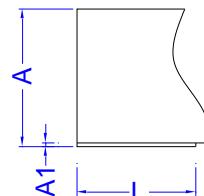
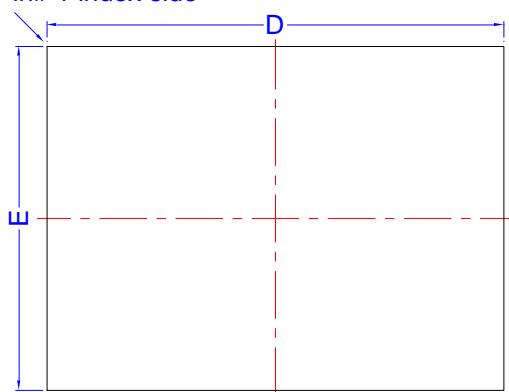
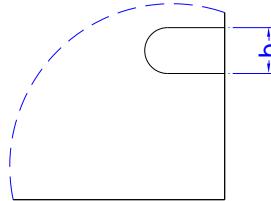
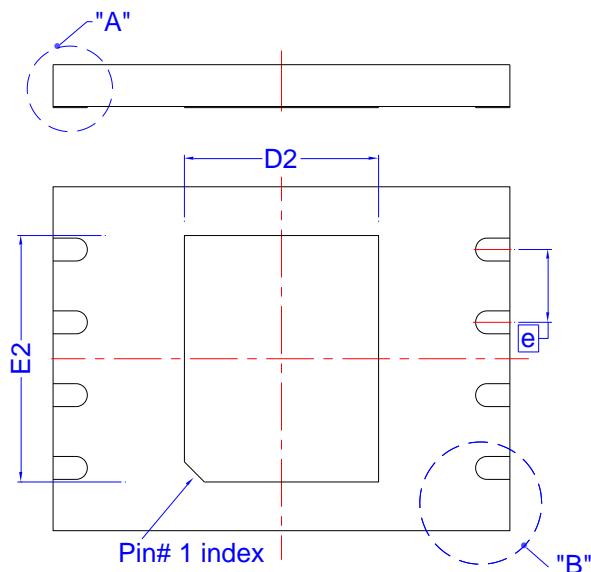
SYMBOL	DIMENSION IN MM		
	MIN.	NOR	MAX
A	---	---	2.65
A1	0.10	0.20	0.30
A2	2.25	---	2.40
C	0.20	0.25	0.30
D	10.10	10.30	10.50
E	10.00	---	10.65
E1	7.40	7.50	7.60
e	---	1.27	---
b	0.31	---	0.51
L	0.4	---	1.27
θ	0°	5°	8°

Note : 1. Coplanarity: 0.1 mm

Figure 59. 8-LEAD VDFN / WSON (6x5 mm)


SYMBOL	DIMENSION IN MM		
	MIN.	NOR	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.04
A2	---	0.20	---
D	5.90	6.00	6.10
E	4.90	5.00	5.10
D2	3.30	3.40	3.50
E2	3.90	4.00	4.10
e	---	1.27	---
b	0.35	0.40	0.45
L	0.55	0.60	0.65

Note: 1. Coplanarity: 0.1 mm

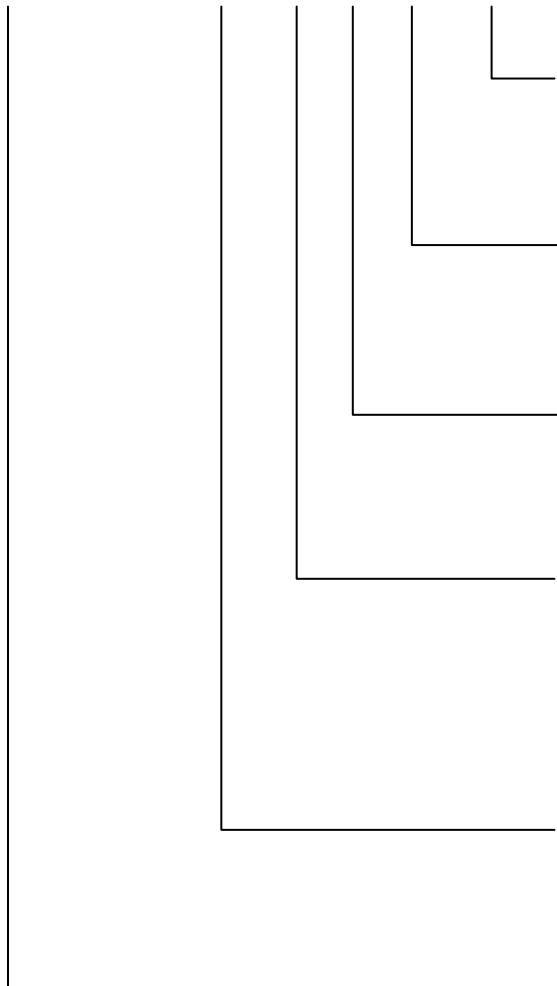
Figure 60. 8-LEAD VDFN / WSON (8x6 mm)
Pin# 1 index side

DETAIL A

DETAIL B

Symbol	Dimension in mm			Dimension in inch		
	Min	Norm	Max	Min	Norm	Max
A	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00	0.02	0.05	0.000	0.001	0.002
b	0.35	0.40	0.48	0.014	0.016	0.019
D	8.00 BSC			0.315 BSC		
D2	3.30	3.40	3.50	0.130	0.134	0.138
E	6.00 BSC			0.236 BSC		
E2	4.20	4.30	4.40	0.165	0.169	0.173
e	1.27 BSC			0.050 BSC		
L	0.40	0.50	0.60	0.016	0.020	0.024

Controlling dimension: millimeter
(Revision date: Jul 14 2022)

ORDERING INFORMATION

EN35QXR128A - 104 H I P 2XC

**DIFFERENTIATION CODE**

2XC = Quad Enable

PACKAGING CONTENT

P = RoHS, Halogen-Free and REACH compliant

TEMPERATURE RANGE

I = Industrial (-40°C to +85°C)

PACKAGE

H = 8-pin 200 mil SOP

F = 16-pin 300 mil SOP

W = 8-contact VDFN / WSON (6x5 mm)

Y = 8-contact VDFN / WSON (8x6 mm)

SPEED

104 = 104 MHz

BASE PART NUMBER

EN = Eon Silicon Solution Inc.

35QX = 3V Serial Flash with 4KB Uniform-Sector

R = RPMC

128 = 128 Megabit (16,384K x 8)

A = version identifier

Revisions List

Revision No	Description	Date
1.0	Initial Release	2023/04/07
1.1	Remove enhance and EQPI mode	2023/07/12

Important Notice

All rights reserved.

No part of this document may be reproduced or duplicated in any form or by any means without the prior permission of ESMT.

The contents contained in this document are believed to be accurate at the time of publication. ESMT assumes no responsibility for any error in this document, and reserves the right to change the products or specification in this document without notice.

The information contained herein is presented only as a guide or examples for the application of our products. No responsibility is assumed by ESMT for any infringement of patents, copyrights, or other intellectual property rights of third parties which may result from its use. No license, either express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of ESMT or others.

Any semiconductor devices may have inherently a certain rate of failure. To minimize risks associated with customer's application, adequate design and operating safeguards against injury, damage, or loss from such failure, should be provided by the customer when making application designs.

ESMT's products are not authorized for use in critical applications such as, but not limited to, life support devices or system, where failure or abnormal operation may directly affect human lives or cause physical injury or property damage. If products described here are to be used for such kinds of application, purchaser must do its own quality assurance testing appropriate to such applications.